



SPIRE Report

IST COLD FUNCTIONAL TEST REPORT - III Prime & Redundant S.D. Sidher, T.L. Lim & B.M. Swinyard

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1. INTRODUCTION

This document reports on the third and final COLD functional tests performed on the SPIRE instrument during the IST test campaign. The tests were conducted at the CSG in Kourou, French Guiana.

1.1 SCOPE

To judge the success or failure of a cold functional test by checking that:

- The telecommand sequence generated for a particular functional test is correctly received and executed on board by the SPIRE DPU.
- No error/event reports or command failures are generated during the execution of these commands.
- Telemetry is generated by the instrument as a result of telemetry requests to its different subunits.
- Particular telemetry parameters for each functional test change in an expected manner.
- A particular success criterion (specified in this document) is met.

1.2 REFERENCE DOCUMENTS

Ref	Document	Name	Version/Issue No.
RD01	SPIRE-RAL-DOC-001652	SPIRE Functional Tests Specification	Issue 1.4
RD02	SPIRE-RAL-DOC-001630	SPIRE I-EGSE Set-up Procedure	Issue 2.3
RD03	SPIRE-RAL-PRJ-001078	SPIRE Data ICD	Issue 2.1
RD04	Sap-SPIRE-CCa-076-02	DRCU/DPU Interface Control Document	Issue 1.3
RD05	LAM.PJT.SPI.NOT.011011	MCU/DPU Command List ICD	Issue 5.0
RD06	SPIRE-IFS-PRJ-001391	SPIRE OBS User Manual	Issue 3.0.B
RD07	SPIRE-RAL-PRC-002398	SPIRE FM Cold Functional Test Procedures	Issue 2.6
RD08	SPIRE-RAL-REP-003147	FM IST COLD FUNCTIONAL DETECTOR CHECK REPORT – Prime & Redundant Side	Issue 1.0
RD09	HP-2-ASED-SD-0203	SPIRE WFT after repair of pixel anomalies on SVM-SIH connectors based on HP-112000-ASED-NC-3725	Issue 01
RD10	SPIRE-RAL-PRJ-003018	SPIRE Commissioning Phase Plan	Issue 1.2 6 th March 2009

1.3 CHANGE RECORD

Document	Change date	Changes
Issue 1	12 th March 2009	First Version



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2. FUNCTIONAL TEST CONFIGURATION

2.1 Software Configuration

Write down in the table the current EGSE software configuration for the tests:

EGSE component	Version/Build number	Comment
SCOS2000	2.3eP5	
HCSS	v0.6.1 Build (#1430)	
QLA	v3.3	Redundant side SCALTEMP (SCAL structure temperature) calibration table patched on spireqla in directories ~/spire/lib/herschel/spire/qla/tables/ and ~/spire/lib/herschel/spire/qla/tables/SPIRE_PFM5_V1. CVS version of table: \$Id: SCALTEMP_T_SCST.ATAB_R,v 1.2 2009/01/21 17:19:01 ssidher Exp \$
QLA scripts	Latest versions from CVS	
CCS scripts	CVS Tag SPIRE_CFT_PROC_V2_7	
CUS Scripts	Mission configs in I-EGSE DB spire_fm_ist_db1@spireqla: Prime side: fm_ist_cft_config19p_Kourou in DB spire_fm_ist_db1 Redundant side: fm_ist_cft_config19r_Kourou in DB spire_fm_ist_db1	

2.2 EGSE Configuration Checks

To check for the success of failure of a functional test, the real time telemetry of the instrument has to be monitored. The following applications must be running to do so. Before the test sequence starts, make the following checks:

Workstation	EGSE component	Status	Check
hspireegse	EGSE router	Started	✓
hspireegse	EGSE Gateway	Started	✓
hspireegse	Pipe Gateway	Started	✓
hspireqla	Telemetry Ingestion	Started	✓
hspireqla	Packet Display	Started	✓
spires2k	SCOS2000	Started	✓
hspireqla	CCS Handler (Server)	Started	✓



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3. TEST PROCEDURE

The following two sections describe general pass/fail criteria (Section 3.1), the general test layout (Section 3.2) and the detailed procedure for each functional test (Section 3.3).

3.1 GENERAL PASS/FAIL CRITERIA

The general criteria for declaring a single test failed is the repeated failure of 2 consecutive runs of this test. In that case the functional test procedure should be aborted and the overall functional testing declared FAILED.

In the case of a 'first run' failure followed by a successful execution a third run of the same test should be performed and in the unlikely event of this third run being a failure the test procedure should be also aborted and the overall functional testing declared FAILED, as this would imply a not reliable operability of the instrument.

As a general remark ANY failure should be closely analysed.

Note: If the functional test is declared FAILED refer to section 4.1 for instrument switch OFF.

3.2 GENERAL TEST PROCEDURE LAYOUT

The table below shows the general CFT sequence as it should be performed. In each step of this procedure the operator should refer to the detailed procedure in Section 3.3. Test Control TCL scripts are available to invoke the correspondent CUS script stored in the HCSS database for each functional test. These CUS scripts will generate the appropriate command sequence for the particular functional test.

Step #	Procedure Name	Test Purpose	Duration /min
1	SPIRE-IST-COLD-DPU-ON-P	DPU PRIME Power up and OBS start	5
2	SPIRE-IST-COLD-DRCU-ON-P	DRCU PRIME Power up	4
3	SPIRE-IST-COLD-FUNC-SCU-02-P	SCU Nominal Science Contents check PRIME	5
4	SPIRE-IST-COLD-FUNC-SCU-03-P	SCU DC Thermometry check PRIME	8
5	SPIRE-IST-COLD-FUNC-SCU-06-P	SCU AC Thermometry check PRIME	2
6	SPIRE-IST-COLD-FUNC-SCU-07-P	Sorption Cooler Heaters Check PRIME	5
7	SPIRE-IST-COLD-FUNC-PCAL-01-P	PCAL Characterisation Test PRIME	5
8	SPIRE-IST-COLD-FUNC-SCAL-01-P	SCAL Characterisation Test PRIME	18
9	SPIRE-IST-COLD-FUNC-MCU-01-P	MCU Boot Check PRIME	5
10	SPIRE-IST-COLD-FUNC-MCU-03-P	MCU Nom. Science Contents Check PRIME	5
11	SPIRE-IST-COLD-FUNC-BSM-01-P	BSM Chop/Jiggle Sensors check PRIME	5
12	SPIRE-IST-COLD-FUNC-BSM-03-P	BSM Open Loop Dynamics Check PRIME	5
13	SPIRE-IST-COLD-FUNC-BSM-05A-P	BSM Open Loop Chop Test PRIME	5
14	SPIRE-IST-COLD-FUNC-BSM-05B-P	BSM Close Loop Chop Test PRIME	5
15	SPIRE-IST-COLD-FUNC-BSM-06-P	BSM Close Loop Operational Mode Chop Test PRIME	5
16	SPIRE-IST-COLD-BSM-OFF-P	BSM switch OFF PRIME	5
17	SPIRE-IST-COLD-FUNC-SMEC-01-	SMEC Encoder and LVDT check PRIME	5



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Step #	Procedure Name	Test Purpose	Duration /min
	P		
18	SPIRE-IST-COLD-FUNC-SMEC-03-P	SMEC Encoder Levels Check PRIME	5
19	SPIRE-IST-COLD-SMEC-OFF-P	SMEC switch OFF PRIME	5
20	SPIRE-IST-COLD-FUNC-DCU-02-P	DCU Nominal Science Contents Check PRIME	5
21	SPIRE-IST-COLD-FUNC-DCU-11-PHOT-P	Photometer BDAs Switch ON Check PRIME	7
22	SPIRE-IST-COLD-FUNC-DCU-13-PHOT-P	Photometer BDAs Integrity Check PRIME	15
23	SPIRE-IST-COLD-FUNC-DCU-14-PHOT-P	Photometer BDAs Noise Check PRIME	5
24	SPIRE-IST-COLD-PHOT-VSS-P	Photometer BDAs Vss Test PRIME	40
25	SPIRE-IST-COLD-PDET-OFF-P	Photometer BDAs Switch OFF PRIME	3
26	SPIRE-IST-COLD-FUNC-DCU-11-SPEC-P	Spectrometer BDAs Switch ON Check PRIME	7
27	SPIRE-IST-COLD-FUNC-DCU-13-SPEC-P	Spectrometer BDAs Integrity Check PRIME	12
28	SPIRE-IST-COLD-FUNC-DCU-14-SPEC-P	Spectrometer BDAs Noise Check PRIME	5
29	SPIRE-IST-COLD-SPEC-VSS-P	Spectrometer BDAs Vss Test PRIME	40
30	SPIRE-IST-COLD-SDET-OFF-P	Spectrometer BDAs switch OFF	3
31	SPIRE-IST-COLD-MCU-OFF-P	MCU switch OFF PRIME	2
32	SPIRE-IST-COLD-SCU-OFF-P	SCU switch OFF PRIME	2
33	SPIRE-IST-COLD-DRCU-OFF-P	DRCU power OFF PRIME	5
34	SPIRE-IST-COLD-DPU-OFF-P	DPU power OFF PRIME	5
35	Switch to redundant side on the I-EGSE and CCS		15
36	Repeat steps 1-34 in the above sequence for the REDUNDANT SIDE. Procedure names for Redundant side end in "-R"		~300
Total Duration ~ 10-11 Hours (PRIME and REDUNDANT)			

Table 1. General CFT sequence

***Note 1:** This procedure is not a functional test, is a close loop initialisation procedure required to test the close loop operability of the BSM.

***Note 2:** This procedure is not a functional test, is a close loop initialisation procedure required to test the close loop operability of the SMEC.

3.3 DETAILED TEST PROCEDURE

The following is a detailed (test by test) procedure including the steps required to perform each functional test individually.



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3.3.1 SPIRE-IST-COLD-DPU-ON-P

Version	2.4
Date	6th December 2007
Purpose	To switch on the SPIRE DPU PRIME and start generating housekeeping
Initial configuration	SPIRE DPU and DRCU PRIME are switched off
Final configuration	SPIRE DPU PRIME is ON and SPIRE HK is being produced , SPIRE DRCU PRIME is OFF
Preconditions	<ul style="list-style-type: none">• SPIRE FM DPU is electrically integrated with the Herschel Satellite• SPIRE MIB PRIME is imported in the CCS database.• CCS is up and running• FUNCTIONAL TEST PARAMETERS display is selected on the CCS
Duration	5 minutes
Pass/Fail Criteria	Nominal and critical HK reports start being generated at their nominal rates of 1Hz and 0.5Hz respectively.

Procedure Steps:



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Step	Description	Parameter	Expected Values Before/After	Actual Values Before/After	Pass/Fail
1	Select DPU AND OBS PARAMETERS display is on the CCS	—	—	—	Pass
2	Power ON the SPIRE DPU PRIME unit using the dedicated spacecraft LCL line and configure 1553 Spacecraft bus for SPIRE DPU PRIME (RT = 21)	—	—	—	Pass
3	Wait for the boot software to produce at least 2 event packets (5,1)	—	—	—	Pass
4	Execute TCL script SPIRE-IST-COLD-DPU-START-P.tcl	—	—	—	Pass
5	Check that Nominal and Critical HK packets are arriving at the CCS: SPIRE Nominal HK: <ul style="list-style-type: none"> • (type ,subtype) : (3,25) • APID : 0x502 SPIRE Critical HK: <ul style="list-style-type: none"> • (type ,subtype) : (3,25) • APID: 0x500 	—	—	—	Pass
6	Check that THSK parameter is refreshing every second	THSK	Refreshing @ 1 Hz	—	Pass
7	Check that TM2N parameter is incrementing by 1 every second	TM2N	Incrementing by 1 @ 1Hz	—	Pass
8	Check that TM1N parameter is incrementing by 1 every 2 second	TM1N	Incrementing by 1 @ 0.5Hz	—	Pass
9	On CCS check the consistency of the SPIRE on board time to the HCDMU time and the CCS. *	—	—	—	Pass
10	On I-EGSE check the consistency between SCOS time and THSK and QLA time.	THSK	Incrementing once per second	—	Pass

Test Result (Pass/Fail): **Pass** – Booted from the secondary partition
DPU Current drawn:
Spacecraft measured value SpireHsN_L11_I (parameter WM308565 on display ZAWS1999) – 0.45A As expected
Start time: 00:55 (27th Feb 2009)
OBSID: 0xb00017bc

* Assuming that OBT is provided by the HCDMU following RD02, i.e, OBT is TAI, there should be a 33 second difference between OBS and CCS time (assuming CCS is using UTC). In the case the HCDMU is using UTC to specify the on board time, there should be no difference between THSK and the CCS/I-EGSE system time.



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3.3.2 SPIRE-IST-COLD-DRCU-ON-P

Version	2.4
Date	6th December 2007
Purpose	To switch on the SPIRE DRCU PRIME and start generating housekeeping
Initial configuration	SPIRE DPU PRIME is ON and DRCU PRIME is switched OFF
Final configuration	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced
Preconditions	<ul style="list-style-type: none">• SPIRE FM DRCU is electrically integrated with the Herschel Satellite• SPIRE DRCU is switched OFF• SPIRE MIB PRIME is imported in the CCS database.• CCS is up and running• FUNCTIONAL TEST PARAMETERS display is selected on the CCS
Duration	5 minutes
Pass/Fail Criteria	DRCU voltages show expected 'ON' values



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Procedure steps:

Step	Description	Parameter	Expected Values Before/After	Actual Values Before/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-DRCU-START-P-STEP1.tcl	—	—	—	Pass
2	Check that THSK parameter is not refreshing anymore	THSK	Not refreshing	—	Pass
3	Check that TM2N parameter is not incrementing anymore	TM2N	Not incrementing	—	Pass
4	Power ON the SPIRE DRCU PRIME unit using the dedicated spacecraft LCL line.	—	—	—	Pass
5	Execute TCL script SPIRE-IST-COLD-DRCU-START-P-STEP2.tcl Note: The two TCs to clear the SPIRE Critical and Nominal HK reports will fail during execution of this script. These should be ignored because the HK reports will already have been cleared by script SPIRE-IST-COLD-DRCU-START-P-STEP1.tcl	—	—	—	Pass
6	Check that THSK parameter is again refreshing every second	THSK	Refreshing @ 1Hz	—	Pass
7	Check that TM2N parameter is again incrementing every second	TM2N	Incrementing by 1 @ 1Hz	—	Pass
8	Check that the SCU/DCU voltages show nominal values	SCUP5V SCUP9V SCUM9V BIASP5V BIASP9V BIASM9V	~ 5.2 ± 0.5V ~ 9.0 ± 0.2V ~ -9.0 ± 0.2V ~ 5.1 ± 0.5V ~ 9.0 ± 0.2V ~ -9.0 ± 0.2V	5.24 V 9.09 V -9.08 V 5.18V 8.99V -9.05V BIASTEMP 297.14K DAQTEMP 298.7K	Pass

Test Result (Pass/Fail): Pass
DRCU Current taken from S/C (parameter WM408565 Display ZAWS1999)
SpireHsfN_L51_I 0.44583 A
OBSID: 0xb00017be
Start time: 01:06 UT



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3.3.3 SPIRE-IST-COLD-FUNC-SCU-02-P

Version	2.4
Date	6th December 2007
Purpose	SCU Nominal Science Contents Check PRIME
Initial configuration	SPIRE DPU and DRCU PRIME are switched ON, SPIRE HK is being produced
Final configuration	Unchanged
Preconditions	<ul style="list-style-type: none"> • SPIRE-IST-COLD-DPU-ON-P and SPIRE-IST-COLD-DRCU-ON-P procedures have been executed. • SPIRE MIB PRIME is imported in the CCS database. • CCS is up and running • I-EGSE is up and running • DPU AND OBS PARAMETERS & FUNCTIONAL TEST PARAMETERS displays are selected on the CCS
Duration	5 minutes (CUS = 35.0)
Success Criteria:	Test passed if : <ol style="list-style-type: none"> 1. The SPIRE HK parameter SCUFRAMECNT increments 0/31. 2. The SPIRE HK parameter SCUFRAMECNT increments 0x3FFF/1 3. No events are generated during the frame generation. QLA to give go ahead.
CUS Parameters	CUS parameter - scuframes = 0x1f = 31

Test Procedure:

Step#	Action
0	Open SCU_PARAMETERS display on SCOS Alpha Numeric Displays.
1	Write down the initial value of the SCUFRAMECNT and TM5N parameters located in SCU_PARAMETERS display.
2	Run QLA script FUNC-SCU-02.py on QLA console.
3	Write down the final value of SCUFRAMECNT and TM5N.
4	Contingency: If test fails repeat steps 1 to 4.

Test Log:



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Step	Description	Parameter	Expected Values Before/After	Actual Values Before/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SCU-02-P.tcl	SCUFRAMECNT TM5N	0/31 0x3FFF/1		PASS

Start time @: 01:17 UT

End time @:

OBSID:0xb00017bf

Comments:

SCU frame count 0 at start and 31 at end

FUNC-SCU-02 version: 1.5

Housekeeping @ Fri Feb 27 01:17:10 UTC 2009

SCU Science @ Fri Feb 27 01:17:05 UTC 2009

Name	HSK value	SCU value	Equal (within 10 raw units)?
TCHTRV	20.0	19.0	True
PCALCURR	11.0	9.0	True
SCAL4CURR	9.0	9.0	True
SCAL2CURR	10.0	10.0	True
PCALV	9.0	8.0	True
SCAL4V	11.0	9.0	True
SCAL2V	11.0	11.0	True
PUMPHTRTEMP	65448.0	65448.0	True
PUMPHSTEMP	136.0	133.0	True
EVAPHSTEMP	65442.0	65442.0	True
SHUNTTEMP	65272.0	65272.0	True
EMCFILTEMP	65522.0	65521.0	True
SL0TEMP	222.0	223.0	True
PL0TEMP	65357.0	65355.0	True
OPTTEMP	53.0	54.0	True
BAFTEMP	26.0	27.0	True
BSMIFTEMP	98.0	98.0	True
SCAL2TEMP	12.0	11.0	True
SCAL4TEMP	65398.0	65397.0	True
SCALTEMP	65419.0	65420.0	True
SMECIFTEMP	14.0	14.0	True
SMECTEMP	65433.0	65432.0	True
BSMTEMP	164.0	164.0	True
SUBKTEMP	32756.0	32756.0	True

Test Result (Pass/Fail): **PASS**



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3.3.4 SPIRE-IST-COLD-FUNC-SCU-03-P

Test Id:	SPIRE-IST-COLD-FUNC-SCU-03-P
Test Purpose:	FPU DC Thermometry Check
Initial Configuration:	DRCU_ON + AC/DC thermometry ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON
Duration	8 minutes (CUS = 38.0)
Success Criteria:	Test passed if thermometry channels show temperature values indicating a correct functioning of the sensor, not open/short-circuited. If ANY reading is anomalous check RAW sensor reading. Open Circuit Criterion: RAW reading in the range [0, -100] Short Circuit Criterion: RAW reading of -32768
CUS Parameters	CUS parameter dparam = 0xffff = 65535

Test Procedure:

Step#	Action
1	Run QLA script FUNC-SCU-03.py on QLA console.
2	Run SPIRE-IST-COLD-FUNC-SCU-03-P.tcl test procedure from the CCS.
3	Contingency: If test fails: <ol style="list-style-type: none"> 1. Execute SCU_OFF procedure. 2. Execute SPIRE-IST-COLD-FUNC-SCU-03-P.tcl procedure. 3. Repeat step 1 of the Test Procedure.

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	No. of frames received	Test Result
FUNC-SCU-03	SCUTEMPSTAT	0xFFFF/0xFFFF	0xFFFF/0xFFFF	N/A	PASS



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Start time @: 01:20
 End time @:
 OBSID: 0xb00017c0

Comments: We took the cryo-scoe and CCU measurements at 27th Feb 2009 00:40 UT

Level	Sensor Description	SCOS Sensor Name	SCOS mnemonic	SCOS Display	Temp/K
L0	Cooling Strap 5; to "SPIRE SM Detector enclosure"	C100_1_T225	KD203303	ZAK10999	5.6
L0	Cooling Strap 6; to "SPIRE Cooler Pump HS"	C100_3_T226	KD209303	ZAK10999	5.56
L0	Cooling Strap 7; to "SPIRE Cooler Evaporator HS"	C100_2_T227	KD206302	ZAK08999	5.62
L1	Ventline upstream strap 4 to "SPIRE Optical Bench"	C100_3_T235	KD211303	ZAK10999	10.54
L1	Ventline downstream strap 4 to "SPIRE Optical Bench"	C100_3_T236	KD211302	ZAK08999	12.73
L2	Spire 2-JFET (JFET-Spec)	C100_4_T250	KD224302	ZAK08999	N/C
L2	Spire 6-JFET (JFET-Phot)	C100_4_T252	KD224303	ZAK10999	N/C
L3	Ventline to 6-JFET Phot	C100_4_T246	KD223302	ZAK08999	N/C
L3	Ventline to 2-JFET Spec	C100_4_T247	KD223303	ZAK10999	N/C
L3	Cooling strap to JFET-S	PT1000_t249	YM238958	YASC2958	26.38
L3	Cooling strap to JFET-P	PT1000_T251	YM239958	YASC2958	26.38

QLA script did not trigger live but OK in playback mode:

SCU-03 Thermometry Check
 OBSID = 0xb00017c0

```

PUMPHRTEMP 6.62 55447
PUMPHSTEMP 9.55 51241
EVAPHSTMP 8.99 51583
SHUNTTEMP 5.43 50853
EMCFILTEMP 14.46 59936
SLOTTEMP 5.45 51075
PLOTTEMP 5.55 51516
OPTTEMP 14.50 57016
BAFTEMP 15.07 58398
BSMIFTEMP 14.63 55523
SCAL2TEMP 14.52 57362
SCAL4TEMP 14.34 57347
SCALTEMP 14.63 56013
SMECIFTEMP 14.26 55904
SMECTEMP 14.33 42104
BSMTEMP 12.80 32768
  
```




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3.3.5 SPIRE-IST-COLD-FUNC-SCU-06-P

Test Id:	SPIRE-IST-COLD-FUNC-SCU-06-P
Test Purpose:	SCU/FPU AC Thermometry Check
Initial Configuration:	DRCU_ON + AC/DC thermometry ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON
Duration	2 minutes
Success Criteria:	At ~ 4K the SUBKTEMP reading should calibration should start being in range. Open Circuit Criterion: RAW reading in the range 0 -100 Short Circuit Criterion: RAW reading of -32768
CUS Parameters	acparam = 0x1

Test Procedure:

Step#	Action
1	Run SPIRE-IST-COLD-FUNC-SCU-06-P.tcl test procedure from the CCS.
2	Contingency: If test fails : 1. Send manual command: SEND_DRCU_COMMAND Parameter1 = 0xA0860000 Parameter2 = 0 2. Then repeat steps 1 and 2 of the Test Procedure. Note: If the test fails and the SUBKTEMP channel is switched OFF manually, the expected value before/after execution of FUNC-SCU-06 for SUBKSTAT is 0/1

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	No. of frames received	Test Result
FUNC-SCU-06	SUBKSTAT SUBKTEMP	0/1 He I (~4K) He II (~1.7K)	0/1	N/A	PASS



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Start time @: 01:26 UT
End time @:
OBSID: 0xb00017c1

Comments:
SUBKTEMP ~5.67 K

QLA script did not trigger live but OK in playback mode:

SCU-06
Start time @: 27-Feb 01:25:40
End time @: 27-Feb 01:25:51
OBSID: 0xB00017C1

SUBKSTAT:
Start value: 0x0
End value: 0x1

SUBKTEMP
RAW value before: 32757

RAW value after: 32646
Converted after: 5808 mK

3.3.6 SPIRE-IST-COLD-FUNC-SCU-07-P

Test Id:	SPIRE-IST-COLD-FUNC-SCU-07-P													
Test Purpose:	Sorption Cooler Heater Check (Not at He II)													
Initial Configuration:	DRCU_ON + AC/DC thermometry ON													
Final Configuration:	DRCU_ON + AC/DC thermometry ON													
Constraints	This test should not be performed at He II temperatures, unless specifically instructed to do so by the I-EGSE staff.													
Duration	5 minutes (CUS 95.0)													
Success Criteria:	Test passed if : <ul style="list-style-type: none"> Sorption cooler heat switches and pump heater show expected voltages PCALCURR HK parameter shows the commanded current. PCALV parameter shows a linear increase proportional to the bias applied. (the proportionality constant in this case should be the PCAL resistor value) i.e. <table border="1" style="margin-left: 20px;"> <thead> <tr> <th>SCU HK parameter</th> <th>RAW</th> <th>Converted</th> </tr> </thead> <tbody> <tr> <td>SPHSV</td> <td>~12715</td> <td>~323mV</td> </tr> <tr> <td>EVHSV</td> <td>~12715</td> <td>~323mV</td> </tr> <tr> <td>SPHTRV</td> <td>~14390</td> <td>~ 8 V</td> </tr> </tbody> </table>		SCU HK parameter	RAW	Converted	SPHSV	~12715	~323mV	EVHSV	~12715	~323mV	SPHTRV	~14390	~ 8 V
SCU HK parameter	RAW	Converted												
SPHSV	~12715	~323mV												
EVHSV	~12715	~323mV												
SPHTRV	~14390	~ 8 V												
CUS Parameters	evaphs = 0.804 pumphps = 0.804													



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	pumpht = 21.85
--	----------------

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1.	Open SCU_PARAMETERS display on SCOS Alpha Numeric Displays.				
2.	Run SPIRE-IST-COLD-FUNC-SCU-07-P.tcl test procedure from the CCS.				
3.	Execute TCL script SPIRE-IST-COLD-FUNC-SCU-07-P.tcl	—	—	—	
4.	Wait for the parameter BBFULLTYPE to get set to Cooler Htr Chk	BBFULLTYPE	Cooler_Htr_Chk		
5.	Record the value of parameter SPHSV – the Sorption Pump Heat Switch Voltage. <i>This voltage stays on for ~20 seconds. Wait for the voltage to go to zero to continue.</i>	SPHSV – mV	0/~323/0		
6.	Record the value of parameter EVHSV – the Evaporator Heat Switch Voltage. <i>This voltage stays on for ~20 seconds. Wait for the voltage to go to zero to continue.</i>	EVHSV – mV	0/~323/0		
7.	Record the value of parameter SPHTRV – the Sorption Pump Heater Voltage. <i>This voltage stays on for ~20 seconds. Wait for the voltage to go to zero to continue.</i>	SPHTRV – V	0/~8.8/0		
8.	Wait for the I-EGSE staff to confirm the success or failure of this test. If test fails repeat.	—	—	—	

Test Result (Pass/Fail):

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/During test	Actual Value Before/After	No. of frames received	Test Result



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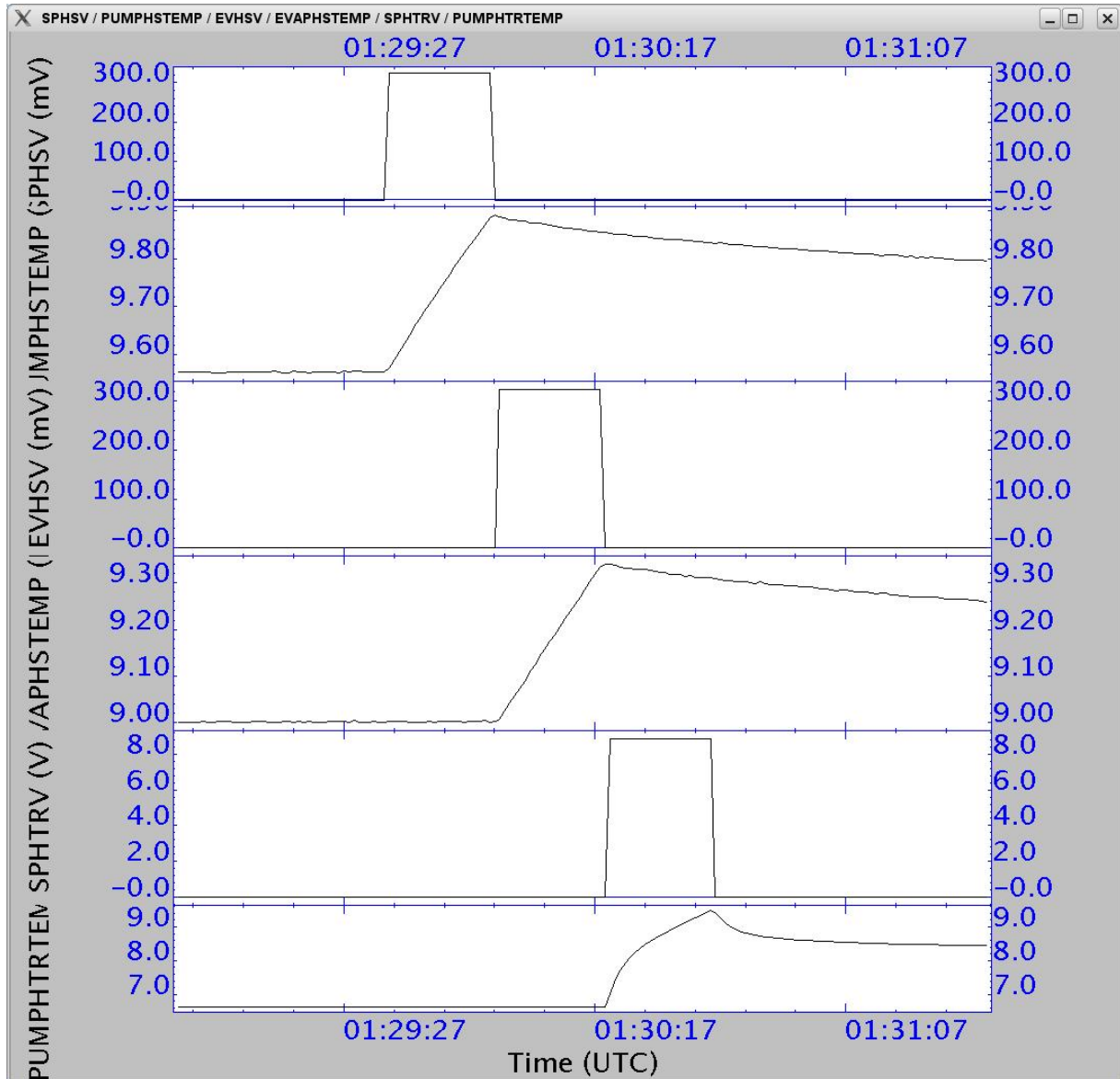
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SPIRE-IST-COLD-FUNC-SCU-07-P.tcl	SPHSV EVHSV SPHTRV	0/ ~ 323 mV 0/ ~ 323 mV 0/ ~ 8.8 V	~0. / 324.14 mV ~0 / 324.05 mV ~0 / 8.85 V	N/A	PASS
----------------------------------	--------------------------	--	--	-----	------

Start time @: 01:30 UT
End time @:
OBSID: 0xb00017c2

Comments:





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3.3.7 SPIRE-IST-COLD-FUNC-PCAL-01-P

Test Id:	SPIRE-IST-COLD-FUNC-PCAL-01-P
Test Purpose:	Photometer Calibrator Characterisation
Initial Configuration:	DRCU_ON + AC/DC thermometry ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON
Duration	5 minutes (CUS 216.0)
Success Criteria:	Test passed if : <ul style="list-style-type: none"> • PCALCURR HK parameter shows the commanded current. • PCALV parameter shows a linear increase proportional to the bias applied. (the proportionality constant in this case should be the PCAL resistor value)
CUS Parameters	p_start = 1.0; // Start input bias (mA) p_end = 7.0; // End input bias (mA) p_step = 1.0; // Step input bias (mA)

Test Procedure

Step#	Action
1	Run QLA script FUNC-PCAL-01.py on QLA console.
2	Run SPIRE-IST-COLD-FUNC-PCAL-01-P test procedure from the CCS.
3	Contingency: If test fails repeat steps 1 and 2.

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/During test	Actual Value Before/After	No. of frames received	Test Result
SPIRE-IST-COLD-FUNC-PCAL-01-P	PCALCURR PCALV	Starts at 0 then steps through 1, 2, 3 .. and ends at 7mA	See plot below	N/A	PASS



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Start time @: 01:36 UT

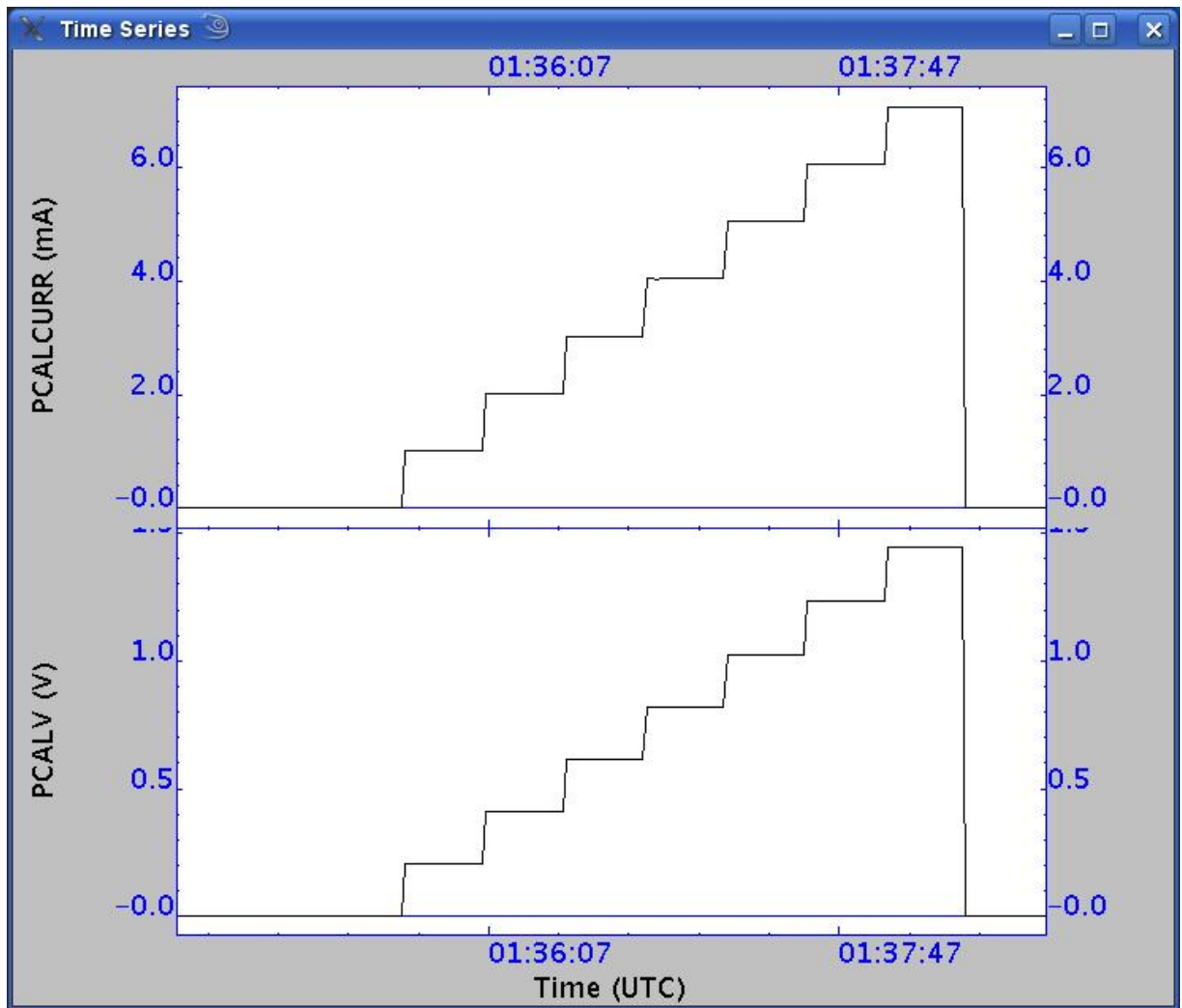
End time @:

OBSID: 0xb00017c3

Comments:

Monitored PCAL current on SCOS - PCAL current settings OK

Better plots to be added





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3.3.8 SPIRE-IST-COLD-FUNC-SCAL-01-P

Test Id:	SPIRE-IST-COLD-FUNC-SCAL-01-P
Test Purpose:	Spectrometer Calibrator Characterisation
Initial Configuration:	DRCU_ON + AC/DC thermometry ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON
Duration	18 minutes (CUS 926)
Success Criteria:	Test passed if : <ul style="list-style-type: none"> • SCAL4CURR HK parameter shows the commanded current sequence (1,2,3,4,5,5.5mA) • SCAL2CURR HK parameter shows the commanded current sequence(1,2,3,4,5,5.5mA) • SCA2LV parameter shows a linear increase proportional to the bias applied. (the proportionality constant in this case should be the SCAL2V resistor value) • SCAL4V parameter shows a linear increase proportional to the bias applied. (the proportionality constant in this case should be the SCAL4V resistor value) • SCAL2TEMP and SCAL4TEMP values follow the increased bias settings
CUS Parameters	s2_start = 1.0 \ \ S2 Bias RAW s2_end = 5.0 \ \ S2 Bias RAW s2_step = 1.0 \ \ S2 Bias RAW s4_start = 1.0 \ \ S4 Bias RAW s4_end = 5.0 \ \ S4 Bias RAW s4_step = 1.0 \ \ S4 Bias RAW

Test Procedure

Step#	Action
1	Run QLA script FUNC-SCAL-01.py on QLA console.
2	Run SPIRE-IST-COLD-FUNC-SCAL-01-P test procedure from the CSS.
3	Contingency: If test fails repeat steps 1 and 2.

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/During test	Actual Value Before/After	No. of frames received	Test Result
SPIRE-IST-COLD-FUNC-SCAL-01-P	SCAL2CURR SCAL4CURR SCAL2V SCAL4V SCAL2TEMP SCAL4TEMP	0/1,2,3,4,5,5.5mA 0/1,2,3,4,5,5.5mA 0/0.5,1.0,1.5,2.0,2.5,2.75V 0/0.5,1.0,1.5,2.0,2.5,2.75V	See plots below	N/A	Pass

Note: First SCAL2CURR starts at 0 then steps through 1, 2, 3 .. and ends at 7mA, then the same for SCAL4CURR



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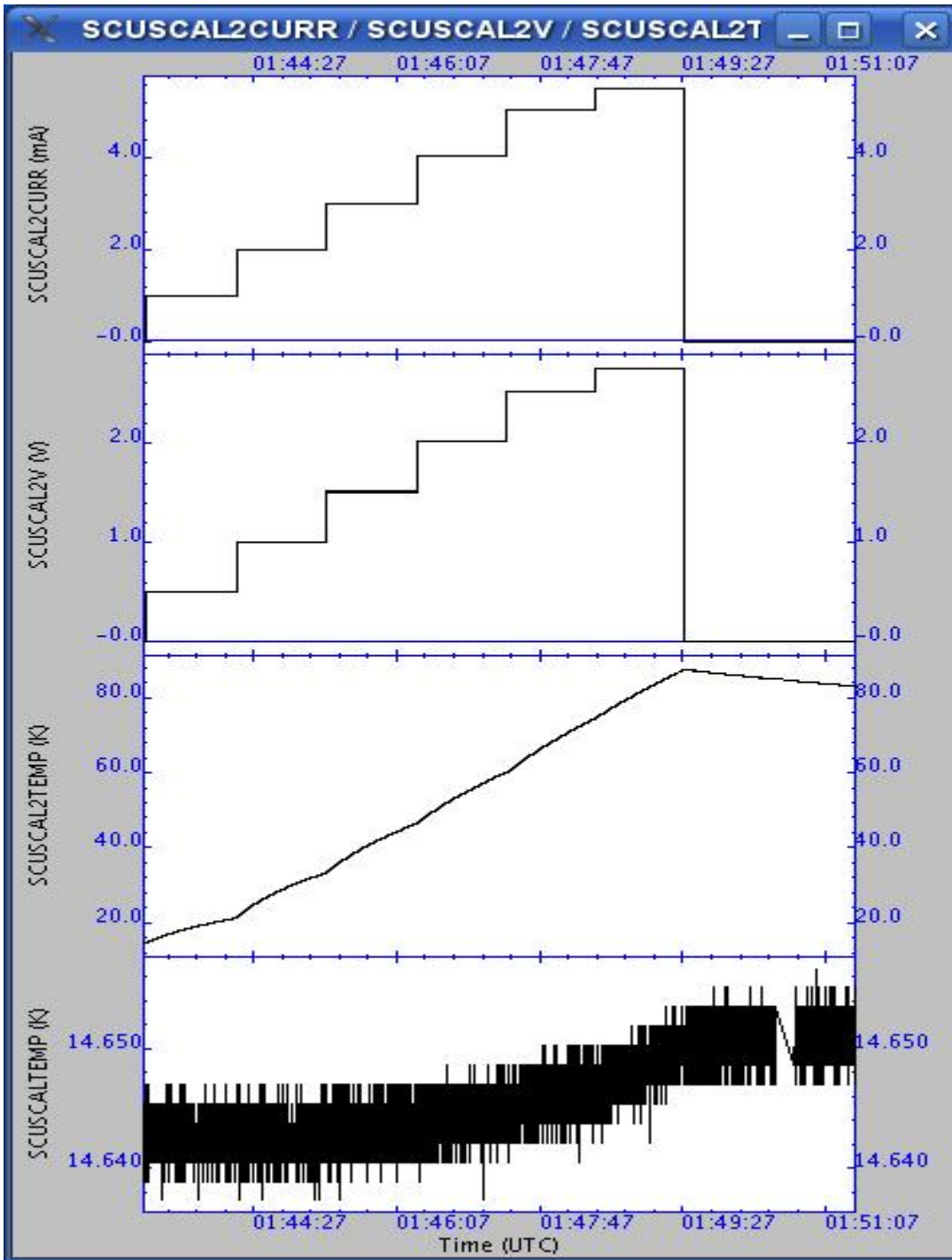
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Start time @: 01:43 UT

End time @:

OBSID: 0xb00017c4

Comments: Test completed successfully. SCAL2 reached ~87K and SCAL4 reached ~68K

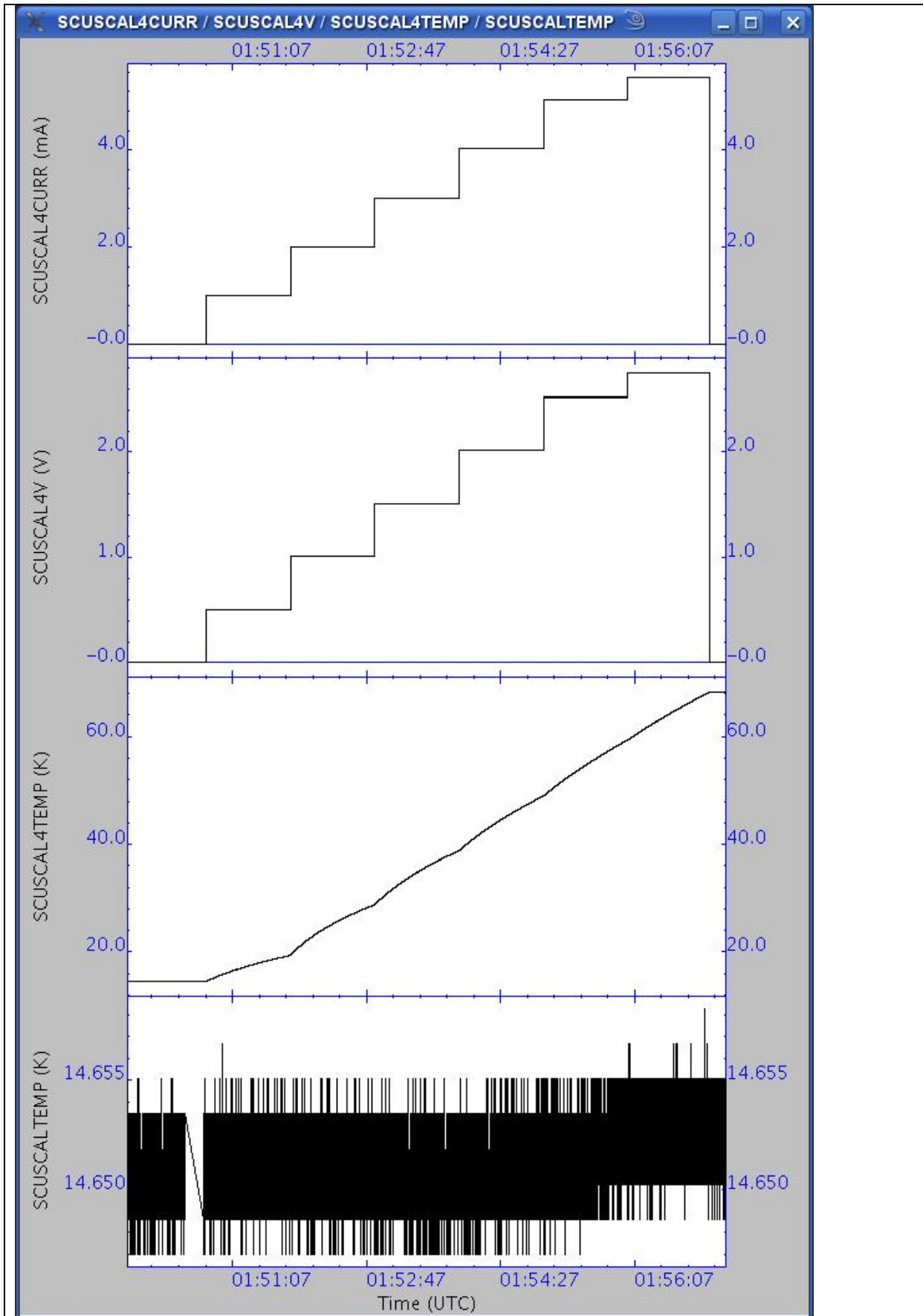




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3.3.9 SPIRE-IST-COLD-FUNC-MCU-01-P

Test Id:	SPIRE-IST-COLD-FUNC-MCU-01-P
Test Purpose:	MCU Boot Check
Initial Configuration:	DRCU_ON + AC/DC thermometry ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON
Duration	5 mins (CUS 64.0)
Success Criteria:	Test passed if: <ol style="list-style-type: none"> 1. MCU boots. 2. MCU voltages show expected values. 3. MAC Board Temperature Reading shows ambient temperature.

Test Procedure:

Step#	Action
1	Run SPIRE-IST-COLD-FUNC-MCU-01-P test procedure from the CCS.
2	When procedure is finished, write down the values of the MCU voltages.
3	Contingency: If test fails repeat steps 1 and 2.

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	No. of frames received	Test Result
SPIRE-IST-COLD-FUNC-MCU-01-P	MCUP5V	N/A / ~ 5V	5.01 V	N/A	PASS
	MCUP15V	N/A / ~15V	15.54 V		
	MCUP14V	N/A / ~ 14V	14.15V		
	MCUM14V	N/A / ~ -14V	-14.47 V		
	MCUM15V	N/A / ~ -15V	-15.63 V		
	MCUMACTEMP	N/A / ~ 300K	295.04 K		
	MCUBSMTEMP	N/A / ~ 300K	299.12 K		
MCUSMECTEMP	N/A / ~ 300K	299.83 K			

Start time @: 02:01

End time @:

DRCU Current taken from S/C (parameter WM408565 Display ZAWS1999)

SpireHsfN_L51_1 0.83 A at switch on now 0.89165 A

OBSID: 0xb00017c5

Comments:

MCU booted OK



3.3.10 SPIRE-IST-COLD-FUNC-MCU-03-P

Test Id:	SPIRE-IST-COLD-FUNC-MCU-03-P																																			
Test Purpose:	MCU Nominal Science Generation Check																																			
Initial Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON																																			
Final Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON																																			
Duration	5 mins (CUS 69.0)																																			
Success Criteria:	<p>Test passed if :</p> <ol style="list-style-type: none"> MCU produces each type of the frames requested and with the following characteristics. <table border="1" style="width: 100%; border-collapse: collapse; margin: 10px 0;"> <thead> <tr> <th>Frame</th> <th>APID</th> <th>Type</th> <th>Subtype</th> <th>SID</th> <th>FrameID</th> <th>Frame length</th> </tr> </thead> <tbody> <tr> <td>Eng.</td> <td>0x508</td> <td>21</td> <td>3</td> <td>0x814</td> <td>0x14</td> <td>0x15</td> </tr> <tr> <td>BSM</td> <td>0x508</td> <td>21</td> <td>1</td> <td>0x612</td> <td>0x12</td> <td>0xD</td> </tr> <tr> <td>SMEC</td> <td>0x508</td> <td>21</td> <td>1</td> <td>0x410</td> <td>0x10</td> <td>0xC</td> </tr> <tr style="background-color: #cccccc;"> <td>BSM +SMEC</td> <td></td> <td></td> <td></td> <td></td> <td></td> <td></td> </tr> </tbody> </table> <ol style="list-style-type: none"> No events are generated during the different frames generation. 	Frame	APID	Type	Subtype	SID	FrameID	Frame length	Eng.	0x508	21	3	0x814	0x14	0x15	BSM	0x508	21	1	0x612	0x12	0xD	SMEC	0x508	21	1	0x410	0x10	0xC	BSM +SMEC						
Frame	APID	Type	Subtype	SID	FrameID	Frame length																														
Eng.	0x508	21	3	0x814	0x14	0x15																														
BSM	0x508	21	1	0x612	0x12	0xD																														
SMEC	0x508	21	1	0x410	0x10	0xC																														
BSM +SMEC																																				
CUS Parameters	<pre>n_eng_frames = 100; //number of engineering frames f_eng_frames = 64.1; //frequency of engineering frames generation n_smec_frames = 100; //number of smec frames f_smec_frames = 250.0; //frequency of smec frames generation n_bsm_frames = 100; //number of bsm frames f_bsm_frames = 64.1; //frequency of bsm frames generation ftime = 10; //time for continuous generation</pre>																																			

Test Procedure:

Step#	Action
1	Write down the current value of MCUFRAMECNT located in MCU_PARAMETERS display
2	Run SPIRE-IST-COLD-FUNC-MCU-03-P test procedure from the CCS.
3	When test is finished Write down the current value of MCUFRAMECNT.
4	Contingency: If test fails repeat steps 1 to 4.

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	No. of frames received	Test Result
SPIRE-IST-COLD-FUNC-MCU-03-P.tcl	MCUFRAMECNT	0 / ~ 297	0 / 297		Pass



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Start time @: 02:07

End time @:

OBSID: 0xb00017c6

Comments:

QLA-MCU-03_B00017C6_8901.txt

Housekeeping Fri Feb 27 02:06:54 UTC 2009

Science Fri Feb 27 02:06:53 UTC 2009

Name	HK before	Science	HK after	Equal (within 10%)?
SMECENC SIG1	12410.0	12408.0	12410.0	True
SMECENC SIG2	20070.0	20072.0	20075.0	True
SMECLVDTDCSIG	32758.0	32760.0	32758.0	True
SMECLVDTAC SIG	27348.0	27350.0	27351.0	True
SMECMOTORCURR	32784.0	32782.0	32780.0	True
SMECMOTORVOLT	32772.0	32770.0	32778.0	True
CHOPSENS SIG	32763.0	32765.0	32764.0	True
CHOPMOTORCURR	32779.0	32778.0	32778.0	True
CHOPMOTORVOLT	32762.0	32765.0	32766.0	True
JIGGSENS SIG	32759.0	32758.0	32755.0	True
JIGGMOTORCURR	32776.0	32775.0	32773.0	True
JIGGMOTORVOLT	32762.0	32764.0	32767.0	True

Empty file QLA-MCU-03_B00017C6_8902.txt but OK when in playback mode:

QLA-MCU-03_B00017C6_8903.txt:

Housekeeping Fri Feb 27 02:07:27 UTC 2009

Science Fri Feb 27 02:07:26 UTC 2009

Name	HK before	Science	HK after	Equal (within 10%)?
CHOPSENS SIG	32765.0	32766.0	32764.0	True
CHOPDACVAL	32768.0	32768.0	32768.0	True
CHOPMOTORVOLT	32764.0	32761.0	32761.0	True
JIGGSENS SIG	32756.0	32758.0	32754.0	True
JIGGDACVAL	32768.0	32768.0	32768.0	True
JIGGMOTORVOLT	32766.0	32766.0	32770.0	True



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Step#	Action	Comments
0	Open BSM PARAMETERS display on SCOS Alpha Numeric Displays.	

3.3.11 SPIRE-IST-COLD-FUNC-BSM-01-P

Test Id:	SPIRE-IST-COLD-FUNC-BSM-01-P
Test Purpose:	BSM Switch ON Check
Initial Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON + BSM ON (open loop)
Duration	5 mins (CUS 24.0)
Success Criteria:	Test passed if: <ol style="list-style-type: none"> 1. CHOPSENSPWR HK parameter goes from 0 to 1 2. CHOPSENSIG HK parameter changes 3. JIGGSENSPWR HK parameter goes from 0 to 1 4. JIGGSENSSIG HK parameter changes

Test Procedure

Step#	Action
1	Run SPIRE-IST-COLD-FUNC-BSM-01-P test procedure from the CCS.
2	When the test is finished record all the Key parameters noted below
3	Contingency: If test fails repeat steps 1 and 2.

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	No. of frames received	Test Result
FUNC-BSM-01	CHOPSENSPWR	0/1/1	0 / 1	N/A	Pass
	CHOPLOOPMODE	3/3	3 / 3		
	CHOPSENSSIG	??	7FFD /931D		
	JIGGSENSPWR	0/1/1	0 / 1		
	JIGGLOOPMODE	3/3	3 / 3		
	JIGGSENSSIG	??	7FF4 / 992C		



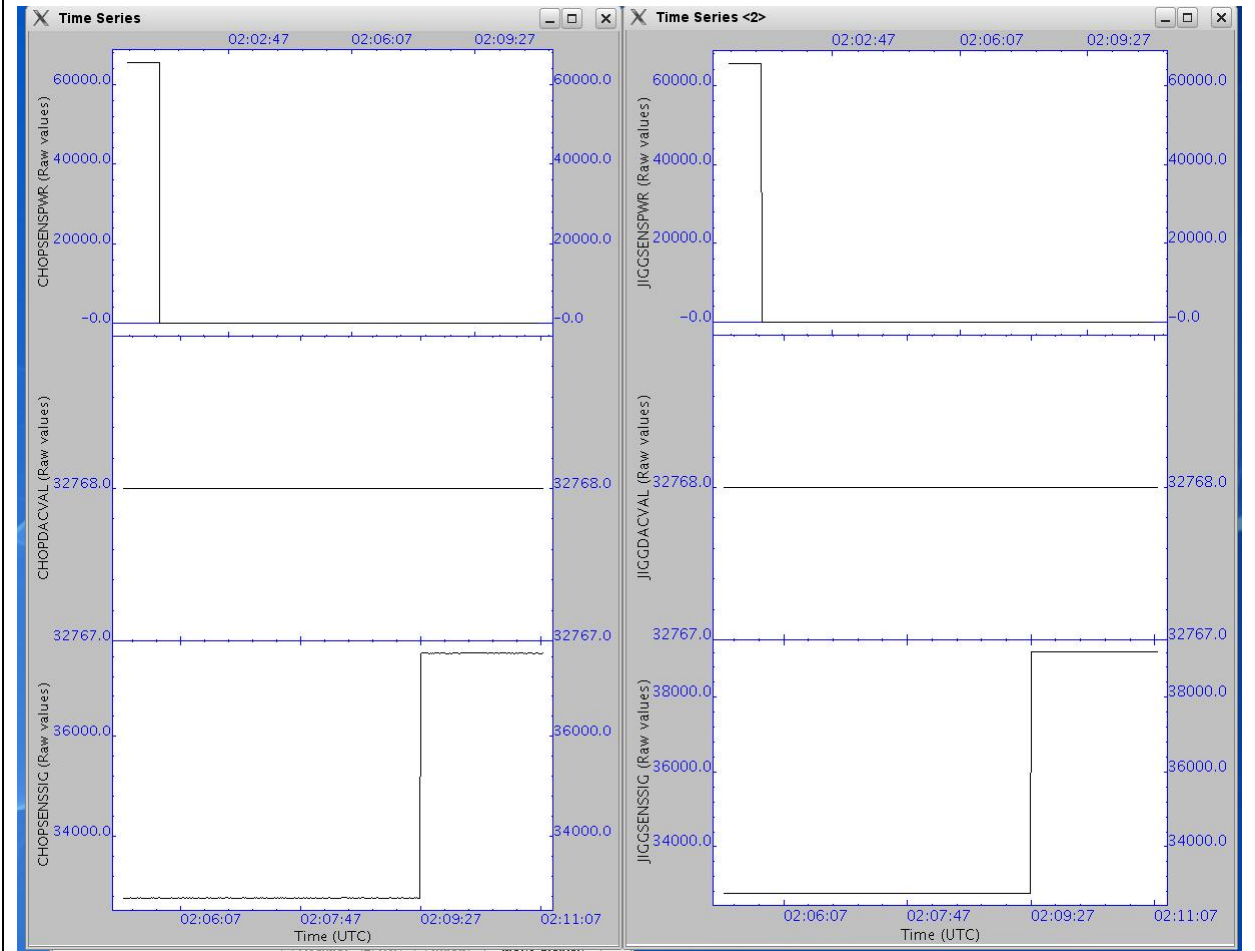
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Start time @: 02:09
End time @:
OBSID: 0xb00017c7

Comments:





3.3.12 SPIRE-IST-COLD-FUNC-BSM-03-P

Test Id:	SPIRE-IST-COLD-FUNC-BSM-03-P
Test Purpose:	BSM Open Loop dynamics Check
Initial Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON + BSM ON (open loop)
Final Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON + BSM ON (open loop)
Duration	5 mins (CUS 269.0)
Success Criteria:	Test passed if the chop sensor signal evolves in the same way as the positions set (i.e. if choppos2 > choppos1 → chopsenssig2 > chopsenssig1) for each jiggle position.
CUS Parameters	<pre> frametype = "BSM"; // Specifies MCU frame type [BSM,SMEC,BSM+SMEC,ENG,TEST] framerate = 64.0; // Specifies the frame rate j_start = 0x4000; // RAW jiggle target start position j_end = 0xc000; // RAW jiggle target end position j_step = 0x4000; // RAW jiggle target step in position j_delay = 2; // Time at each jiggle target position in seconds c_start = 0x3000; // RAW chop target start position c_end = 0xf000; // RAW chop target end position c_step = 0x1000; // RAW chop target step in position c_delay = 5; // Time at each chop target position in seconds </pre>

Test Procedure

Step#	Action
1	On QLA open up 2 time series display with the following HK parameters in each display: Display 1: <i>HK</i> : CHOPPOSN <i>BSM Nominal Science:</i> BSMCHOPMOTORCURREN BSMCHOPSENSSIG BSMCHOPMOTORVOLT Display2: <i>HK</i> : JIGGPOSN <i>BSM Nominal Science:</i> BSMJIGGMOTORCURREN BSMJIGGSENSSIG BSMJIGGMOTORVOLT
2	Run SPIRE-IST-COLD-FUNC-BSM-03-P test procedure from the CCS
3	Contingency: If test fails repeat step 2.

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	No. of frames received	Test Result
SPIRE-IST-COLD-FUNC-BSM-03-P				N/A	Pass



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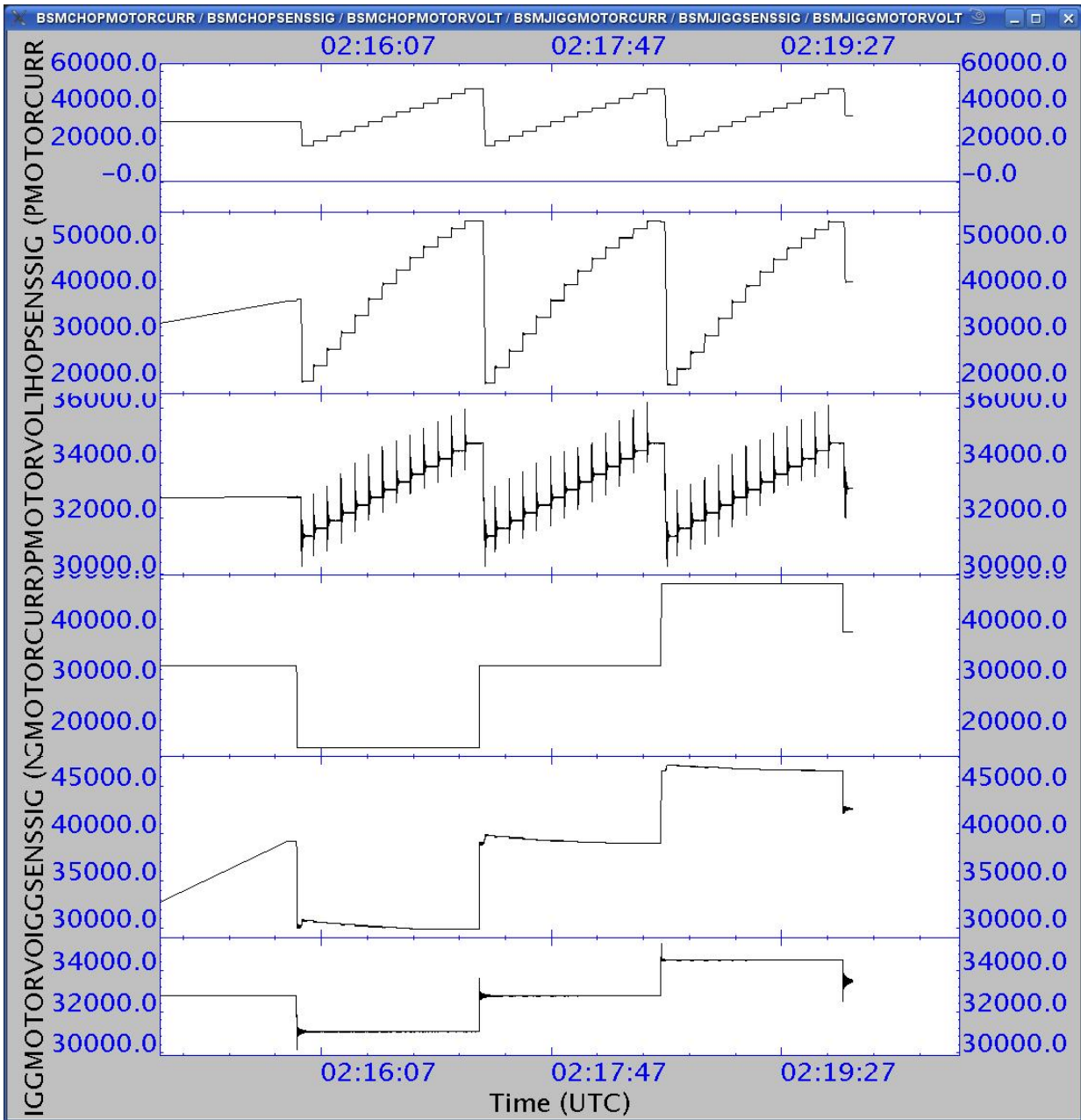
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Start time @: 02:16 UT

End time @:

OBSID: 0xb00017c8

Comments: **Nominal behaviour.**





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3.3.13 SPIRE-IST-COLD-FUNC-BSM-05A-P

Test Id:	SPIRE-IST-COLD-FUNC-BSM-05A-P.tcl
Test Purpose:	BSM Open Loop chop test (Degraded operational mode check)
Initial Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON + BSM ON (open loop)
Final Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON + BSM ON (open loop)
Duration	5 mins (CUS 75.0)
Success Criteria:	<p>Note: The purpose of this test is to check the effectiveness of the dumping of the natural oscillations of the BSM in chop axis via motor bmf, through the use of the commendable motor resistance value. As it is now is just a check of the default motor resistance value. NO adjusting of this value should be attempted during this test.</p> <p>The success criteria are therefore not applicable.</p>
CUS Parameters	<pre>frametype = "BSM"; // Specifies MCU frame type [BSM,SMEC,BSM+SMEC,ENG,TEST] framerate = 125.0; // Specifies the frame rate on_source_chop = 0xa000; // On source chop position on_source_jiggle = 0x8000; // On source jiggle position off_source_chop = 0x8000; // Off source chop position off_source_jiggle = 0x8000; // Off source jiggle position ncycles = 50; //Number of chop cycles chop_period = 500000; //period of chop cycles in microsec dcumode = 0; //Data type dcusample = 4; //Number of DCU samples per chop position dcudelay = 34959; //Dealy to start sampling the DCU bsmsample = 31; //Number of BSM samples per position</pre>

Test Procedure

Step#	Action
1	On QLA open up a time series display of BSM science parameters: BSMCHOPSENSSIG BSMCHOPMOTORCURR BSMCHOPMOTORVOLT
2	Run SPIRE-IST-COLD-FUNC-BSM-05A-P.tcl test procedure from the CCS.
3	Contingency: None contemplated.

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	No. of frames received	Test Result
SPIRE-IST-COLD-FUNC-BSM-05A-P.tcl	BSMCHOPSENSSIG BSMCHOPMOTORCURR BSMCHOPMOTORVOLT	?? ?? ??		N/A	Pass



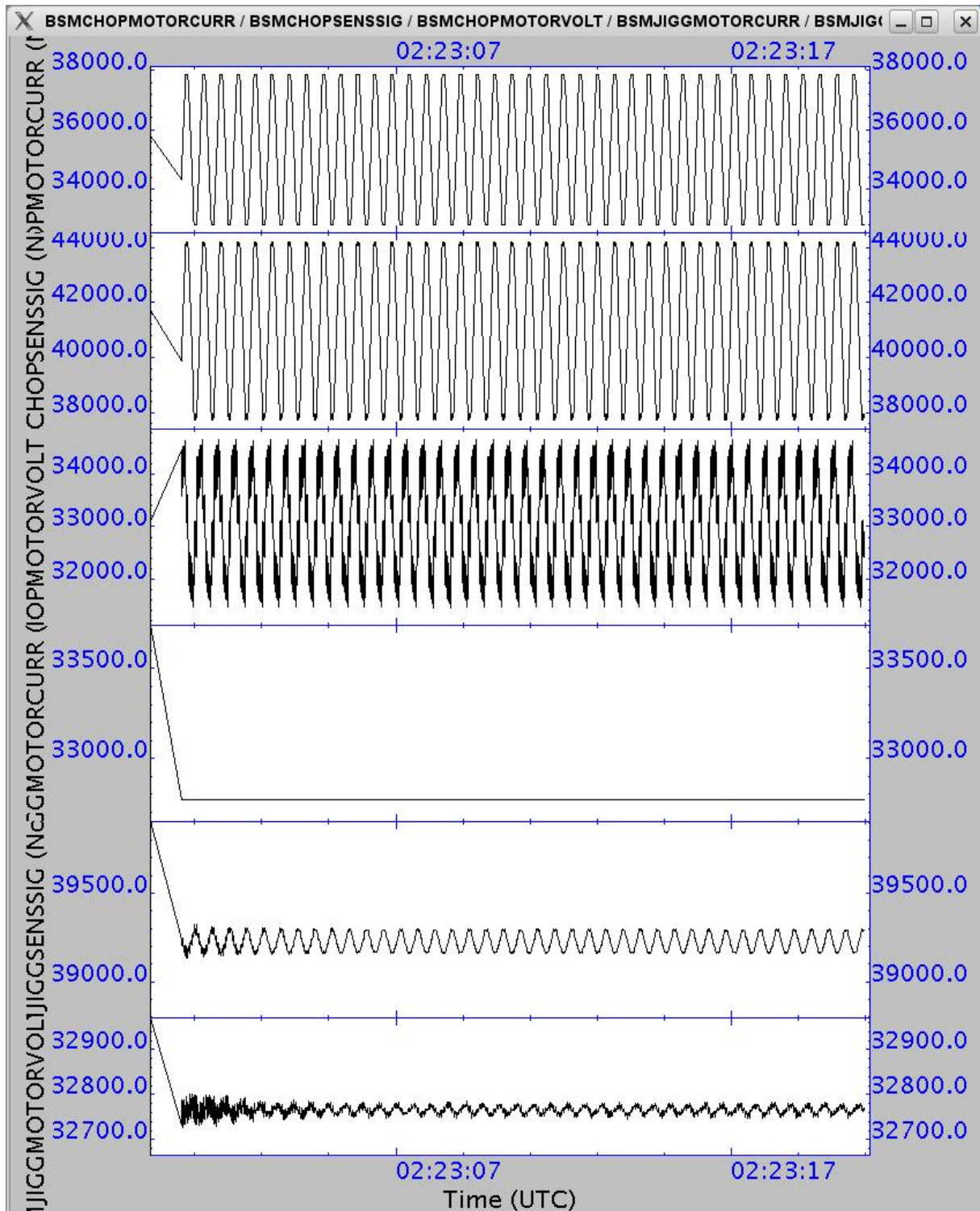
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Start time @: 02:23
End time @:
OBSID: 0xb00017c9

Comments: All looks like it should





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3.3.14 SPIRE-IST-COLD-FUNC-BSM-05B-P

Test Id:	SPIRE-IST-COLD-FUNC-BSM-05B-P
Test Purpose:	BSM Close Loop chop test
Initial Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON + BSM ON (OPEN loop)
Final Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON + BSM ON (CLOSED loop)
Duration	5 mins (CUS 72.0)
Success Criteria:	Note: Currently this test does not differ at ALL from the next one. In any case the success/fail criteria are NOT applicable for this test.
CUS Parameters	frametype = "BSM"; // Specifies MCU frame type [BSM,SMEC,BSM+SMEC,ENG,TEST] framerate = 125.0; // Specifies the frame rate on_source_chop = 0xb600; // On source chop position (46592) on_source_jiggle = 0x9a60; // On source jiggle position (39520) off_source_chop = 0x6a28; // Off source chop position (27176) off_source_jiggle = 0x9a60; // Off source jiggle position (39520) ncycles = 50; //Number of chop cycles chop_period = 500000; //period of chop cycles in microsec dcumode = 0; //Data type dcusample = 4; //Number of DCU samples per chop position dcudelay = 34959; //Dealy to start sampling the DCU bsmsample = 31; //Number of BSM samples per position

Test Procedure

Step#	Action
1	Execute SPIRE-IST-COLD-BSM-INIT-P.tcl from the CCS.
2	On QLA open up a time series display of BSM science parameters: BSMCHOPSENSSIG BSMCHOPMOTORCURR BSMCHOPMOTORVOLT
3	Run SPIRE-IST-COLD-FUNC-BSM-05B-P.tcl test procedure from the CCS.

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	No. of frames received	Test Result
SPIRE-IST-COLD-BSM-INIT-P.tcl	CHOPLOOPMODE JIGLOOPMODE	3/-1 3/-1	3/-1 3/-1	N/A	Pass
SPIRE-IST-COLD-FUNC-BSM-05B-P.tcl	BSMCHOPSENSSIG BSMCHOPMOTORCURR BSMCHOPMOTORVOLT	?? ?? ??	See plots below	N/A	Pass



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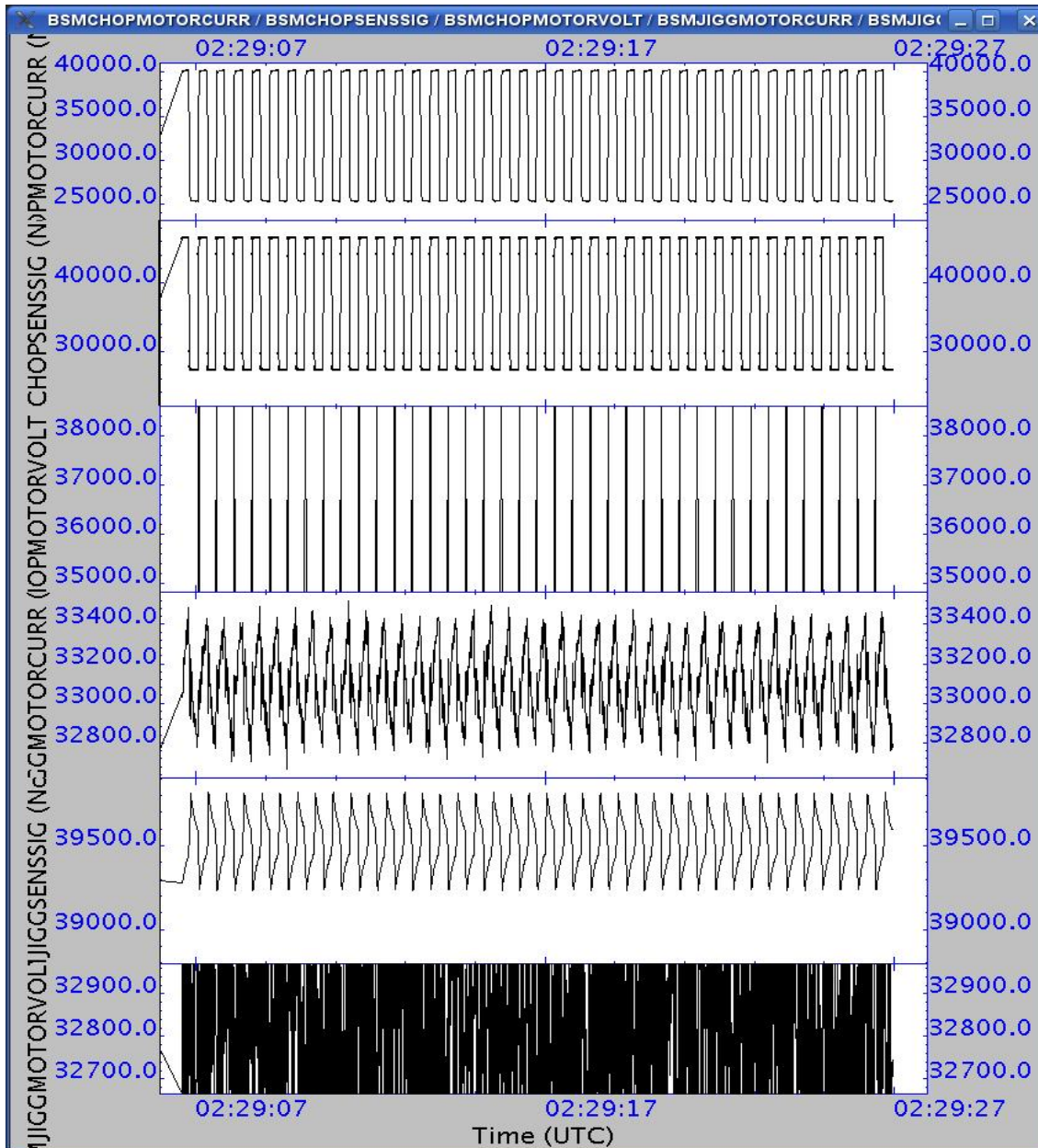
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BSM_INIT:
Start Time: 02:27
End Time:
OBSID: 0xb00017ca

FUNC-BSM-05B
Start time: 02:29
End time:
OBSID: 0xb00017cb

Comments: Chopping OK. **Settling time ~40 ms.**





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3.3.15 SPIRE-IST-COLD-FUNC-BSM-06-P

Test Id:	SPIRE-IST-COLD-FUNC-BSM-06-P
Test Purpose:	BSM Operational Mode Check
Initial Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON + BSM ON (open loop)
Final Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON + BSM ON (open loop)
Duration	5 mins (CUS 72.0)
Success Criteria:	<p>Note:</p> <p>The purpose of this test is to check the effectiveness of the BSM close loop initialisation procedure and the default PID parameters. If the dynamical behaviour of the BSM during chopping with these PID parameters is close or within requirements this indicates that the PID parameters used can be applied to cold testing with certain adjustment. If NOT these indicates that the PID parameters need further tuning BUT NOT TO BE DONE DURING THESE TEST.</p> <p>In any case the success/fail criteria are NOT applicable for this test.</p>
CUS Parameters	<pre>frametype = "BSM"; // Specifies MCU frame type [BSM,SMEC,BSM+SMEC,ENG,TEST] framerate = 125.0; // Specifies the frame rate on_source_chop = 0x5279; // On source chop position (21113) on_source_jiggle = 0x8d00; // On source jiggle position (36096) off_source_chop = 0xad87; // Off source chop position (44423) off_source_jiggle = 0x8d00; // Off source jiggle position (36096) ncycles = 50; //Number of chop cycles chop_period = 500000; //period of chop cycles in microsec dcumode = 0; //Data type dcusample = 4; //Number of DCU samples per chop position dcudelay = 34959; //Dealy to start sampling the DCU bsmsample = 65535; //Number of BSM samples per position</pre>

Test Procedure

Step#	Action
1	On QLA open up a time series display of BSM science parameters: BSMCHOPSENSSIG BSMCHOPMOTORCURR BSMCHOPMOTORVOLT
2	Run SPIRE-IST-COLD-FUNC-BSM-06-P test procedure from the CCS.

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	No. of frames received	Test Result
SPIRE-IST-COLD-FUNC-BSM-06-P	CHOPLOOPMODE	1/1/1	1/1/1		
	JIGGLOOPMODE	1/1/1	1/1/1		
	BSMCHOPSENSSIG	??	See plots below	N/A	N/A
	BSMCHOPMOTORCURR	??			
	BSMCHOPMOTORVOLT	??			



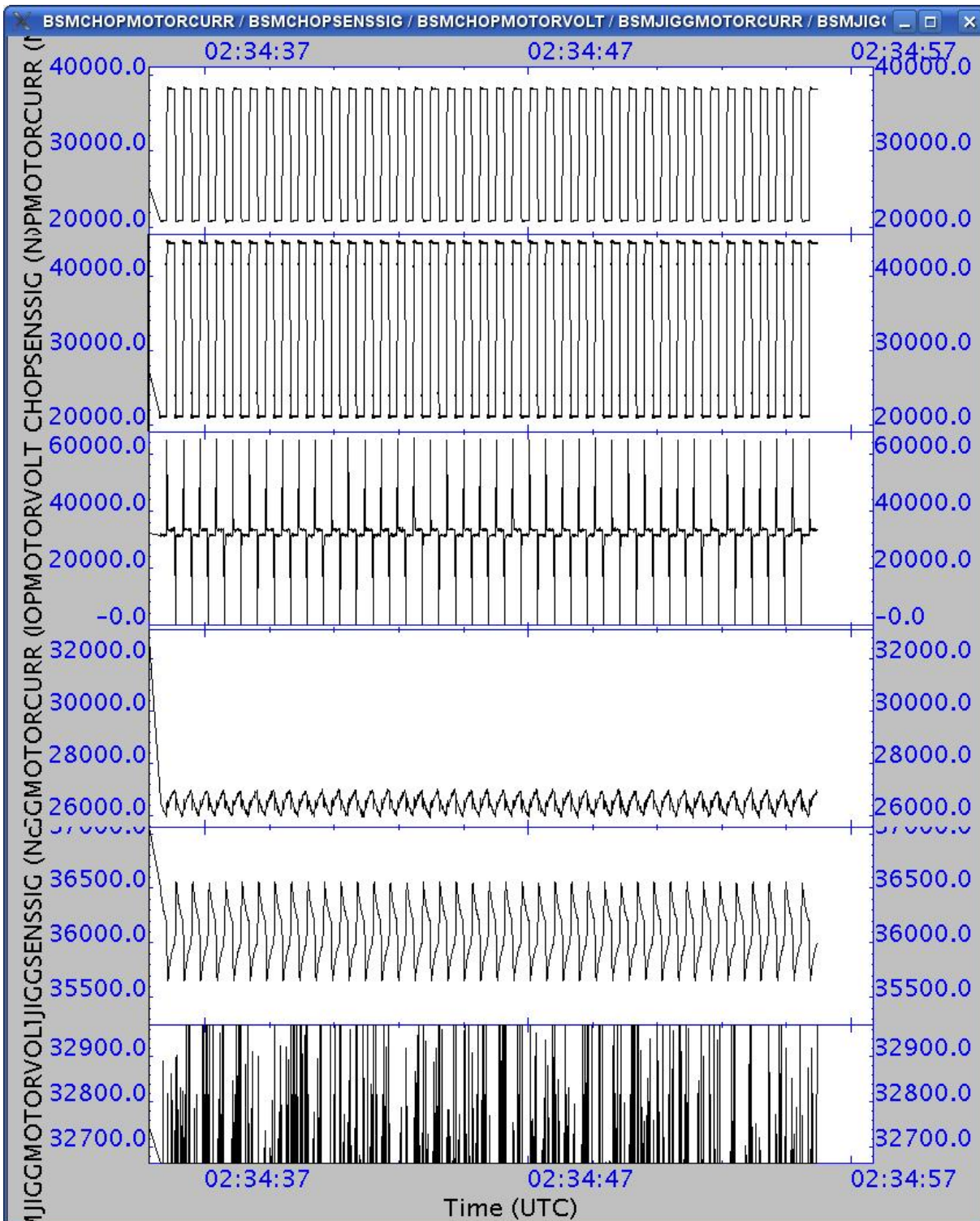
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Start time @: 02:34
End time @:
OBSID: 0xb00017cc

Comments: Settling time ~40 ms





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Step#	Action	Comments
4	Execute SPIRE-IST-COLD-BSM-OFF-P	Start Time: 02:38 End Time: OBSID: 0xb00017cd



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Step#	Action	Comments
0	Open SMEC PARAMETERS display on SCOS Alpha Numeric Displays.	

3.3.16 SPIRE-IST-COLD-FUNC-SMEC-01-P

Test Id:	SPIRE-IST-COLD-FUNC-SMEC-01-P
Test Purpose:	SMEC Switch ON Check. Encoder and LVDT alive check.
Initial Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON+ SMEC ON (open loop)
Final Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON+ SMEC ON (open loop)
Duration	5 Minutes (CUS 40.0)
Success Criteria:	Test passed if : <ol style="list-style-type: none"> 1. SMECENCPWR HK parameter changes from 0 to 1. 2. SMEC encoder signals 1 and 2 show variation when encoder is switched ON. 3. SMEC LVDT is switched ON. 4. SMEC LVDT DC and AC signals show variation when LVDT is switched ON.

Test Procedure:

Step#	Action	Comments
1	Run FUNC-SMEC-01.py script on QLA	
2	Run SPIRE-IST-COLD-FUNC-SMEC-01-P test procedure from the CCS.	
3	Contingency: If test fails repeat steps 1.	

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	No. of frames received	Test Result
SPIRE-IST-COLD-FUNC-SMEC-01-P	SMECENCPWR SMECLVDTPWR SMECENC SIG1 SMECENC SIG2	0/-/1 0/-/1	0/-/1 0/-/1 0x7724 0x72D4	N/A	Pass



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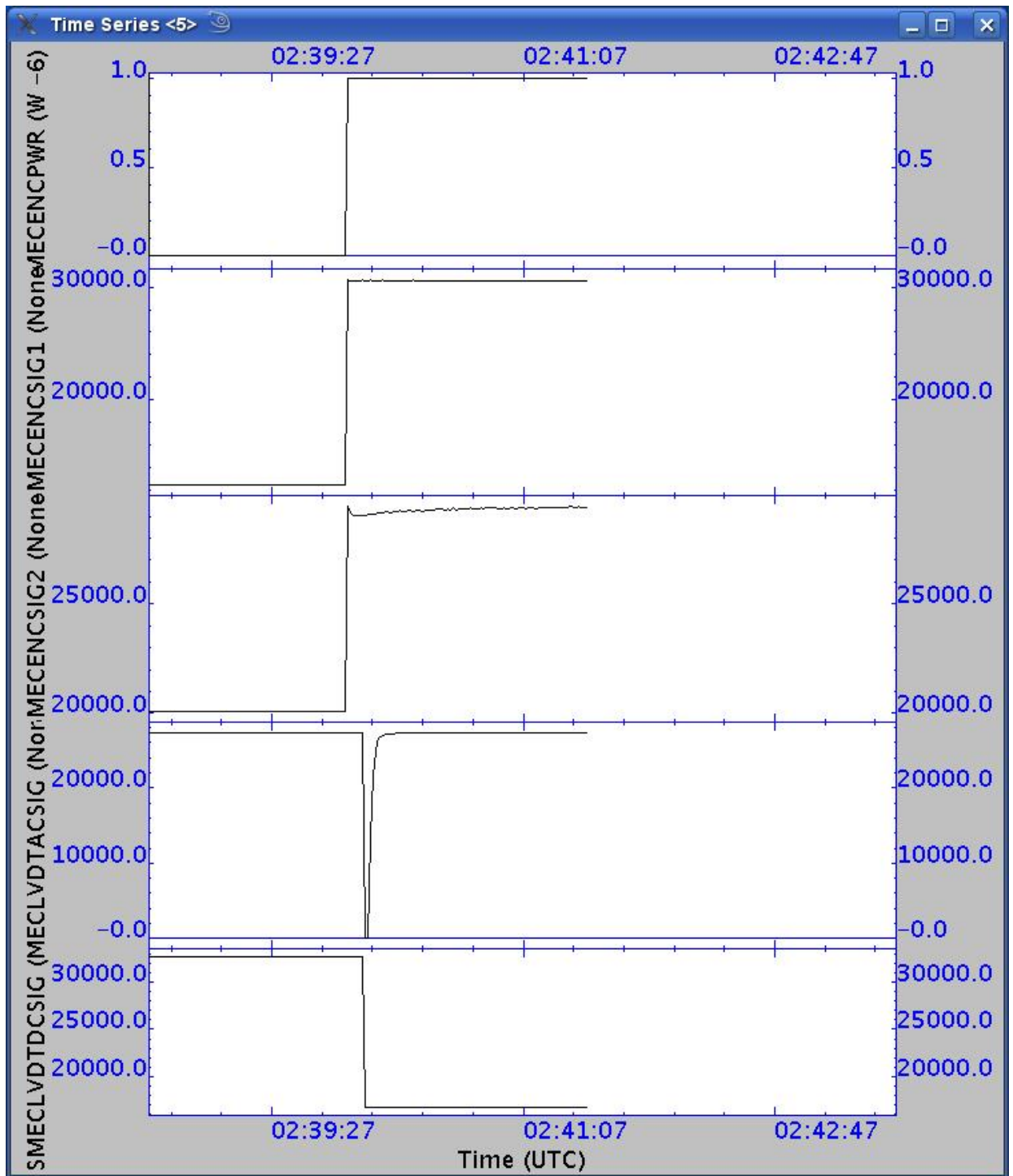
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Start time @: 02:40 UT

End time @:

OBSID: 0xb00017ce

Comments: Passed OK at this temperature no problems





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3.3.17 SPIRE-IST-COLD-FUNC-SMEC-03-P

Test Id:	SPIRE-IST-COLD-FUNC-SMEC-03-P
Test Purpose:	SMEC (PRIME) Encoder Integrity Check.
Initial Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON+ SMEC ON (open loop)
Final Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON+ SMEC ON (open loop)
Duration	5 minutes (CUS 49.0)
Success Criteria:	Test passed if: SMEC encoder signals 1 and 2 show a variation on their amplitudes from one LED illumination level to another. (i.e. MCUENGSMECENC SIG1/2 increase as the encoder power is increased.)
CUS Parameters	frametype = "ENG"; // Specifies MCU frame type [BSM,SMEC,BSM+SMEC,ENG,TEST] framerate = 64.0; // Specifies the frame rate framenummer = 0xffff; // Frame number level_init = 1; // level_start = 1; level_end = 3; level_step = 1; led_delay = 5; // Time at each level in seconds

Test Procedure:

Step#	Action
1	Run FUNC-SMEC-03.py script on QLA
2	Run SPIRE-IST-COLD-FUNC-SMEC-03-P test procedure from the CCS.
3	Contingency: If test fails repeat steps 1 and 2.

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	No. of frames received	Test Result
SPIRE-IST-COLD-FUNC-SMEC-03-P	SMECENC PWR SMECENC SIG1 SMECENC SIG2		See plots below		Pass

Start time @: 02:44
 End time @:
 OBSID: 0xb00017cf

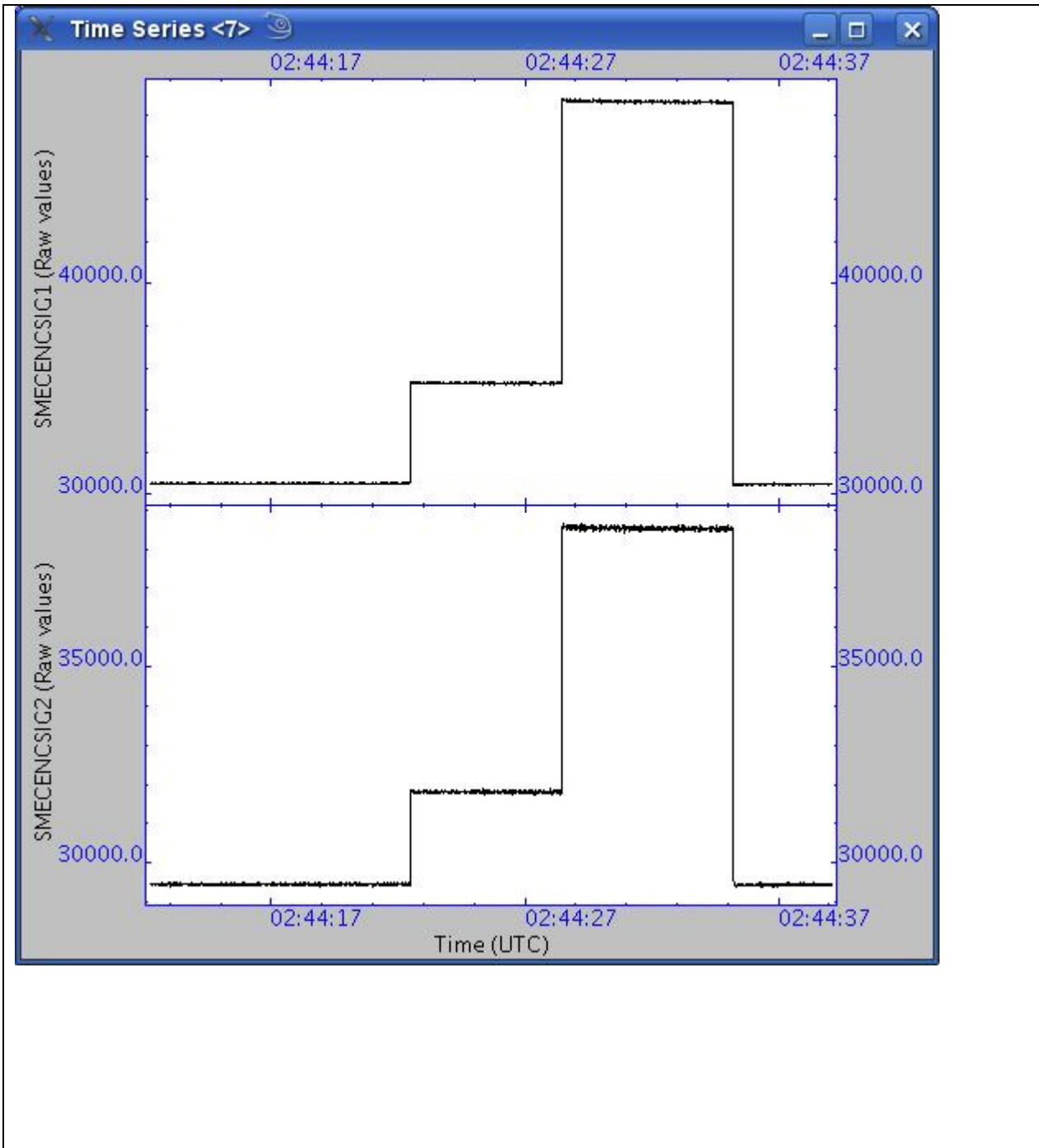
Comments: Encoder signals did not saturate.



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3.3.18 SPIRE-IST-COLD-FUNC-SMEC-OFF-P

Test Id:	SPIRE-IST-COLD-FUNC-SMEC-OFF-P
Test Purpose:	SMEC (PRIME) Switch OFF
Initial Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON+ SMEC ON (open loop)
Final Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON+ SMEC OFF
Duration	3 minutes
Success Criteria:	HK Parameters SMECENCPWR and SMECLVDTPWR show expected OFF values.

Test Procedure:

Step#	Action
1	Run Execute SPIRE-IST-COLD-SMEC-OFF-P.tcl test procedure from the CCS.

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	No. of frames received	Test Result
SPIRE-IST-COLD-SMEC-OFF-P	SMECENCPWR SMECLVDTPWR	1/-/0 1/-/0	1/0 1/0		Pass

Start time @: 02:47 UT
End time @:
OBSID: 0xb00017d0

Comments:



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Step#	Action	Comments
0	Open DCU PARAMETERS SCOS Alpha Numeric Display	

3.3.19 SPIRE-IST-COLD-FUNC-DCU-02-P

Test Id:	SPIRE-IST-COLD-FUNC-DCU-02-P
Initial Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON
Duration	5 Minutes (CUS 140.0)
Success Criteria:	Test passed if DCUFRAMECNT goes from n to n+700 and the frametime difference between consecutive frames computed by QLA script is in agreement with the expected differences based on commanded sampling rate: <ol style="list-style-type: none"> 1. Photometer Sampling rate is 15.3Hz → Δt ~ 65.5 ms 2. Spectrometer Sampling rate is 80Hz → Δt = 12.5 ms
CUS Parameters	photbiasfreq = 200.0; photosampfreq = 15.3; specbiasfreq = 160.0; specsampfreq = 80.0; frames = 100;

Test Procedure:

Step#	Action	Comments
1	Write the current value of DCUFRAMECNT located in DCU PARAMETERS	
2	Run QLA script FUNC-DCU-02.py on QLA console.	
3	Run SPIRE-IST-COLD-FUNC-DCU-02-P test procedure from the CCS.	
4	Write the current value of DCUFRAMECNT	
5	Contingency: If test fails repeat steps 1 to 4.	

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	Nb. of frames received	Test Result
SPIRE-IST-COLD-FUNC-DCU-02-P	DCUFRAMECNT	n/n+700	1200/1900	700	Success
Start time @: 02:51 End time @: OBSID: 0xb00017d1 Comments: Temps are OK see entry for SCU-03 QLA script successfully produced files.					



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3.3.20 SPIRE-IST-COLD-FUNC-DCU-11-PHOT-P

Test Id:	SPIRE-IST-COLD-FUNC-DCU-11-PHOT-P
Test Purpose:	Photometer BDAs Switch ON Check
Initial Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON+ Photometer LIAs ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON+ Photometer LIAs ON + Photometer BIAS ON +Photometer JFETs ON
Duration	7 minutes (CUS 122.0)
Success Criteria:	Test passed if Photometer JFET source and drain voltages are correct: <ol style="list-style-type: none"> 1. PSWJFETVSS1/2/3/4/5/6 (values according to latest Vss). 2. PMLWJFETVSS1/2/3/4 (values according to latest Vss). 3. PSWJFETSTAT = 0x3F 4. PMLWJFETSTAT = 0x7F
CUS Parameters	heater_V = 0; // Specifies if the heater is to be switched ON or not array = "PF"; //default array to switch ON

Test Procedure:

Step#	Action
1	Run SPIRE-IST-COLD-FUNC-DCU-11-PHOT-P test procedure from the CCS. with default input parameters
2	After the test, write down the values RAW and converted values of: PSWJFETSTAT, PMLWJFETSTAT, PSWJFET1/2/3/4/5/6V PMWJFET1/2/3/4V PLWJFET1/2V located in the DCU PARAMETERS display
3	Contingency: If test fails repeat steps 1 and 2.

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	No. of frames received	Test Result
SPIRE-IST-COLD-FUNC-DCU-11-PHOT-P	PSWJFETSTAT PMLWJFETSTAT PLIABITSTAT PLIAP5V PLIAP9V PLIAM9V	0/0x3f 0/0x7f 1 ~0/ ~+5.17 ± 0.1V ~0/ ~+11.53 ± 0.1V ~0/ ~-11.53 ± 0.1V	OK OK 1 5.23V 11.58V -11.58V	N/A	Pass



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Start time @: 03:11

End time @:

OBSID: 0xb00017d2

Comments:

Flow rate is at 22.5 mg/sec

Used JPL approved switch-on procedure for the JFETs.

Initial Vss values were -1.47V.

Final Vss values were consistent with Jamie Bock's spreadsheet (least noise).

See Annexe 1 for the load curve plots



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3.3.21 SPIRE-IST-COLD-FUNC-DCU-13-PHOT-P

Test Id:	SPIRE-IST-COLD-FUNC-DCU-13-PHOT-P
Test Purpose:	Photometer Detectors Integrity Check
Initial Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON+ Photometer LIAs ON + Photometer BIAS ON +Photometer JFETs ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON+ Photometer LIAs ON + Photometer BIAS ON +Photometer JFETs ON
Duration	15 minutes (CUS 726)
Success Criteria:	Test passed if : The photometer detectors show a small linear variation on the output voltage when different bias is applied through the load curve.
CUS Parameters	dcumode = "PF"; // Specifies array in which to perform LC mclkdiv = 0x95; // Master clock divisor ,which specifies bias freq biasdiv = 0x6; // Sampling divisor ,which specifies sampling rate psw_phase = 0x80; // PSW demod phase pmw_phase = 0x80; // PMW demod phase plw_phase = 0x80; // PLW demod phase ftime = 10; // Time at each bias level

Test Procedure:

Step#	Action
1	Run FUNC-DCU-13P.py script on QLA
2	Run SPIRE-IST-COLD-FUNC-DCU-13-PHOT-P test procedure from the CCS. With default input parameters
3	Contingency: If test fails repeat step 1 and 2.

Test Log:

Test Id	Key Parameter(s)	Expected Value Before	Actual Value Before/After	No. of frames received	Test Result
SPIRE-IST-COLD-FUNC-DCU-13-PHOT-P	PLIABITSTAT PSWJFETSTAT PMLWJFETSTAT	1/1 0x3F/0x3F 0x7F/0x7F	1/1 0x3F/0x3F 0x7F/0x7F		Pass

OBSID: 0xb00017d3

Start: 03:19 UT

End:

DRCU Current taken from S/C (parameter WM408565 Display ZAWS1999)

SpireHsfN_L51_I2.1242 A

Comments: Ran visual check on all JFETs – all look OK

See Annexe 1 for Load Curve plots – all the plots are the same as before.

The calculated bolometer resistances are in Annexe 2.



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3.3.22 SPIRE-IST-COLD-FUNC-DCU-14-PHOT-P

Test Id:	SPIRE-IST-COLD-FUNC-DCU-14-PHOT-P
Initial Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON + Photometer LIAs ON + Photometer BIAS ON + Photometer JFETs ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON + Photometer LIAs ON + Photometer BIAS ON + Photometer JFETs ON
Duration	5 minutes
Success Criteria:	Test passed if : The Photometer detectors do not show excess noise.

Test Procedure:

Step#	Action	Comments
1	Run SPIRE-IST-COLD-FUNC-DCU-14-PHOT-P test procedure from the CCS.	
2	Contingency: If test fails repeat step 1.	

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	Nb. of frames received	Test Result
SPIRE-IST-COLD-FUNC-DCU-14-PHOT-P	PLIABITSTAT PSWJFETSTAT PMLWJFETSTAT	1/1 0x3F/0x3F 0x7F/0x7F	1/1 0x3F/0x3F 0x7F/0x7F		PASS

Start time @: 03:35
End time @:
OBSID: b00017d4

Comments:



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3.3.23 SPIRE-IST-COLD-PHOT-VSS-P

Test Id:	SPIRE-IST-COLD-PHOT-VSS-P
Purpose:	Photometer BDAs Vss Test PRIME
Initial Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON + Photometer LIAs ON + Photometer BIAS ON + Photometer JFETs ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON + Photometer LIAs ON + Photometer BIAS ON + Photometer JFETs ON
Duration	40 minutes
Success Criteria:	Test passed if the Photometer detectors do not show excess noise.

Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Check that Photometer LIAs and detectors are switched on	PLIABITSTAT PSWJFETSTAT PMLWJFETSTAT	1/1 0x3F/0x3F 0x7F/0x7F		
2	Execute TCL script SPIRE-IST-COLD -PHOT-VSS-P.tcl	—	—	—	
3	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
Test Result (Pass/Fail):					

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	Nb. of frames received	Test Result
SPIRE-IST-PHOT-VSS-P	PLIABITSTAT PSWJFETSTAT PMLWJFETSTAT	1/1 0x3F/0x3F 0x7F/0x7F	1/1 0x3F/0x3F 0x7F/0x7F	NA	Pass



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Start time @: 03:40

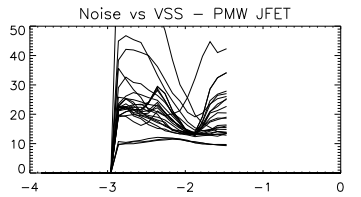
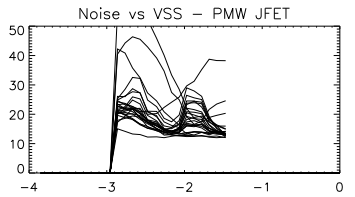
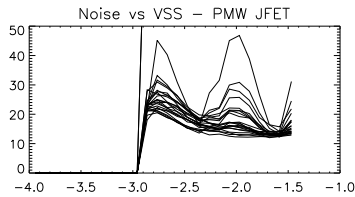
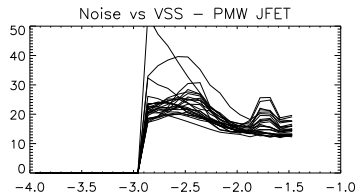
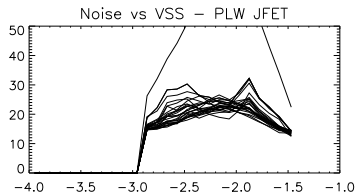
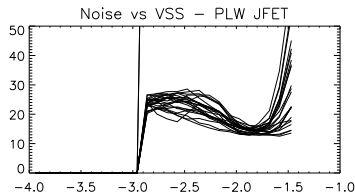
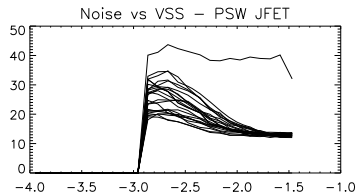
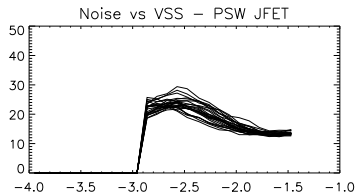
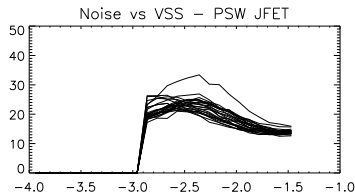
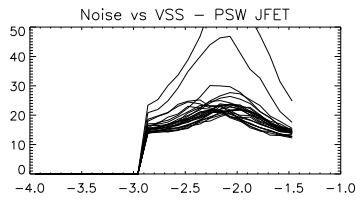
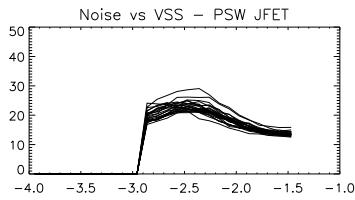
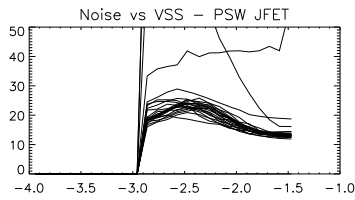
End time @:

OBSID: 0xb00017d5

Comments:

Script executed successfully.

See Noise (nV/\sqrt{Hz}) v. Vss plot below





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3.3.24 SPIRE-IST-COLD-PDET-OFF-P

Test Id:	SPIRE-IST-COLD-PDET-OFF-P
Test Purpose:	Photometer BDAs Switch OFF
Initial Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON + Photometer BDAs ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON + Photometer BDAs OFF
Duration	3 minutes
Success Criteria:	Test passed if SCUDCDCSTAT goes from 4 to 6, Spectrometer LIAs voltages are correct and SJFET voltages are also correct.

Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Execute TCL script SPIRE-IST-COLD-PDET-OFF-P.tcl	—	—	—	
2	Check that the Photometer detectors are switched off	PSWJFETSTAT PMLWJFETSTAT	0x3F/-/0 0x7F/-/0		
3	Check that the Photometer LIAs are switched off	PLIABITSTAT	1/-/0		
4	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	

Test Result (Pass/Fail):

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	Nb. of frames received	Test Result
SPIRE-IST-PDET-OFF-P	PLIABITSTAT PSWJFETSTAT PMLWJFETSTAT	1/0 0x3F/0 0x7F/0	1/0 0x3F/0 0x7F/0	N/A	Pass



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Start time @: 04:46

End time @:

OBSID: 0xb00017d9

Comments: First attempt failed with mismatch between the number of TCs in the CCS template and the I-EGSE CUS DB.

Stopped CCS Handler

Changed mission configuration to fm_ist_cft_config14p – restarted CCS Handler

Success.



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3.3.25 SPIRE-IST-COLD-FUNC-DCU-11-SPEC-P

Test Id:	SPIRE-IST-COLD-FUNC-DCU-11-SPEC-P
Test Purpose:	Spectrometer BDAs switch ON check
Initial Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON + Spectrometer LIAs ON + Spectrometer BIAS ON + Spectrometer JFETs ON
Duration	7 minutes
Success Criteria:	Test passed if SCUDCDCSTAT goes from 4 to 6, Spectrometer LIAs voltages are correct and SJFET voltages are also correct.
CUS Parameters	heater_V = 0; //Specifies if the heater is to be switched ON array = "SF"; //default array to swich ON

Test Procedure:

Step#	Action
1	Run SPIRE-IST-COLD-FUNC-DCU-11-SPEC-P test procedure from the CCS.
2	After the test Write down the values RAW and converted values of: LIASTAT SLIAP5V, SLIAP9V, SLIAM9V SSWJFETSTAT,SLWJFETSTAT SSWJFET1V,SLWJFET2d located in on the DCU PARAMETERS display.
3	Contingency: If test fails repeat steps 1 and 2.

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	No. of frames received	Test Result
SPIRE-IST-COLD-FUNC-DCU-11-SPEC-P	SPECJFETSTAT SSWJFET1V SSWJFET2V SLWJFET1V SLIABITSTAT SLIAP5V SLIAP9V SLIAM9V	0/7 0V/-1.5V 0V/-1.5V 0V/-1.5V 1 ~0/ ~+5.23 ± 0.1V ~0/ ~+11.57 ± 0.1V ~0/ ~-11.54 ± 0.1V	0 / 7 0 / -V 0 / -V 0 / -V See plots below 5.25V 11.59V -11.57V	N/A	Pass

Changed config back to fm_ist_cft_config19p_Kourou and restarted CCS Handler

First attempt will be to switch on the Spec JFETs at the nominal Vss values of ~-1.5V

- Check mission configuration to ensure the right Vss values are used – Config is fm_ist_cft_config19p_Kourou

Start time @: 04:53

End time @:

OBSID: 0xb00017da

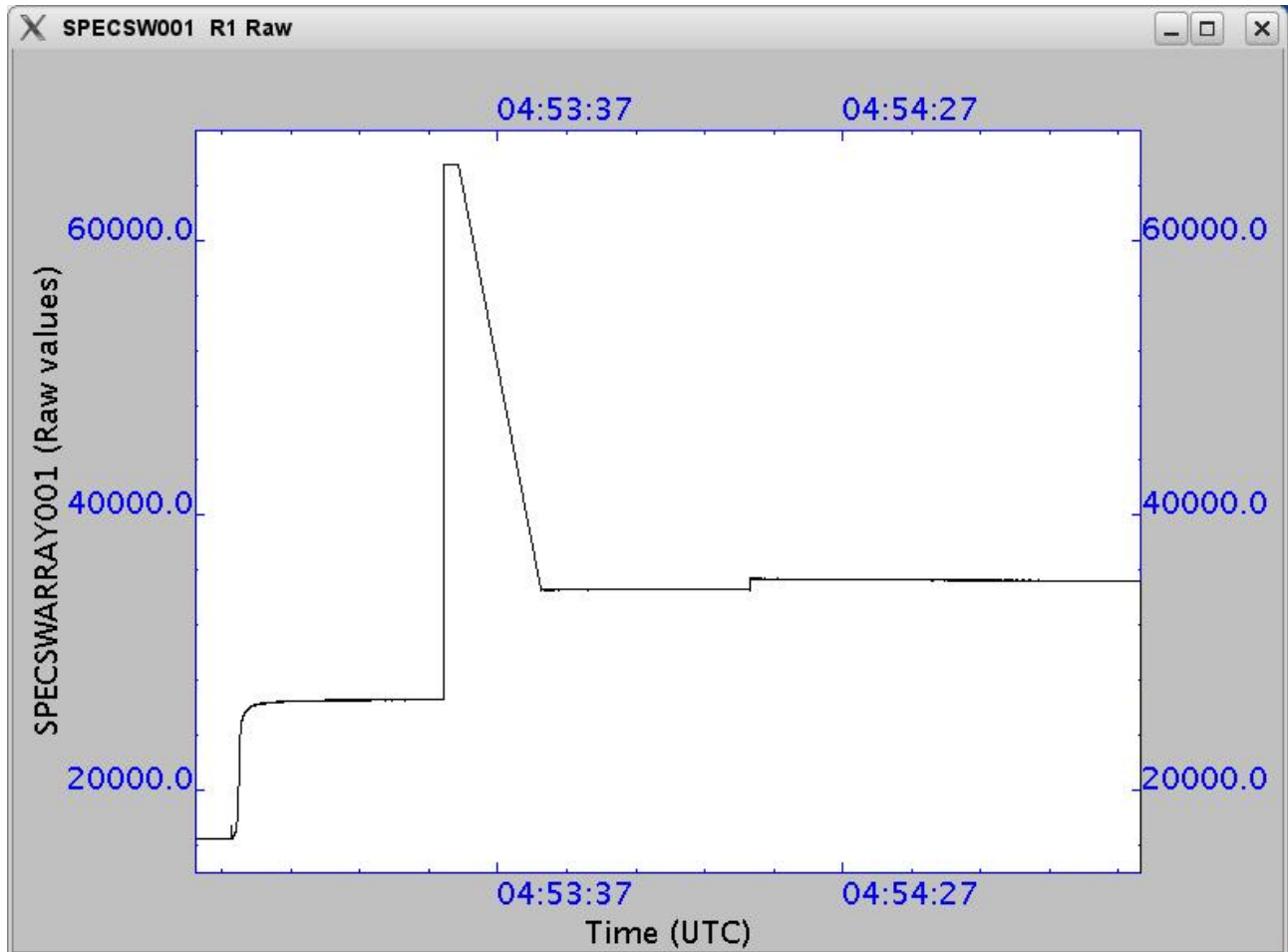


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Comments: JFETs were turned on using the default PFM Vss settings (-1.47 V for all membranes). Both SSW membranes responded immediately – looks like we have proved the case that the failure to switch on is associated with the JFET temperature.

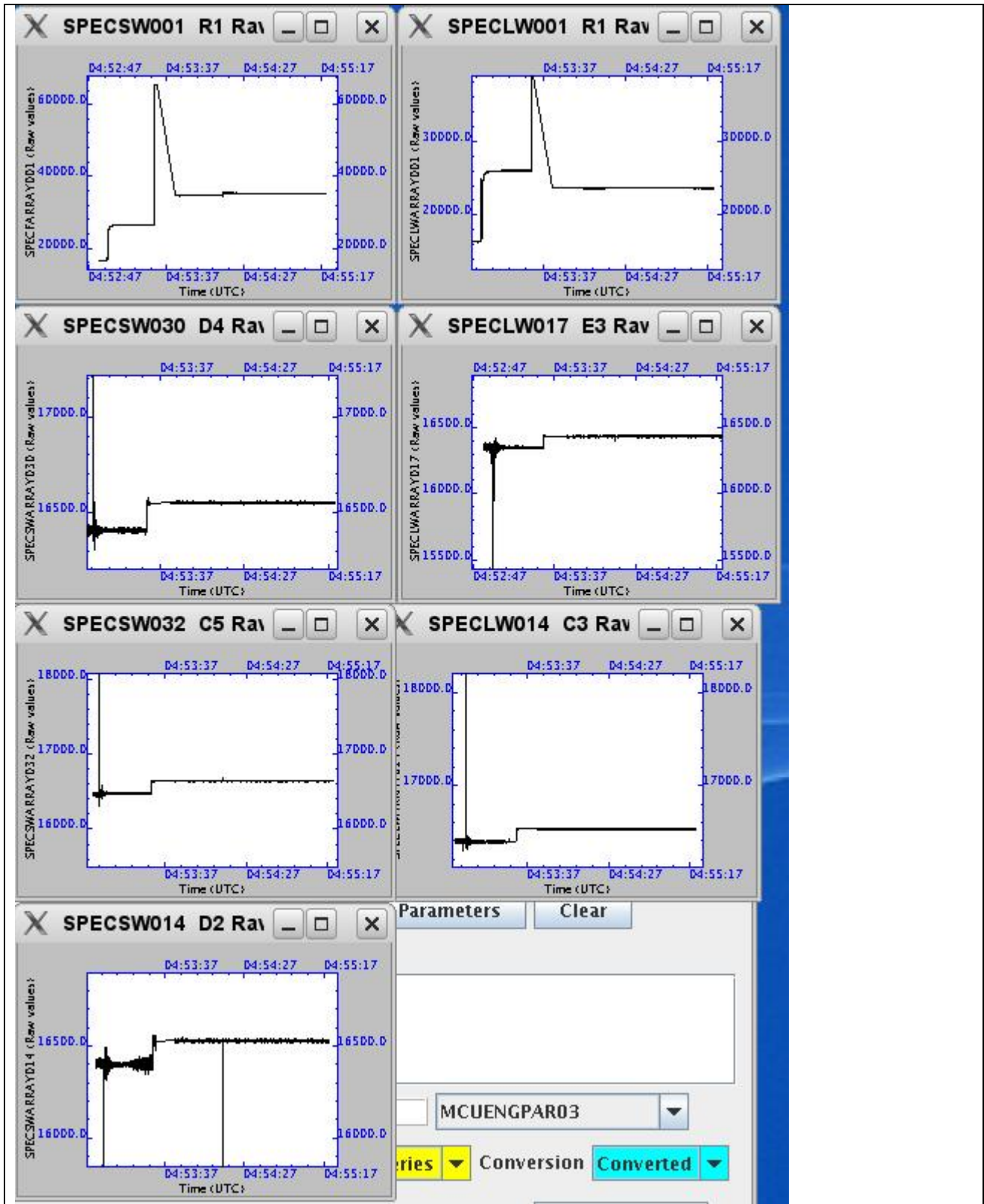




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3.3.26 SPIRE-IST-COLD-FUNC-DCU-13-SPEC-P

Test Id:	SPIRE-IST-COLD-FUNC-DCU-13-SPEC-P
Test Purpose:	Spectrometer detectors check
Initial Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON + Spectrometer LIAs ON + Spectrometer BIAS ON + Spectrometer JFETs ON
Final Configuration:	Unchanged
Duration	12 minutes
Success Criteria:	The spectrometer detectors show a small linear variation on the output voltage when different bias is applied through the load curve.
CUS Parameters	dcumode = "SF"; //DCU data mode mclkdiv = 0x79; //Master clock divisor biasdiv = 0x1; // Bias divisor ssw_phase = 0x80; // SSW demod phase slw_phase = 0x80; // SLW demod phase ftime = 10; // Time at each bias level

Test Procedure:

Step#	Action	Comments
1	On QLA bring up a time series display of a couple of pixels on each of the spectrometer BDAs	
2	Run SPIRE-IST-COLD-FUNC-DCU-13-SPEC-P test procedure from the CCS.	
3	Contingency: If test fails repeat steps 1 and 2	

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	No. of frames received	Test Result
SPIRE-IST-COLD-FUNC-DCU-13-SPEC-P	SPECJFETSTAT SLIABITSTAT	7 1	7 1	N/A	Pass

Start time @: 05:02
End time @:
OBSID: 0xb00017dc

The OBSID skips from a to c because CCS templates were being checked using the DB.

Load Curve plots look OK.

See Annexe 1 for the load curve plots.

The calculated bolometer resistances are in Annexe 2.



3.3.27 SPIRE-IST-COLD-FUNC-DCU-14-SPEC-P

Test Id:	SPIRE-IST-COLD-FUNC-DCU-14-SPEC-P
Initial Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON + Spectrometer LIAs ON + Spectrometer BIAS ON + Spectrometer JFETs ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON + Spectrometer LIAs ON + Spectrometer BIAS ON + Spectrometer JFETs ON
Duration	5 minutes (CUS 146.0)
Success Criteria:	The Spectrometer detectors don't show excess noise.
CUS Parameters	dcumode = "SF"; //Array ftime = 120; //time

Test Procedure:

Step#	Action	Comments
1	Run SPIRE-IST-COLD-FUNC-DCU-14-SPEC-P test procedure from the CCS.	
2	Contingency: If test fails repeat step 1.	

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	Nb. of frames received	Test Result
SPIRE-IST-COLD-FUNC-DCU-14-SPEC-P	SPECJFETSTAT SLIABITSTAT	7 1	7 1	N/A	Pass

Start time @: 05:14

End time @:

OBSID: b00017dd

Comments:



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3.3.28 SPIRE-IST-COLD- SPEC-VSS-P

Test Id:	SPIRE-IST-COLD-SPEC-VSS-P
Purpose	Spectrometer BDAs Vss Test PRIME
Initial Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON + Spectrometer LIAs ON + Spectrometer BIAS ON + Spectrometer JFETs ON
Final Configuration:	Unchanged
Duration	40 minutes (CUS 906.0)
Success Criteria:	Spectrometer BDA Vss values are optimised
CUS Parameters	jfet_Vss_start = -1.5; //Starting JFET source voltage jfet_Vss_end = -4.0; //ending JFET source voltage jfet_Vss_step = -0.1; //stepping JFET source volatge ftime = 60; //wait time at each level;

Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Check that the Spectrometer detectors and LIAs are switched on	SPECJFETSTAT SLIABITSTAT	7 1		
2	Execute TCL script SPIRE-IST-COLD- SPEC-VSS-P.tcl	—	—	—	
3	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
Test Result (Pass/Fail):					

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	Nb. of frames received	Test Result
SPIRE-IST-COLD-SPEC-VSS-P	SPECJFETSTAT SLIABITSTAT	7 1	7 1	N/A	Pass



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Start time @: 05:19

End time @:

OBSID: 0xb00017de

Comments:

Detectors settings:

Bias frequency: 160.09 Hz

Sampling frequency: 80.05 Hz

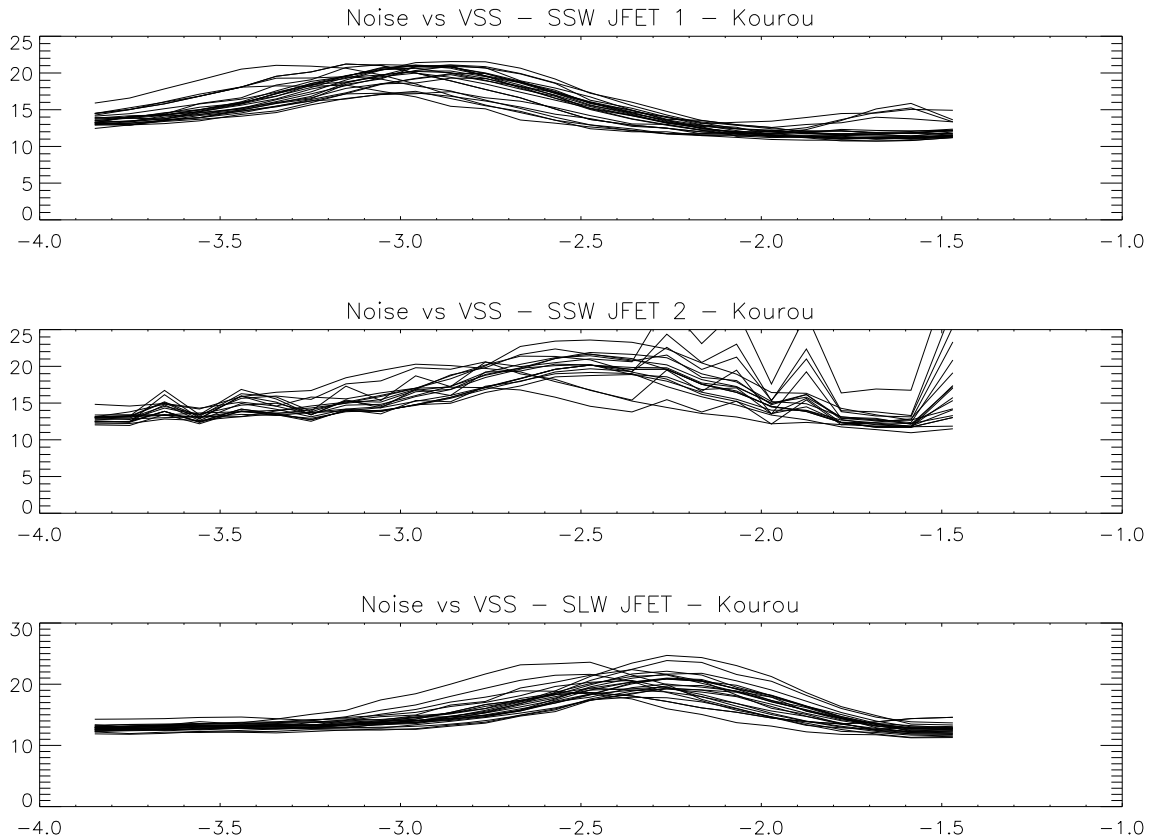
SSW phase: 180.71 deg

SLW phase: 180.71 deg

SSW bias : ~ 31mV

SLW bias : ~ 31mV

See Noise ($\text{nV}/\sqrt{\text{Hz}}$) v. Vss plot below





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3.3.29 SPIRE-IST-COLD-SDET-OFF-P

Test Id:	SPIRE-IST-COLD-SDET-OFF-P
Purpose	Spectrometer BDAs Switch OFF
Initial Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON + Spectrometer LIAs ON + Spectrometer BIAS ON + Spectrometer JFETs ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON + Spectrometer BDAS OFF
Duration	3 minutes
Success Criteria:	DCU HK parameters show expected values

Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Execute TCL script SPIRE-IST-COLD-SDET-OFF-P.tcl	—	—		OK
2	Check that the Spectrometer detectors are switched off	SPECJFETSTAT	7/-/0	7/-/0	OK
3	Check that the Spectrometer LIAs are switched off	SLIABITSTAT	1/-/0	1/-/0	OK
4	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	OK

Test Result (Pass/Fail):

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	Nb. of frames received	Test Result
SPIRE-IST-COLD-SDET-OFF-P	SPECJFETSTAT SLIABITSTAT	7 1		N/A	PASS



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Stopped CCS Handler

Changed mission configuration to fm_ist_cft_config14p – restarted CCS Handler

Start time @: 05:51

End time @:

OBSID: 0xb00017df

Comments: Switched off successfully.

Modified the CUS script to not switch-on SSW JFET-2

Stopped CCS Handler

Changed mission configuration to fm_ist_cft_config20p_Kourou – restarted CCS Handler

SPIRE-IST-COLD-FUNC-DCU-11-SPEC-P

OBSID: 0xb00017e1

Start time: 06:03

Confirmed that the correct JFET is left switched OFF.

Changed mission configuration back to fm_ist_cft_config14p – restarted CCS Handler

SPIRE-IST-COLD-SDET-OFF-P

OBSID: 0xb00017e2

Start time: 06:08

CCS switched the CDMS to Bus B



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3.3.30 SPIRE-IST-COLD-MCU-OFF-P

Test Id:	SPIRE-IST-COLD-MCU-OFF-P
Purpose	MCU Prime Switch OFF
Initial Configuration:	DRCU_ON + AC/DC thermometry ON+MCU Prime ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON+MCU Prime OFF
Duration	5 minutes
Success Criteria:	MCU HK parameters show expected values

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Execute SPIRE-IST-COLD-MCU-OFF-P.tcl	—	—	—	OBSID: 0xb00017e3 06:16
2	Check that the MCU is switched off	MCUBITSTAT	1/-/0	1/-/0	OK
Test Result (Pass/Fail): PASS					



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3.3.31 SPIRE-IST-COLD-SCU-OFF-P

Test Id:	SPIRE-IST-COLD-SCU-OFF-P
Purpose	SCU Prime Switch OFF
Initial Configuration:	DRCU_ON + AC/DC thermometry ON
Final Configuration:	DRCU_ON + AC/DC thermometry OFF
Duration	5 minutes
Success Criteria:	SCU HK parameters show expected values

Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Execute TCL script SPIRE-IST-COLD-SCU-OFF-P.tcl	—	—	—	OBSID: 0xb00017e4 06:19
2	A few seconds later record the value of parameter SCUTEMPSTAT	SCUTEMPSTAT	0xFFFF/-/0	0xFFFF/-/0	OK
3	A few seconds later record the value of parameter SUBKSTAT	SUBKSTAT	1/-/0	1/-/0	OK
Test Result (Pass/Fail): PASS					



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3.3.32 SPIRE-IST-COLD-DRCU-OFF-P

Test Id:	SPIRE-IST-COLD-DRCU-OFF-P
Purpose	DRCU PRIME Switch OFF
Initial Configuration:	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON.
Final Configuration:	SPIRE DPU PRIME is ON, SPIRE DRCU PRIME is OFF and SPIRE HK is not being produced.
Duration	5 minutes
Success Criteria:	THSK and TM2N stop refreshing/incrementing

Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Execute TCL script SPIRE-IST-COLD-DRCU-OFF.tcl	—	—	—	OK
2	Check that THSK parameter is not refreshing anymore	THSK	Not refreshing	—	OK
3	Check that TM2N parameter is not incrementing anymore	TM2N	Not incrementing	—	OK
4	Power OFF the SPIRE DRCU PRIME unit.	—	—	—	

Test Result (Pass/Fail): PASS

OBSID: 0xb00017e5

06:21



3.3.33 SPIRE-IST-COLD-DPU-OFF-P

Test Id:	SPIRE-IST-COLD-DPU-OFF-P
Purpose	DPU PRIME Switch OFF
Initial Configuration:	SPIRE DPU PRIME is ON but not generating HK.
Final Configuration:	SPIRE DPU PRIME is OFF.
Duration	5 minutes
Success Criteria:	Power to SPIRE DPU PRIME is OFF

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Power OFF the SPIRE DPU PRIME unit.	—	—	—	OK

Test Result (Pass/Fail): PASS

Switched off at 06:23



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3.3.34 SPIRE-IST-COLD-DPU-ON-R

Version	2.4
Date	6th December 2007
Purpose	To switch on the SPIRE DPU RED and start generating housekeeping
Initial configuration	SPIRE DPU and DRCU RED are switched off
Final configuration	SPIRE DPU RED is ON and SPIRE HK is being produced , SPIRE DRCU RED is OFF
Preconditions	<ul style="list-style-type: none">• SPIRE FM DPU is electrically integrated with the Herschel Satellite• SPIRE MIB RED is imported in the CCS database.• CCS is up and running• FUNCTIONAL TEST PARAMETERS display is selected on the CCS
Duration	5 minutes
Pass/Fail Criteria	Nominal and critical HK reports start being generated at their nominal rates of 1Hz and 0.5Hz respectively.

Procedure Steps:



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Step	Description	Parameter	Expected Values Before/After	Actual Values Before/After	Pass/Fail
1	Select DPU AND OBS PARAMETERS display is on the CCS	—	—	—	Pass
2	Power ON the SPIRE DPU RED unit using the dedicated spacecraft LCL line and configure 1553 Spacecraft bus for SPIRE DPU RED (RT = 22)	—	—	—	Pass
3	Wait for the boot software to produce at least 2 event packets (5,1)	—	—	—	Pass
4	Execute TCL script SPIRE-IST-COLD-DPU-START-R.tcl	—	—	—	Pass
5	Check that Nominal and Critical HK packets are arriving at the CCS: SPIRE Nominal HK: <ul style="list-style-type: none"> • (type ,subtype) : (3,25) • APID : 0x503 SPIRE Critical HK: <ul style="list-style-type: none"> • (type ,subtype) : (3,25) • APID: 0x501 	—	—	—	Pass
6	Check that THSK parameter is refreshing every second	THSK	Refreshing @ 1 Hz	—	Pass
7	Check that TM2N parameter is incrementing by 1 every second	TM2N	Incrementing by 1 @ 1Hz	—	Pass
8	Check that TM1N parameter is incrementing by 1 every 2 second	TM1N	Incrementing by 1 @ 0.5Hz	—	Pass
9	On CCS check the consistency of the SPIRE on board time to the HCDMU time and the CCS. *	—	—	—	Pass
10	On I-EGSE check the consistency between SCOS time and THSK and QLA time.	THSK	Incrementing once per second	—	Pass

Test Result (Pass/Fail): Pass – Booted from the secondary partition

Start time: 06:39
OBSID: 0xb00017e7

DPU current switched on from S/C – parameter SpireHsdR_L12_I (WM808565) is 0.45 A

* Assuming that OBT is provided by the HCDMU following RD02, i.e, OBT is TAI, there should be a 33 second difference between OBS and CCS time (assuming CCS is using UTC). In the case the HCDMU is using UTC to specify the on board time, there should be no difference between THSK and the CCS/I-EGSE system time.



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3.3.35 SPIRE-IST-COLD-DRCU-ON-R

Version	2.4
Date	6th December 2007
Purpose	To switch on the SPIRE DRCU RED and start generating housekeeping
Initial configuration	SPIRE DPU RED is ON and DRCU RED is switched OFF
Final configuration	SPIRE DPU and DRCU RED are ON and SPIRE HK is being produced
Preconditions	<ul style="list-style-type: none">• SPIRE FM DRCU is electrically integrated with the Herschel Satellite• SPIRE DRCU is switched OFF• SPIRE MIB RED is imported in the CCS database.• CCS is up and running• FUNCTIONAL TEST PARAMETERS display is selected on the CCS
Duration	5 minutes
Pass/Fail Criteria	DRCU voltages show expected 'ON' values



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Procedure steps:

Step	Description	Parameter	Expected Values Before/After	Actual Values Before/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-DRCU-START-R-STEP1.tcl	—	—	—	Pass
2	Check that THSK parameter is not refreshing anymore	THSK	Not refreshing	—	Pass
3	Check that TM2N parameter is not incrementing anymore	TM2N	Not incrementing	—	Pass
4	Power ON the SPIRE DRCU RED unit using the dedicated spacecraft LCL line.	—	—	—	Pass
5	Execute TCL script SPIRE-IST-COLD-DRCU-START-R-STEP2.tcl Note: The two TCs to clear the SPIRE Critical and Nominal HK reports will fail during execution of this script. These should be ignored because the HK reports will already have been cleared by script SPIRE-IST-COLD-DRCU-START-R-STEP1.tcl	—	—	—	Pass
6	Check that THSK parameter is again refreshing every second	THSK	Refreshing @ 1Hz	—	Pass
7	Check that TM2N parameter is again incrementing every second	TM2N	Incrementing by 1 @ 1Hz	—	Pass
8	Check that the SCU/DCU voltages show nominal values	SCUP5V SCUP9V SCUM9V BIASP5V BIASP9V BIASM9V	~ 5.2 ± 0.5V ~ 9.0 ± 0.2V ~ -9.0 ± 0.2V ~ 5.1 ± 0.5V ~ 9.0 ± 0.2V ~ -9.0 ± 0.2V	5.23V 9.09V -9.11V 5.16V 9.01V -9.07V	Pass

Test Result (Pass/Fail): Pass
OBSID: 0xb00017e9
Start time: 06:43
DRCU Current measured by S/C parameter SpireHsfR_L52_I (WM798565) 0.45 A



3.3.36 SPIRE-IST-COLD-FUNC-SCU-02-R

Version	2.4
Date	6th December 2007
Purpose	SCU Nominal Science Contents Check RED
Initial configuration	SPIRE DPU and DRCU RED are switched ON, SPIRE HK is being produced
Final configuration	Unchanged
Preconditions	<ul style="list-style-type: none"> • SPIRE-IST-COLD-DPU-ON-R and SPIRE-IST-COLD-DRCU-ON-R procedures have been executed. • SPIRE MIB RED is imported in the CCS database. • CCS is up and running • I-EGSE is up and running • DPU AND OBS PARAMETERS & FUNCTIONAL TEST PARAMETERS displays are selected on the CCS
Duration	5 minutes (CUS = 35.0)
Success Criteria:	Test passed if : <ol style="list-style-type: none"> 4. The SPIRE HK parameter SCUFRAMECNT increments 0/31. 5. The SPIRE HK parameter SCUFRAMECNT increments 0x3FFF/1 6. No events are generated during the frame generation. QLA to give go ahead.
CUS Parameters	CUS parameter - scuframes = 0x1f = 31

Test Procedure:

Step#	Action
0	Open SCU_PARAMETERS display on SCOS Alpha Numeric Displays.
1	Write down the initial value of the SCUFRAMECNT and TM5N parameters located in SCU_PARAMETERS display.
2	Run QLA script FUNC-SCU-02.py on QLA console.
3	Write down the final value of SCUFRAMECNT and TM5N.
4	Contingency: If test fails repeat steps 1 to 4.

Test Log:



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Step	Description	Parameter	Expected Values Before/After	Actual Values Before/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SCU-02-R.tcl	SCUFRAMECNT TM5N	0/31 0x3FFF/1		PASS

Start time @: 06:46
End time @:
OBSID:0xb00017ea
Comments:
SCU frame count 0 at start and 31 at end

FUNC-SCU-02 version: 1.5

Housekeeping @ Fri Feb 27 06:46:07 UTC 2009
 SCU Science @ Fri Feb 27 06:45:59 UTC 2009

Name	HSK value	SCU value	Equal (within 10 raw units)?
TCHTRV	14.0	16.0	True
PCALCURR	6.0	7.0	True
SCAL4CURR	10.0	8.0	True
SCAL2CURR	7.0	8.0	True
PCALV	10.0	12.0	True
SCAL4V	5.0	8.0	True
SCAL2V	9.0	8.0	True
PUMPHTRTEMP	65419.0	65421.0	True
PUMPHSTEMP	65346.0	65348.0	True
EVAPHSTEMP	65379.0	65380.0	True
SHUNTTEMP	65461.0	65460.0	True
EMCFILTEMP	65453.0	65453.0	True
SL0TEMP	181.0	180.0	True
PL0TEMP	36.0	37.0	True
OPTTEMP	40.0	40.0	True
BAFTEMP	61.0	64.0	True
BSMIFTEMP	65448.0	65445.0	True
SCAL2TEMP	4.0	2.0	True
SCAL4TEMP	34.0	36.0	True
SCALTEMP	65359.0	65360.0	True
SMECIFTEMP	65469.0	65469.0	True
SMECTEMP	374.0	376.0	True
BSMTEMP	65325.0	65323.0	True
SUBKTEMP	32767.0	32767.0	True

Test Result (Pass/Fail): **PASS**



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3.3.37 SPIRE-IST-COLD-FUNC-SCU-03-R

Test Id:	SPIRE-IST-COLD-FUNC-SCU-03-R
Test Purpose:	FPU DC Thermometry Check
Initial Configuration:	DRCU_ON + AC/DC thermometry ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON
Duration	8 minutes (CUS = 38.0)
Success Criteria:	Test passed if thermometry channels show temperature values indicating a correct functioning of the sensor, not open/short-circuited. If ANY reading is anomalous check RAW sensor reading. Open Circuit Criterion: RAW reading in the range [0, -100] Short Circuit Criterion: RAW reading of -32768
CUS Parameters	CUS parameter dtparam = 0xffff = 65535

Test Procedure:

Step#	Action
1	Run QLA script FUNC-SCU-03.py on QLA console.
2	Run SPIRE-IST-COLD-FUNC-SCU-03-R.tcl test procedure from the CCS.
3	Contingency: If test fails: 4. Execute SCU_OFF procedure. 5. Execute SPIRE-IST-COLD-FUNC-SCU-03-R.tcl procedure. 6. Repeat step 1 of the Test Procedure.

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	No. of frames received	Test Result
FUNC-SCU-03	SCUTEMPSTAT	0xFFFF/0xFFFF	0xFFFF/0xFFFF	N/A	PASS



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Start time @: 06:47

End time @:

OBSID: 0xb00017eb

Comments: All temps on alright – as for prime side

QLA script did not trigger but OK in playback mode:

SCU-03 Thermometry Check
OBSID = 0xb00017eb

PUMPHRTEMP	6.98	54437
PUMPHSTEMP	9.13	51402
EVAPHSTMP	8.71	52110
SHUNTTEMP	5.45	50282
EMCFILTMP	13.69	60223
SLOTTEMP	5.53	51030
PLOTTEMP	5.56	52370
OPTTEMP	13.82	57350
BAFTEMP	14.34	58682
BSMIFTEMP	13.78	55877
SCAL2TEMP	13.52	57263
SCAL4TEMP	13.53	55988
SCALTEMP	13.58	47209
SMECIFTEMP	13.45	55873
SMECTEMP	13.41	43380
BSMTEMP	13.13	32768



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3.3.38 SPIRE-IST-COLD-FUNC-SCU-06-R

Test Id:	SPIRE-IST-COLD-FUNC-SCU-06-R
Test Purpose:	SCU/FPU AC Thermometry Check
Initial Configuration:	DRCU_ON + AC/DC thermometry ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON
Duration	2 minutes
Success Criteria:	At ~ 4K the SUBKTEMP reading should calibration should start being in range. Open Circuit Criterion: RAW reading in the range 0 -100 Short Circuit Criterion: RAW reading of -32768
CUS Parameters	acparam = 0x1

Test Procedure:

Step#	Action
1	Run SPIRE-IST-COLD-FUNC-SCU-06-R.tcl test procedure from the CCS.
2	Contingency: If test fails : 3. Send manual command: SEND_DRCU_COMMAND Parameter1 = 0xA0860000 Parameter2 = 0 4. Then repeat steps 1 and 2 of the Test Procedure. Note: If the test fails and the SUBKTEMP channel is switched OFF manually, the expected value before/after execution of FUNC-SCU-06 for SUBKSTAT is 0/1

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	No. of frames received	Test Result
FUNC-SCU-06	SUBKSTAT SUBKTEMP	0/1 He I (~4K) He II (~1.7K)	0/1	N/A	PASS



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<p>Start time @: 06:51 End time @: OBSID: 0xb00017ec</p> <p>Comments: SUBKTEMP ~6.2 K</p> <p style="background-color: yellow;">QLA script did not trigger but OK in playback mode:</p> <p>SCU-06 Start time @: 27-Feb 06:50:58 End time @: 27-Feb 06:51:12 OBSID: 0xB00017EC</p> <p>SUBKSTAT: Start value: 0x0 End value: 0x1</p> <p>SUBKTEMP RAW value before: 32767</p> <p>RAW value after: 32686 Converted after: 6168 mK</p>
--

3.3.39 SPIRE-IST-COLD-FUNC-SCU-07-R

Test Id:	SPIRE-IST-COLD-FUNC-SCU-07-R													
Test Purpose:	Sorption Cooler Heater Check (Not at He II)													
Initial Configuration:	DRCU_ON + AC/DC thermometry ON													
Final Configuration:	DRCU_ON + AC/DC thermometry ON													
Constraints	This test should not be performed at He II temperatures, unless specifically instructed to do so by the I-EGSE staff.													
Duration	5 minutes (CUS 95.0)													
Success Criteria:	<p>Test passed if :</p> <ul style="list-style-type: none"> Sorption cooler heat switches and pump heater show expected voltages PCALCURR HK parameter shows the commanded current. PCALV parameter shows a linear increase proportional to the bias applied. (the proportionality constant in this case should be the PCAL resistor value) <p>i.e.</p> <table border="1" style="width: 100%; border-collapse: collapse;"> <thead> <tr> <th>SCU HK parameter</th> <th>RAW</th> <th>Converted</th> </tr> </thead> <tbody> <tr> <td style="text-align: center;">SPHSV</td> <td style="text-align: center;">~12715</td> <td style="text-align: center;">~323mV</td> </tr> <tr> <td style="text-align: center;">EVHSV</td> <td style="text-align: center;">~12715</td> <td style="text-align: center;">~323mV</td> </tr> <tr> <td style="text-align: center;">SPHTRV</td> <td style="text-align: center;">~14390</td> <td style="text-align: center;">~ 8 V</td> </tr> </tbody> </table>		SCU HK parameter	RAW	Converted	SPHSV	~12715	~323mV	EVHSV	~12715	~323mV	SPHTRV	~14390	~ 8 V
SCU HK parameter	RAW	Converted												
SPHSV	~12715	~323mV												
EVHSV	~12715	~323mV												
SPHTRV	~14390	~ 8 V												
CUS Parameters	evaphs = 0.804													



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	pumphs = 0.804 pumpht = 21.85
--	----------------------------------

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
9.	Open SCU_PARAMETERS display on SCOS Alpha Numeric Displays.				
10	Run SPIRE-IST-COLD-FUNC-SCU-07-R.tcl test procedure from the CCS.				
11	Execute TCL script SPIRE-IST-COLD-FUNC-SCU-07-R.tcl	—	—	—	
12	Wait for the parameter BBFULLTYPE to get set to Cooler Htr Chk	BBFULLTYPE	Cooler_Htr_Chk		
13	Record the value of parameter SPHSV – the Sorption Pump Heat Switch Voltage. <i>This voltage stays on for ~20 seconds. Wait for the voltage to go to zero to continue.</i>	SPHSV – mV	0/~323/0		
14	Record the value of parameter EVHSV – the Evaporator Heat Switch Voltage. <i>This voltage stays on for ~20 seconds. Wait for the voltage to go to zero to continue.</i>	EVHSV – mV	0/~323/0		
15	Record the value of parameter SPHTRV – the Sorption Pump Heater Voltage. <i>This voltage stays on for ~20 seconds. Wait for the voltage to go to zero to continue.</i>	SPHTRV – V	0/~8.8/0		
16	Wait for the I-EGSE staff to confirm the success or failure of this test. If test fails repeat.	—	—	—	

Test Result (Pass/Fail):

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/During test	Actual Value Before/After	No. of frames received	Test Result



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SPIRE-IST-COLD-FUNC-SCU-07-R.tcl	SPHSV EVHSV SPHTRV	0/ ~ 323 mV 0/ ~ 323 mV 0/ ~ 8.8 V	~0. / 323.78 mV ~0 / 324.78mV ~0 / 8.85V	N/A	
----------------------------------	--------------------------	--	--	-----	--



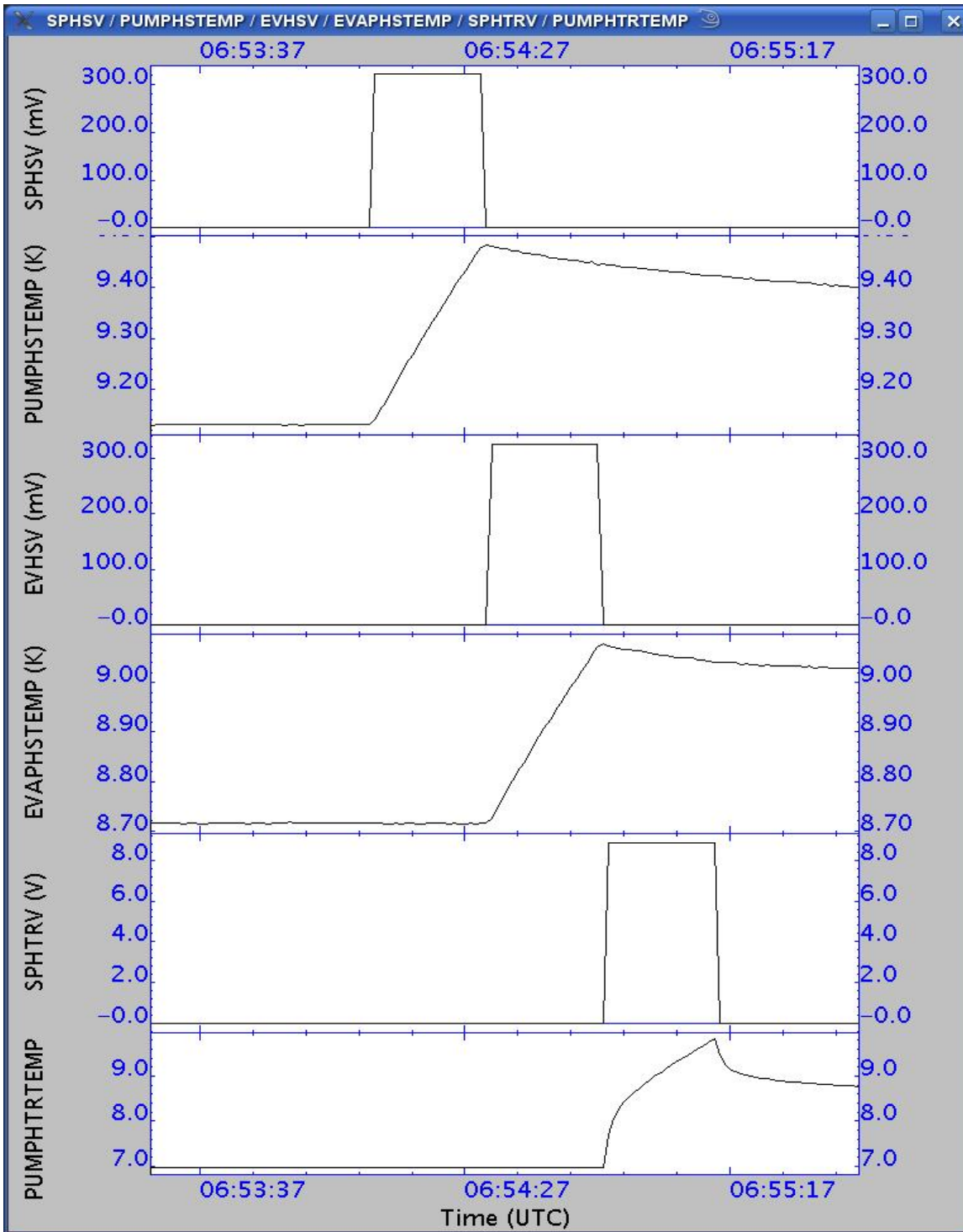
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Start time @: 06:54
End time @:
OBSID: 0xb00017ed

Comments:





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3.3.40 SPIRE-IST-COLD-FUNC-PCAL-01-R

Test Id:	SPIRE-IST-COLD-FUNC-PCAL-01-R
Test Purpose:	Photometer Calibrator Characterisation
Initial Configuration:	DRCU_ON + AC/DC thermometry ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON
Duration	5 minutes (CUS 216.0)
Success Criteria:	Test passed if : <ul style="list-style-type: none"> • PCALCURR HK parameter shows the commanded current. • PCALV parameter shows a linear increase proportional to the bias applied. (the proportionality constant in this case should be the PCAL resistor value)
CUS Parameters	p_start = 1.0; // Start input bias (mA) p_end = 7.0; // End input bias (mA) p_step = 1.0; // Step input bias (mA)

Test Procedure

Step#	Action
1	Run QLA script FUNC-PCAL-01.py on QLA console.
2	Run SPIRE-IST-COLD-FUNC-PCAL-01-R test procedure from the CCS.
3	Contingency: If test fails repeat steps 1 and 2.

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/During test	Actual Value Before/After	No. of frames received	Test Result
SPIRE-IST-COLD-FUNC-PCAL-01-R	PCALCURR PCALV	Starts at 0 then steps through 1, 2, 3 .. and ends at 7mA	See plot below	N/A	PASS



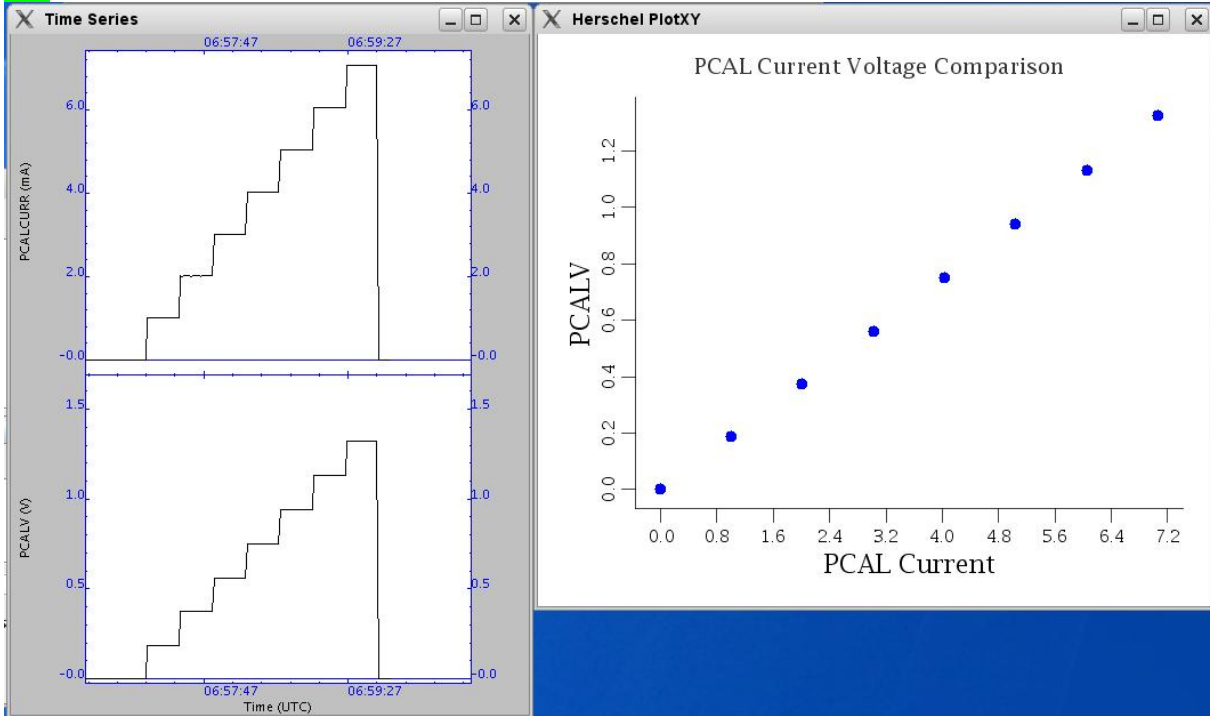
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Start time @: 06:57
End time @:
OBSID: 0xb00017ee

Comments: **Levels**
OK





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3.3.41 SPIRE-IST-COLD-FUNC-SCAL-01-R

Test Id:	SPIRE-IST-COLD-FUNC-SCAL-01-R
Test Purpose:	Spectrometer Calibrator Characterisation
Initial Configuration:	DRCU_ON + AC/DC thermometry ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON
Duration	18 minutes (CUS 926)
Success Criteria:	Test passed if : <ul style="list-style-type: none"> • SCAL4CURR HK parameter shows the commanded current sequence (1,2,3,4,5,5.5mA) • SCAL2CURR HK parameter shows the commanded current sequence(1,2,3,4,5,5.5mA) • SCA2LV parameter shows a linear increase proportional to the bias applied. (the proportionality constant in this case should be the SCAL2V resistor value) • SCAL4V parameter shows a linear increase proportional to the bias applied. (the proportionality constant in this case should be the SCAL4V resistor value) • SCAL2TEMP and SCAL4TEMP values follow the increased bias settings
CUS Parameters	s2_start = 1.0 \ \ S2 Bias RAW s2_end = 5.0 \ \ S2 Bias RAW s2_step = 1.0 \ \ S2 Bias RAW s4_start = 1.0 \ \ S4 Bias RAW s4_end = 5.0 \ \ S4 Bias RAW s4_step = 1.0 \ \ S4 Bias RAW

Test Procedure

Step#	Action
1	Run QLA script FUNC-SCAL-01.py on QLA console.
2	Run SPIRE-IST-COLD-FUNC-SCAL-01-R test procedure from the CSS.
3	Contingency: If test fails repeat steps 1 and 2.

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/During test	Actual Value Before/After	No. of frames received	Test Result
SPIRE-IST-COLD-FUNC-SCAL-01-R	SCAL2CURR SCAL4CURR SCAL2V SCAL4V SCAL2TEMP SCAL4TEMP	0/1,2,3,4,5,5.5mA 0/1,2,3,4,5,5.5mA 0/0.5,1.0,1.5,2.0,2.5,2.75V 0/0.5,1.0,1.5,2.0,2.5,2.75V	See plots below	N/A	Pass

Note: First SCAL2CURR starts at 0 then steps through 1, 2, 3 .. and ends at 7mA, then the same for SCAL4CURR



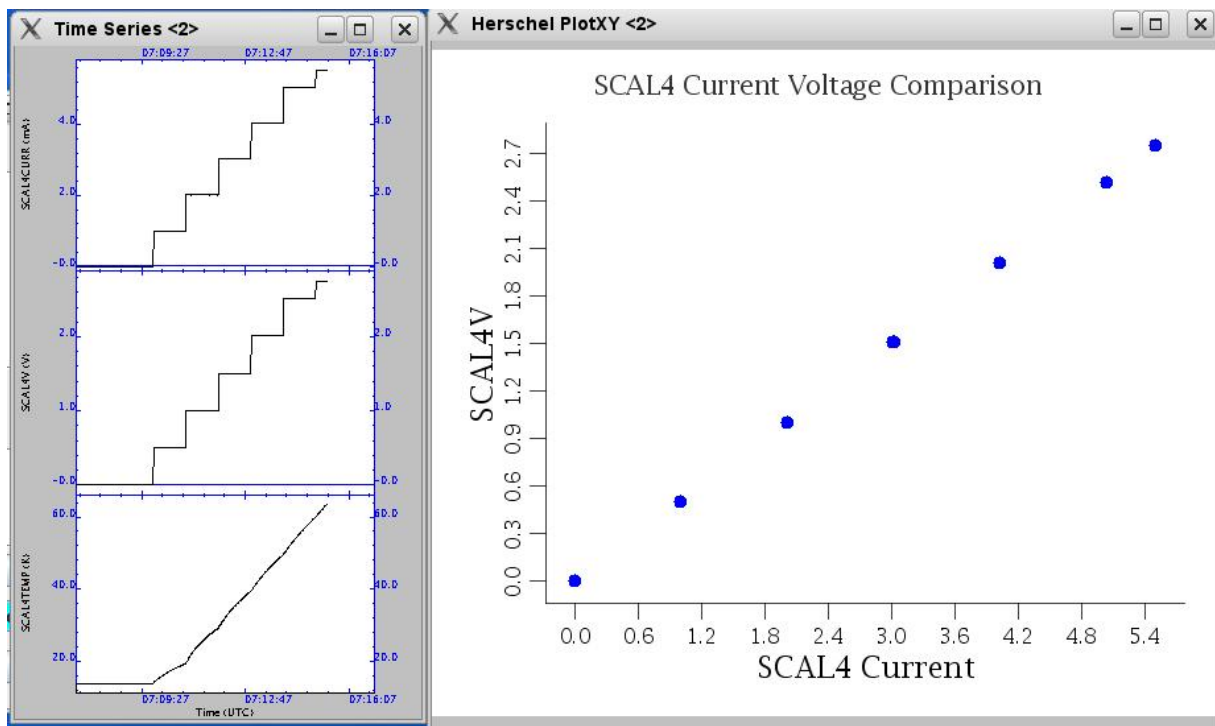
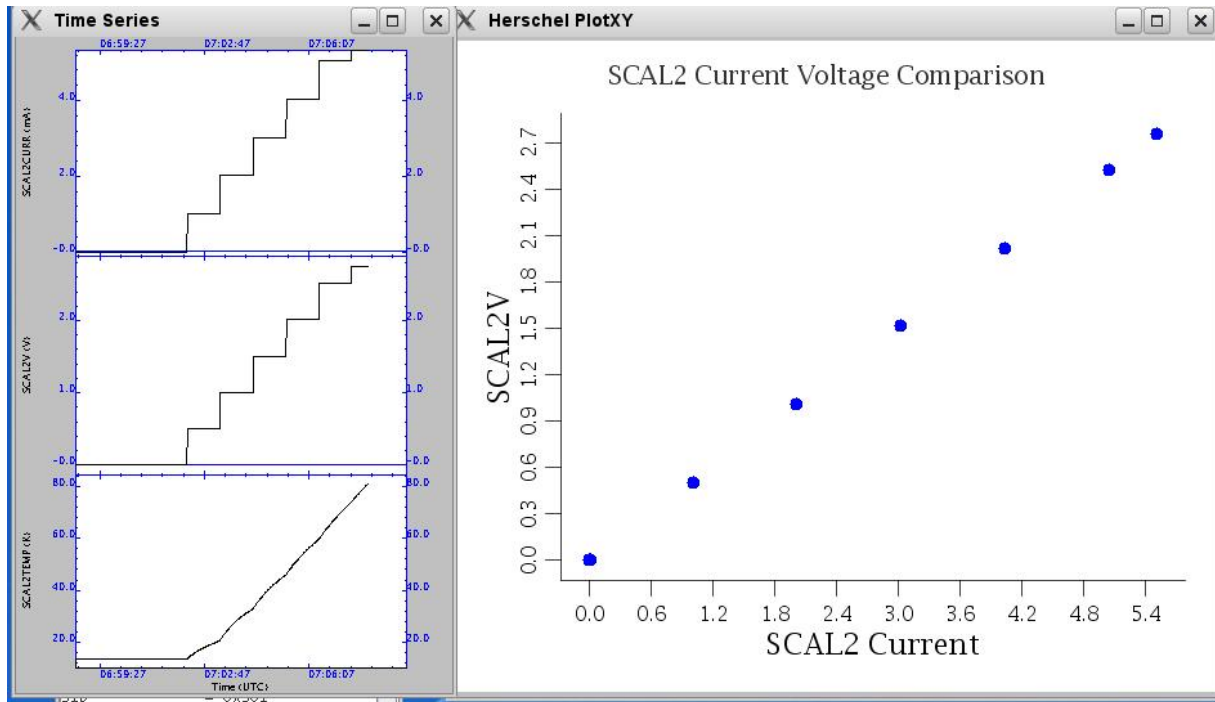
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Start time @: 07:02
End time @:
OBSID: 0xb00017ef

Comments: Test completed successfully. SCAL2 reached ~87K and SCAL4 reached ~68K





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3.3.42 SPIRE-IST-COLD-FUNC-MCU-01-R

Test Id:	SPIRE-IST-COLD-FUNC-MCU-01-R
Test Purpose:	MCU Boot Check
Initial Configuration:	DRCU_ON + AC/DC thermometry ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON
Duration	5 mins (CUS 64.0)
Success Criteria:	Test passed if: 4. MCU boots. 5. MCU voltages show expected values. 6. MAC Board Temperature Reading shows ambient temperature.

Test Procedure:

Step#	Action
1	Run SPIRE-IST-COLD-FUNC-MCU-01-R test procedure from the CCS.
2	When procedure is finished, write down the values of the MCU voltages.
3	Contingency: If test fails repeat steps 1 and 2.

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	No. of frames received	Test Result
SPIRE-IST-COLD-FUNC-MCU-01-R	MCUP5V	N/A / ~ 5V	5.00 V	N/A	PASS
	MCUP15V	N/A / ~15V	15.50 V		
	MCUP14V	N/A / ~ 14V	14.13V		
	MCUM14V	N/A / ~ -14V	-14.49 V		
	MCUM15V	N/A / ~ -15V	-15.61 V		
	MCUMACTEMP	N/A / ~ 300K	297.96 K		
	MCUBSMTEMP	N/A / ~ 300K	301.69 K		
MCUSMECTEMP	N/A / ~ 300K	302.15 K			

Start time @: 07:19

End time @:

OBSID: 0xb00017f0

Comments:

MCU booted OK



3.3.43 SPIRE-IST-COLD-FUNC-MCU-03-R

Test Id:	SPIRE-IST-COLD-FUNC-MCU-03-R																																			
Test Purpose:	MCU Nominal Science Generation Check																																			
Initial Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON																																			
Final Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON																																			
Duration	5 mins (CUS 69.0)																																			
Success Criteria:	Test passed if : 3. MCU produces each type of the frames requested and with the following characteristics. <table border="1" style="margin: 10px auto; border-collapse: collapse; text-align: center;"> <thead> <tr> <th>Frame</th> <th>APID</th> <th>Type</th> <th>Subtype</th> <th>SID</th> <th>FrameID</th> <th>Frame length</th> </tr> </thead> <tbody> <tr> <td>Eng.</td> <td>0x509</td> <td>21</td> <td>3</td> <td>0x814</td> <td>0x14</td> <td>0x15</td> </tr> <tr> <td>BSM</td> <td>0x509</td> <td>21</td> <td>1</td> <td>0x612</td> <td>0x12</td> <td>0xD</td> </tr> <tr> <td>SMEC</td> <td>0x509</td> <td>21</td> <td>1</td> <td>0x410</td> <td>0x10</td> <td>0xC</td> </tr> <tr style="background-color: #cccccc;"> <td>BSM +SMEC</td> <td></td> <td></td> <td></td> <td></td> <td></td> <td></td> </tr> </tbody> </table>	Frame	APID	Type	Subtype	SID	FrameID	Frame length	Eng.	0x509	21	3	0x814	0x14	0x15	BSM	0x509	21	1	0x612	0x12	0xD	SMEC	0x509	21	1	0x410	0x10	0xC	BSM +SMEC						
Frame	APID	Type	Subtype	SID	FrameID	Frame length																														
Eng.	0x509	21	3	0x814	0x14	0x15																														
BSM	0x509	21	1	0x612	0x12	0xD																														
SMEC	0x509	21	1	0x410	0x10	0xC																														
BSM +SMEC																																				
CUS Parameters	4. No events are generated during the different frames generation. n_eng_frames = 100; //number of engineering frames f_eng_frames = 64.1; //frequency of engineering frames generation n_smec_frames = 100; //number of smec frames f_smec_frames = 250.0; //frequency of smec frames generation n_bsm_frames = 100; //number of bsm frames f_bsm_frames = 64.1; //frequency of bsm frames generation ftime = 10; //time for continuous generation																																			

Test Procedure:

Step#	Action
1	Write down the current value of MCUFRAMECNT located in MCU_PARAMETERS display
2	Run SPIRE-IST-COLD-FUNC-MCU-03-R test procedure from the CCS.
3	When test is finished Write down the current value of MCUFRAMECNT.
4	Contingency: If test fails repeat steps 1 to 4.

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	No. of frames received	Test Result
SPIRE-IST-COLD-FUNC-MCU-03-R.tcl	MCUFRAMECNT	0 / ~ 297	0 / 297	297	Pass



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Start time @: 07:21
End time @:
OBSID: 0xb00017f1

Comments:

QLA-MCU-03_B00017F1_8901.txt

Housekeeping Fri Feb 27 02:06:54 UTC 2009
Science Fri Feb 27 02:06:53 UTC 2009

Name	HK before	Science	HK after	Equal (within 10%)?
SMECENC SIG1	12410.0	12408.0	12410.0	True
SMECENC SIG2	20070.0	20072.0	20075.0	True
SMECLVDTDCSIG	32758.0	32760.0	32758.0	True
SMECLVDTAC SIG	27348.0	27350.0	27351.0	True
SMECMOTORCURRE	32784.0	32782.0	32780.0	True
SMECMOTORVOLT	32772.0	32770.0	32778.0	True
CHOPSENS SIG	32763.0	32765.0	32764.0	True
CHOPMOTORCURRE	32779.0	32778.0	32778.0	True
CHOPMOTORVOLT	32762.0	32765.0	32766.0	True
JIGGSENS SIG	32759.0	32758.0	32755.0	True
JIGGMOTORCURRE	32776.0	32775.0	32773.0	True
JIGGMOTORVOLT	32762.0	32764.0	32767.0	True

Empty file QLA-MCU-03_B00017F1_8902.txt

Empty file QLA-MCU-03_B00017F1_8903.txt:



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Step#	Action	Comments
0	Open CHOP PARAMETERS display on SCOS Alpha Numeric Displays.	

3.3.44 SPIRE-IST-COLD-FUNC-BSM-01-R

Test Id:	SPIRE-IST-COLD-FUNC-BSM-01-R
Test Purpose:	BSM Switch ON Check
Initial Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON + BSM ON (open loop)
Duration	5 mins (CUS 24.0)
Success Criteria:	Test passed if: <ul style="list-style-type: none"> 5. CHOPSENSPWR HK parameter goes from 0 to 1 6. CHOPSENSIG HK parameter changes 7. JIGGSENSPWR HK parameter goes from 0 to 1 8. JIGGSENSSIG HK parameter changes

Test Procedure

Step#	Action
1	Run SPIRE-IST-COLD-FUNC-BSM-01-R test procedure from the CCS.
2	When the test is finished record all the Key parameters noted below
3	Contingency: If test fails repeat steps 1 and 2.

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	No. of frames received	Test Result
FUNC-BSM-01	CHOPSENSPWR	0/1/1	0 / 1	N/A	Pass
	CHOPLOOPMODE	3/3	3 / 3		
	CHOPSENSSIG	??	7FFD / 0x9fec		
	JIGGSENSPWR	0/1/1	0 / 1		
	JIGGLOOPMODE	3/3	3 / 3		
	JIGGSENSSIG	??	7FF4 / 0x8cf4		



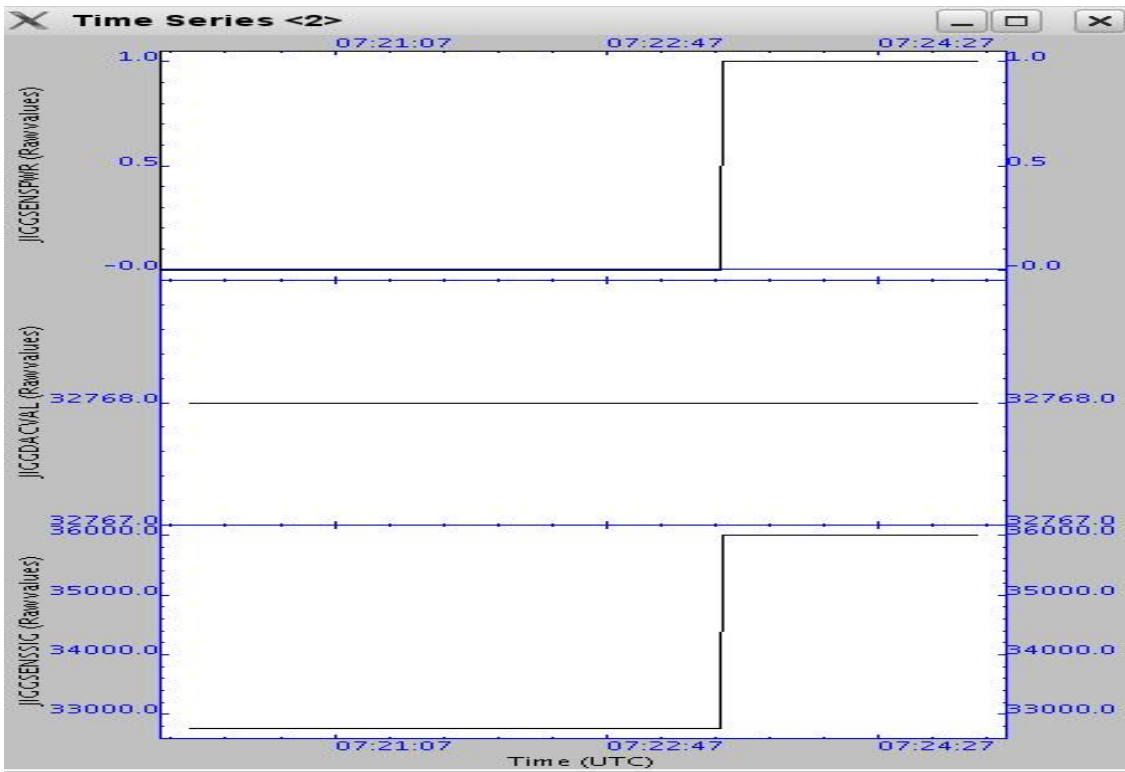
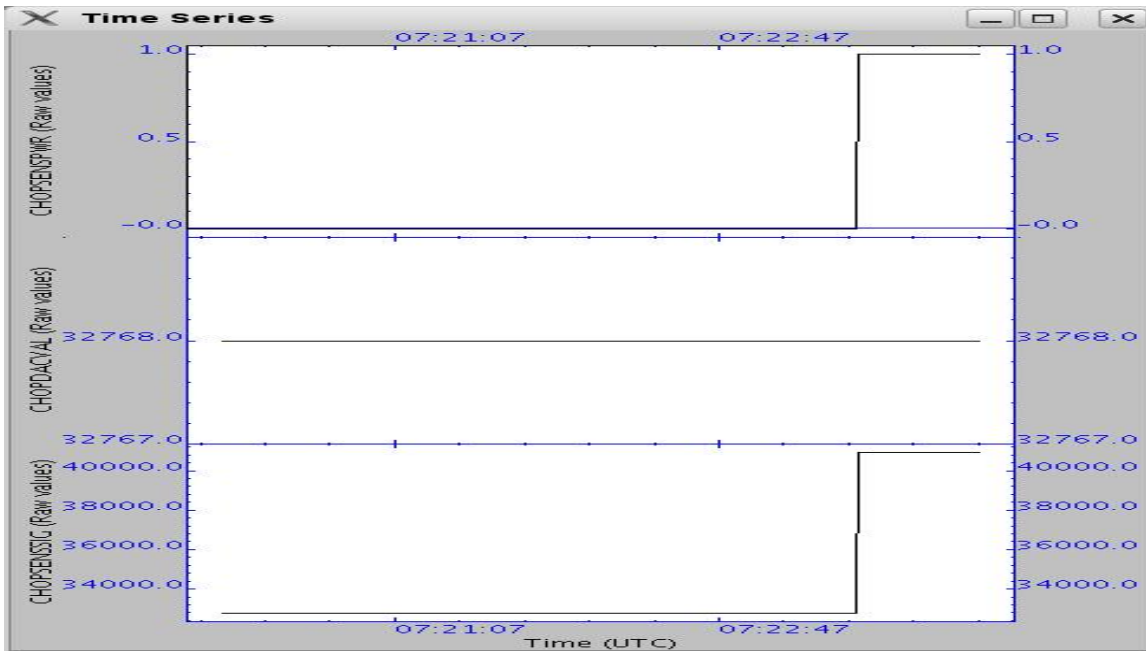
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Start time @: 07:23
End time @:
OBSID: 0xb00017f2

Comments:





3.3.45 SPIRE-IST-COLD-FUNC-BSM-03-R

Test Id:	SPIRE-IST-COLD-FUNC-BSM-03-R
Test Purpose:	BSM Open Loop dynamics Check
Initial Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON + BSM ON (open loop)
Final Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON + BSM ON (open loop)
Duration	5 mins (CUS 269.0)
Success Criteria:	Test passed if the chop sensor signal evolves in the same way as the positions set (i.e. if choppos2 > choppos1 → chopsenssig2 > chopsenssig1) for each jiggle position.
CUS Parameters	<pre> frametype = "BSM"; // Specifies MCU frame type [BSM,SMEC,BSM+SMEC,ENG,TEST] framerate = 64.0; // Specifies the frame rate j_start = 0x4000; // RAW jiggle target start position j_end = 0xc000; // RAW jiggle target end position j_step = 0x4000; // RAW jiggle target step in position j_delay = 2; // Time at each jiggle target position in seconds c_start = 0x3000; // RAW chop target start position c_end = 0xf000; // RAW chop target end position c_step = 0x1000; // RAW chop target step in position c_delay = 5; // Time at each chop target position in seconds </pre>

Test Procedure

Step#	Action
1	On QLA open up 2 time series display with the following HK parameters in each display: Display 1: <i>HK</i> : CHOPPOSN <i>BSM Nominal Science:</i> BSMCHOPMOTORCURREN BSMCHOPSENSSIG BSMCHOPMOTORVOLT Display2: <i>HK</i> : JIGGPOSN <i>BSM Nominal Science:</i> BSMJIGGMOTORCURREN BSMJIGGSENSSIG BSMJIGGMOTORVOLT
2	Run SPIRE-IST-COLD-FUNC-BSM-03-R test procedure from the CCS
3	Contingency: If test fails repeat step 2.

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	No. of frames received	Test Result
SPIRE-IST-COLD-FUNC-BSM-03-R				N/A	Pass



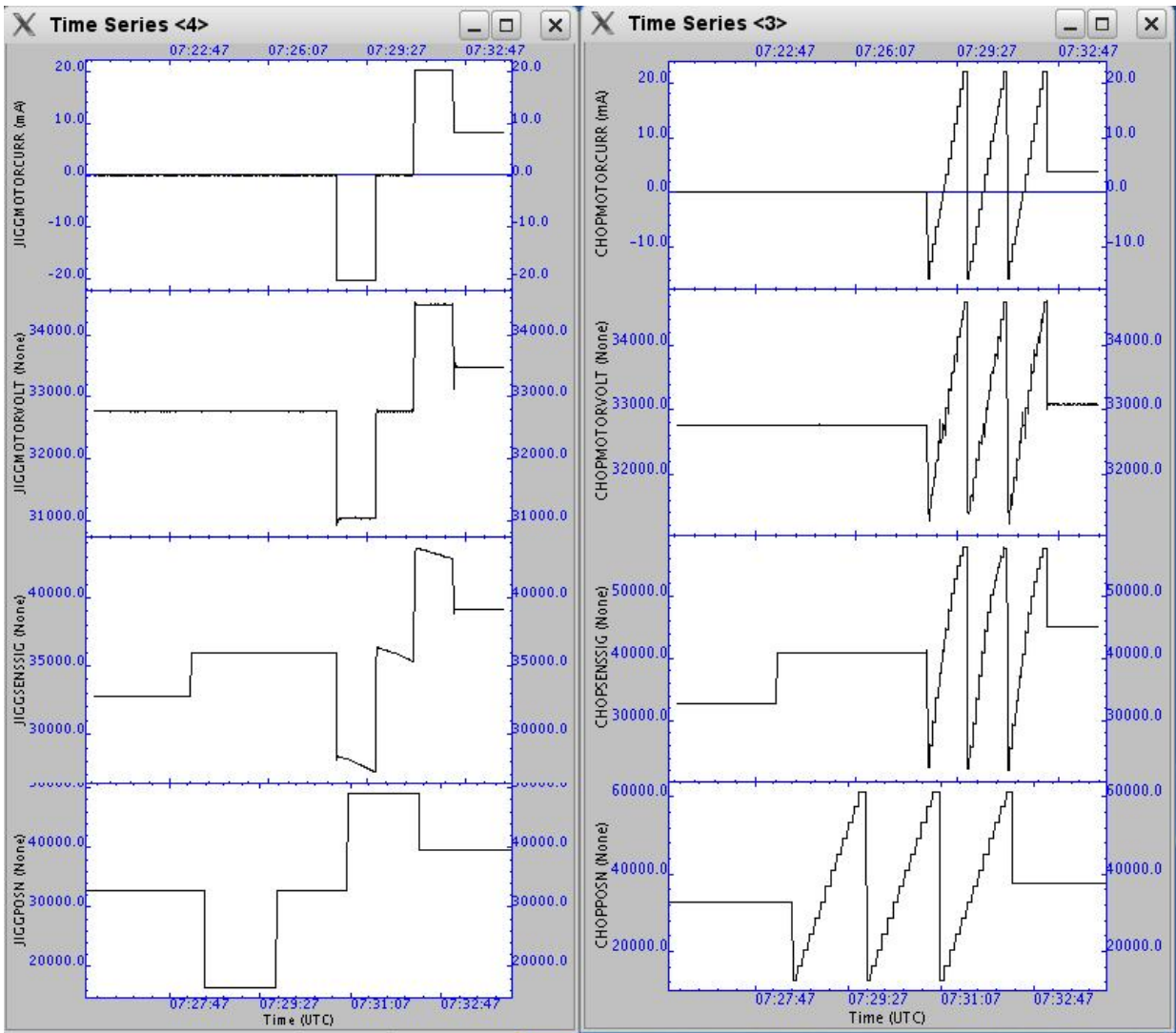
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Start time @: 07:28
End time @:
OBSID: 0xb00017f3

Comments: Nominal behaviour.





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3.3.46 SPIRE-IST-COLD-FUNC-BSM-05A-R

Test Id:	SPIRE-IST-COLD-FUNC-BSM-05A-R.tcl
Test Purpose:	BSM Open Loop chop test (Degraded operational mode check)
Initial Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON + BSM ON (open loop)
Final Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON + BSM ON (open loop)
Duration	5 mins (CUS 75.0)
Success Criteria:	<p>Note: The purpose of this test is to check the effectiveness of the dumping of the natural oscillations of the BSM in chop axis via motor bmf, through the use of the commendable motor resistance value. As it is now is just a check of the default motor resistance value. NO adjusting of this value should be attempted during this test.</p> <p>The success criteria are therefore not applicable.</p>
CUS Parameters	<pre>frametype = "BSM"; // Specifies MCU frame type [BSM,SMEC,BSM+SMEC,ENG,TEST] framerate = 125.0; // Specifies the frame rate on_source_chop = 0xa000; // On source chop position on_source_jiggle = 0x8000; // On source jiggle position off_source_chop = 0x8000; // Off source chop position off_source_jiggle = 0x8000; // Off source jiggle position ncycles = 50; //Number of chop cycles chop_period = 500000; //period of chop cycles in microsec dcumode = 0; //Data type dcusample = 4; //Number of DCU samples per chop position dcudelay = 34959; //Dealy to start sampling the DCU bsmsample = 31; //Number of BSM samples per position</pre>

Test Procedure

Step#	Action
1	On QLA open up a time series display of BSM science parameters: BSMCHOPSENSSIG BSMCHOPMOTORCURR BSMCHOPMOTORVOLT
2	Run SPIRE-IST-COLD-FUNC-BSM-05A-R.tcl test procedure from the CCS.
3	Contingency: None contemplated.

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	No. of frames received	Test Result
SPIRE-IST-COLD-FUNC-BSM-05A-R.tcl	BSMCHOPSENSSIG BSMCHOPMOTORCURR BSMCHOPMOTORVOLT	?? ?? ??		N/A	Pass



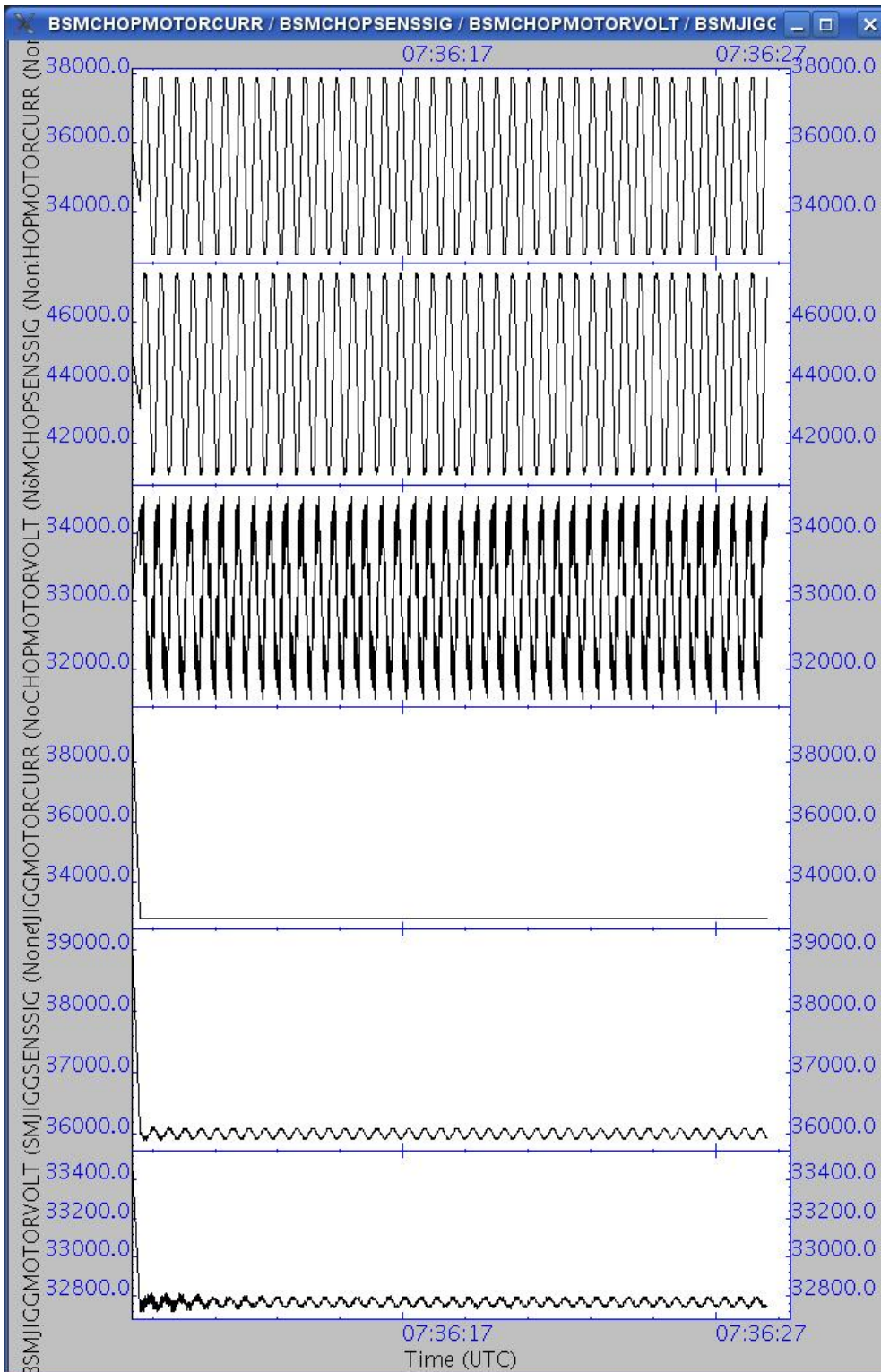
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Start time @: 07:36
End time @:
OBSID: 0xb00017f4

Comments: It chopped OK in open loop





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3.3.47 SPIRE-IST-COLD-FUNC-BSM-05B-R

Test Id:	SPIRE-IST-COLD-FUNC-BSM-05B-R
Test Purpose:	BSM Close Loop chop test
Initial Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON + BSM ON (OPEN loop)
Final Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON + BSM ON (CLOSED loop)
Duration	5 mins (CUS 72.0)
Success Criteria:	Note: Currently this test does not differ at ALL from the next one. In any case the success/fail criteria are NOT applicable for this test.
CUS Parameters	frametype = "BSM"; // Specifies MCU frame type [BSM,SMEC,BSM+SMEC,ENG,TEST] framerate = 125.0; // Specifies the frame rate on_source_chop = 0xb600; // On source chop position (46592) on_source_jiggle = 0x9a60; // On source jiggle position (39520) off_source_chop = 0x6a28; // Off source chop position (27176) off_source_jiggle = 0x9a60; // Off source jiggle position (39520) ncycles = 50; //Number of chop cycles chop_period = 500000; //period of chop cycles in microsec dcumode = 0; //Data type dcusample = 4; //Number of DCU samples per chop position dcudelay = 34959; //Dealy to start sampling the DCU bsmsample = 31; //Number of BSM samples per position

Test Procedure

Step#	Action
1	Execute SPIRE-IST-COLD-BSM-INIT-R.tcl from the CCS.
2	On QLA open up a time series display of BSM science parameters: BSMCHOPSENSSIG BSMCHOPMOTORCURR BSMCHOPMOTORVOLT
3	Run SPIRE-IST-COLD-FUNC-BSM-05B-R.tcl test procedure from the CCS.

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	No. of frames received	Test Result
SPIRE-IST-COLD-BSM-INIT-R.tcl	CHOPLOOPMODE JIGLOOPMODE	3/-1 3/-1	3/-1 3/-1	N/A	Pass
SPIRE-IST-COLD-FUNC-BSM-05B-R.tcl	BSMCHOPSENSSIG BSMCHOPMOTORCURR BSMCHOPMOTORVOLT	?? ?? ??	See plots below	N/A	Pass



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BSM_INIT:

Start Time: 07:39

End Time:

OBSID: 0xb00017f5

FUNC-BSM-05B

Start time: 07:41

End time:

OBSID: 0xb00017f6

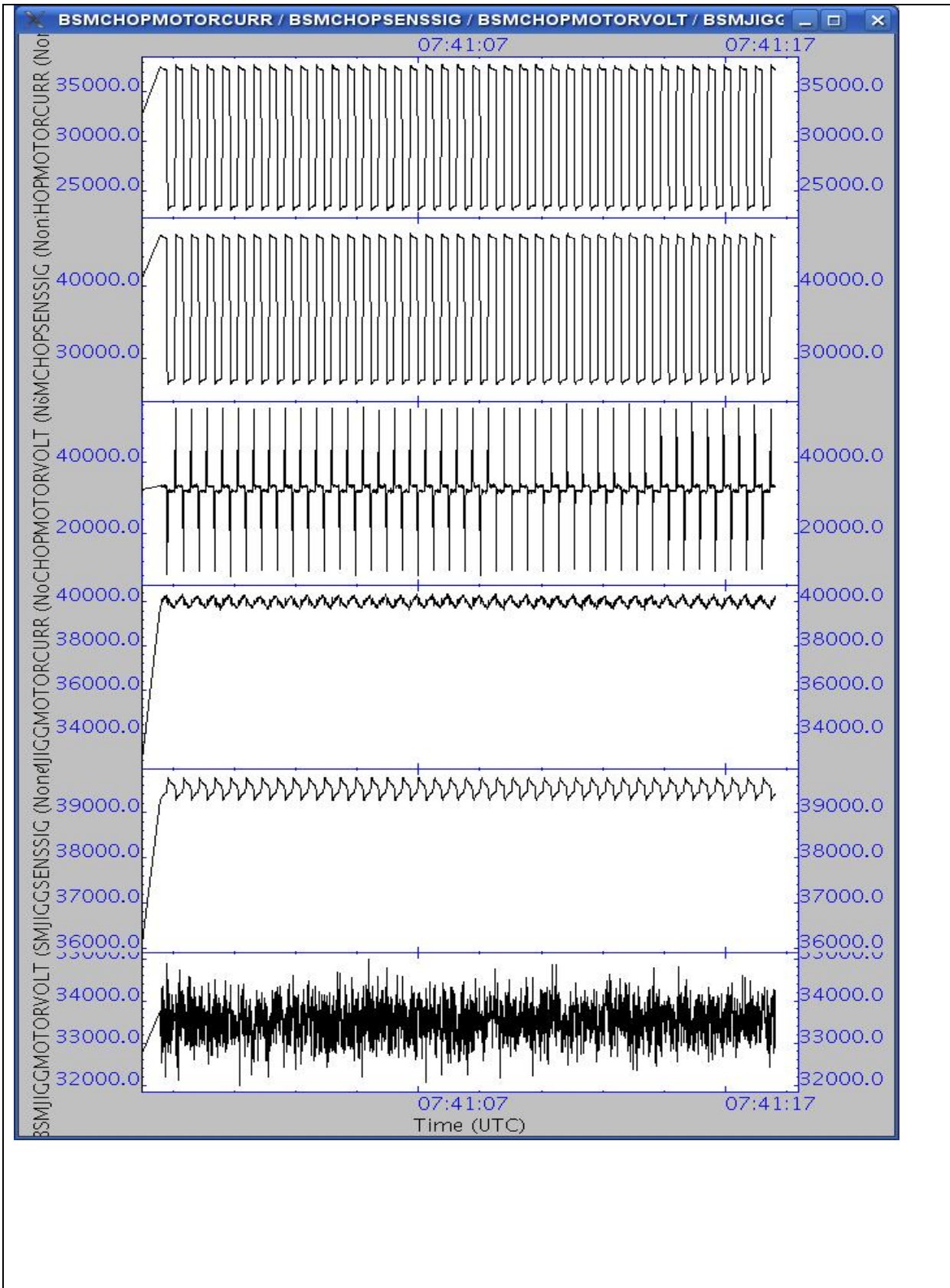
Comments: Chopping OK. Settling time ~40 ms.



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3.3.48 SPIRE-IST-COLD-FUNC-BSM-06-R

Test Id:	SPIRE-IST-COLD-FUNC-BSM-06-R
Test Purpose:	BSM Operational Mode Check
Initial Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON + BSM ON (open loop)
Final Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON + BSM ON (open loop)
Duration	5 mins (CUS 72.0)
Success Criteria:	<p>Note:</p> <p>The purpose of this test is to check the effectiveness of the BSM close loop initialisation procedure and the default PID parameters. If the dynamical behaviour of the BSM during chopping with these PID parameters is close or within requirements this indicates that the PID parameters used can be applied to cold testing with certain adjustment. If NOT these indicates that the PID parameters need further tuning BUT NOT TO BE DONE DURING THESE TEST.</p> <p>In any case the success/fail criteria are NOT applicable for this test.</p>
CUS Parameters	<pre>frametype = "BSM"; // Specifies MCU frame type [BSM,SMEC,BSM+SMEC,ENG,TEST] framerate = 125.0; // Specifies the frame rate on_source_chop = 0x5279; // On source chop position (21113) on_source_jiggle = 0x8d00; // On source jiggle position (36096) off_source_chop = 0xad87; // Off source chop position (44423) off_source_jiggle = 0x8d00; // Off source jiggle position (36096) ncycles = 50; //Number of chop cycles chop_period = 500000; //period of chop cycles in microsec dcumode = 0; //Data type dcusample = 4; //Number of DCU samples per chop position dcudelay = 34959; //Dealy to start sampling the DCU bsmsample = 65535; //Number of BSM samples per position</pre>

Test Procedure

Step#	Action
1	On QLA open up a time series display of science parameters: BSMCHOPSENSSIG BSMCHOPMOTORCURR BSMCHOPMOTORVOLT
2	Run SPIRE-IST-COLD-FUNC-BSM-06-R test procedure from the CCS.

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	No. of frames received	Test Result
SPIRE-IST-COLD-FUNC-BSM-06-R	CHOPLOOPMODE	1/1/1	1/1/1	N/A	PASS
	JIGGLOOPMODE	1/1/1	1/1/1		
	BSMCHOPSENSSIG BSMCHOPMOTORCURR BSMCHOPMOTORVOLT	??/ ??/ ??/	See plots below	N/A	PASS



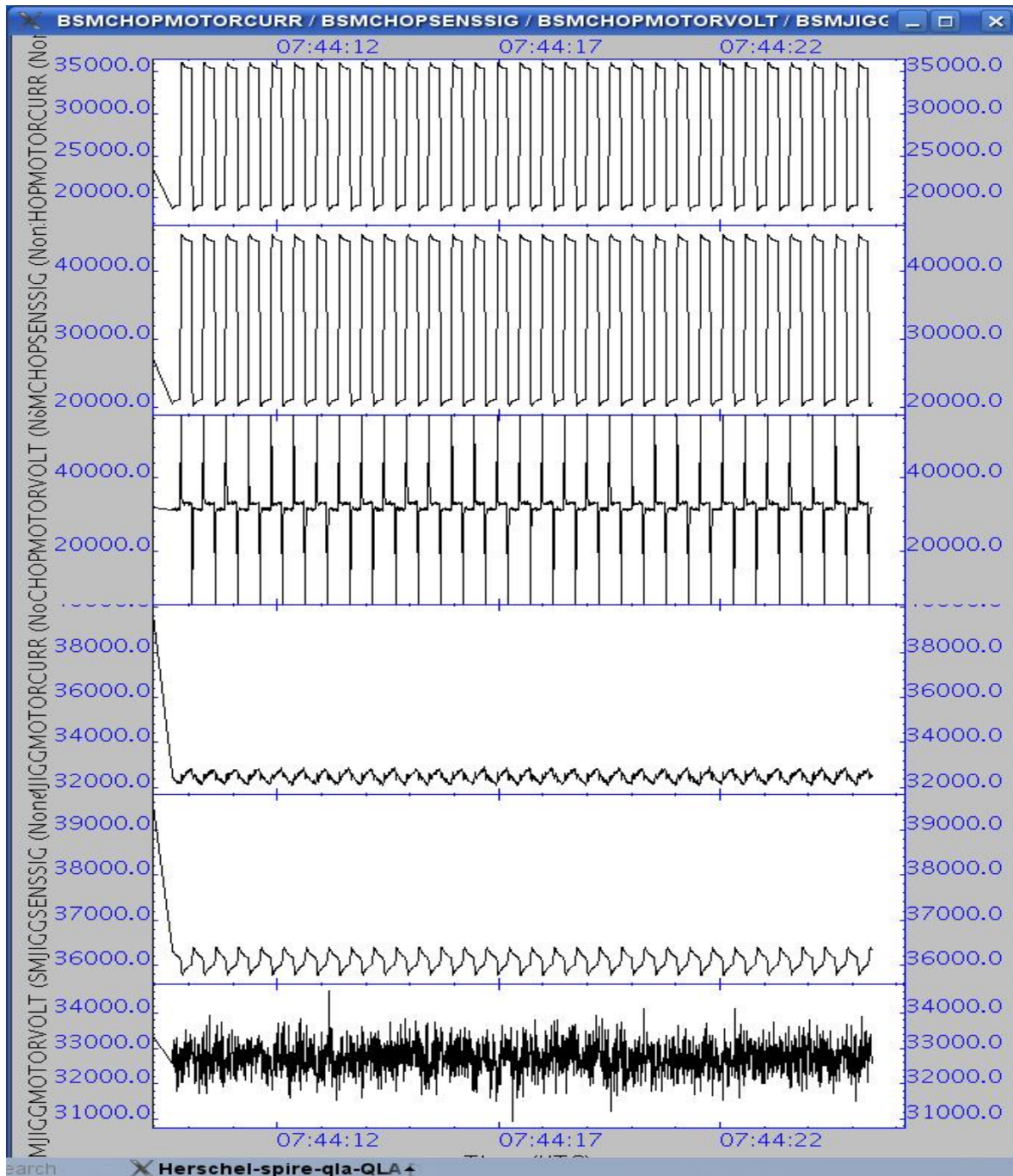
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Start time @: 07:44
End time @:
OBSID: 0xb00017f8

Comments:





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Step#	Action	Comments
4	Execute SPIRE-IST-COLD-BSM-OFF-R	Start Time: 07:46 End Time: OBSID: 0xb00017f9



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Step#	Action	Comments
0	Open SMEC PARAMETERS display on SCOS Alpha Numeric Displays.	

3.3.49 SPIRE-IST-COLD-FUNC-SMEC-01-R

Test Id:	SPIRE-IST-COLD-FUNC-SMEC-01-R
Test Purpose:	SMEC Switch ON Check. Encoder and LVDT alive check.
Initial Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON+ SMEC ON (open loop)
Final Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON+ SMEC ON (open loop)
Duration	5 Minutes (CUS 40.0)
Success Criteria:	Test passed if : <ul style="list-style-type: none"> 5. SMECENCPWR HK parameter changes from 0 to 4. 6. SMEC encoder signals 1 and 2 show variation when encoder is switched ON. 7. SMEC LVDT is switched ON. 8. SMEC LVDT DC and AC signals show variation when LVDT is switched ON.

Test Procedure:

Step#	Action	Comments
1	Run FUNC-SMEC-01.py script on QLA	
2	Run SPIRE-IST-COLD-FUNC-SMEC-01-R test procedure from the CCS.	
3	Contingency: If test fails repeat steps 1.	

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	No. of frames received	Test Result
SPIRE-IST-COLD-FUNC-SMEC-01-R	SMECENCPWR SMECLVDTPWR SMECENC SIG1 SMECENC SIG2	0/-3 0/-1	0/-3 0/-1 0x521c 0x7943	N/A	Pass



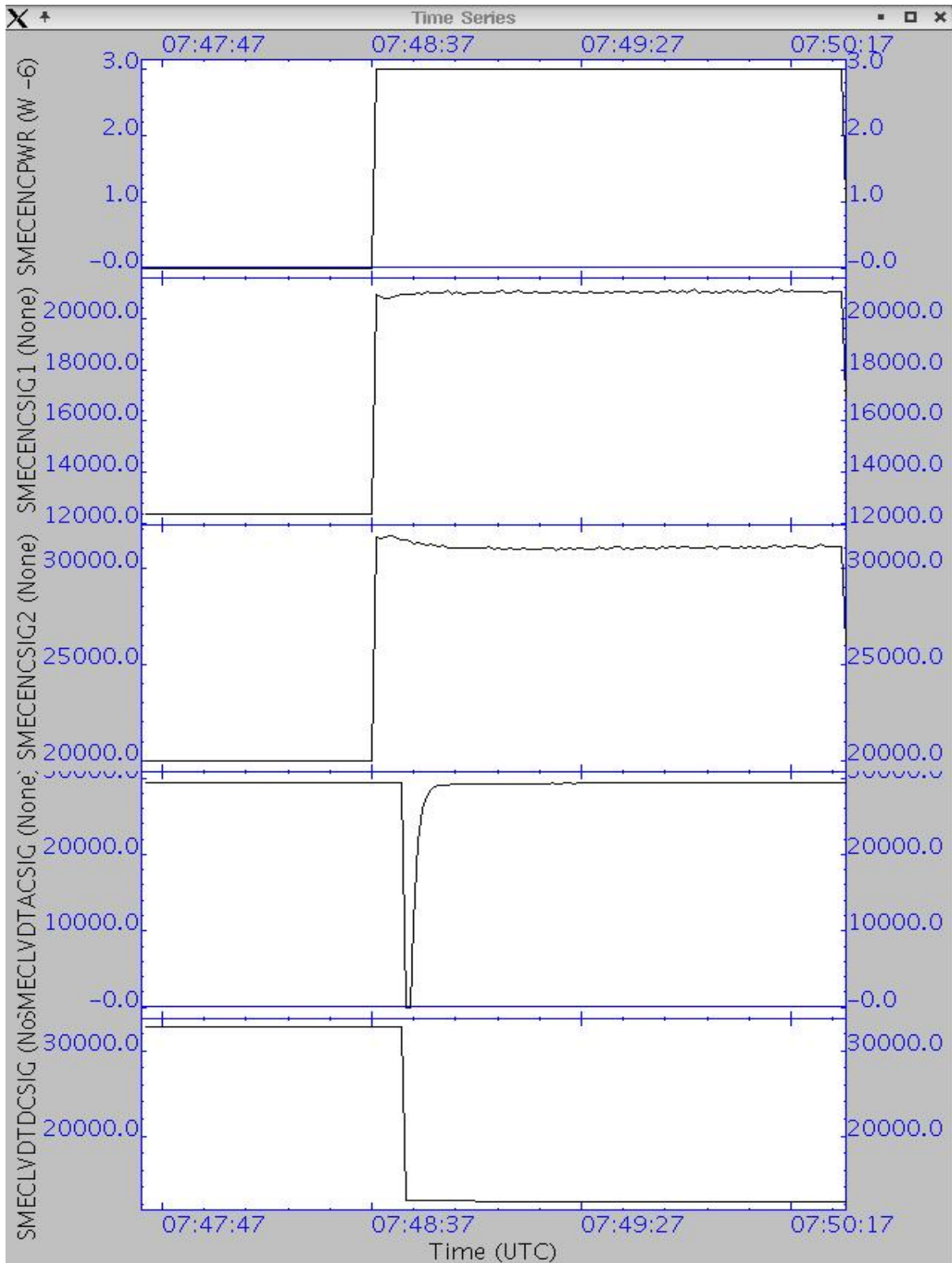
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Start time @: 07:49
End time @:
OBSID: 0xb00017fa

Comments:





3.3.50 SPIRE-IST-COLD-FUNC-SMEC-03-R

Test Id:	SPIRE-IST-COLD-FUNC-SMEC-03-R
Test Purpose:	SMEC (RED) Encoder Integrity Check.
Initial Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON+ SMEC ON (open loop)
Final Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON+ SMEC ON (open loop)
Duration	5 minutes (CUS 49.0)
Success Criteria:	Test passed if: SMEC encoder signals 1 and 2 show a variation on their amplitudes from one LED illumination level to another. (i.e. MCUENGSMECENC SIG1/2 increase as the encoder power is increased.)
CUS Parameters	frametype = "ENG"; // Specifies MCU frame type [BSM,SMEC,BSM+SMEC,ENG,TEST] framerate = 64.0; // Specifies the frame rate framenummer = 0xffff; // Frame number level_init = 1; // level_start = 1; level_end = 3; level_step = 1; led_delay = 5; // Time at each level in seconds

Test Procedure:

Step#	Action
1	Run FUNC-SMEC-03.py script on QLA
2	Run SPIRE-IST-COLD-FUNC-SMEC-03-R test procedure from the CCS.
3	Contingency: If test fails repeat steps 1 and 2.

Test Log:

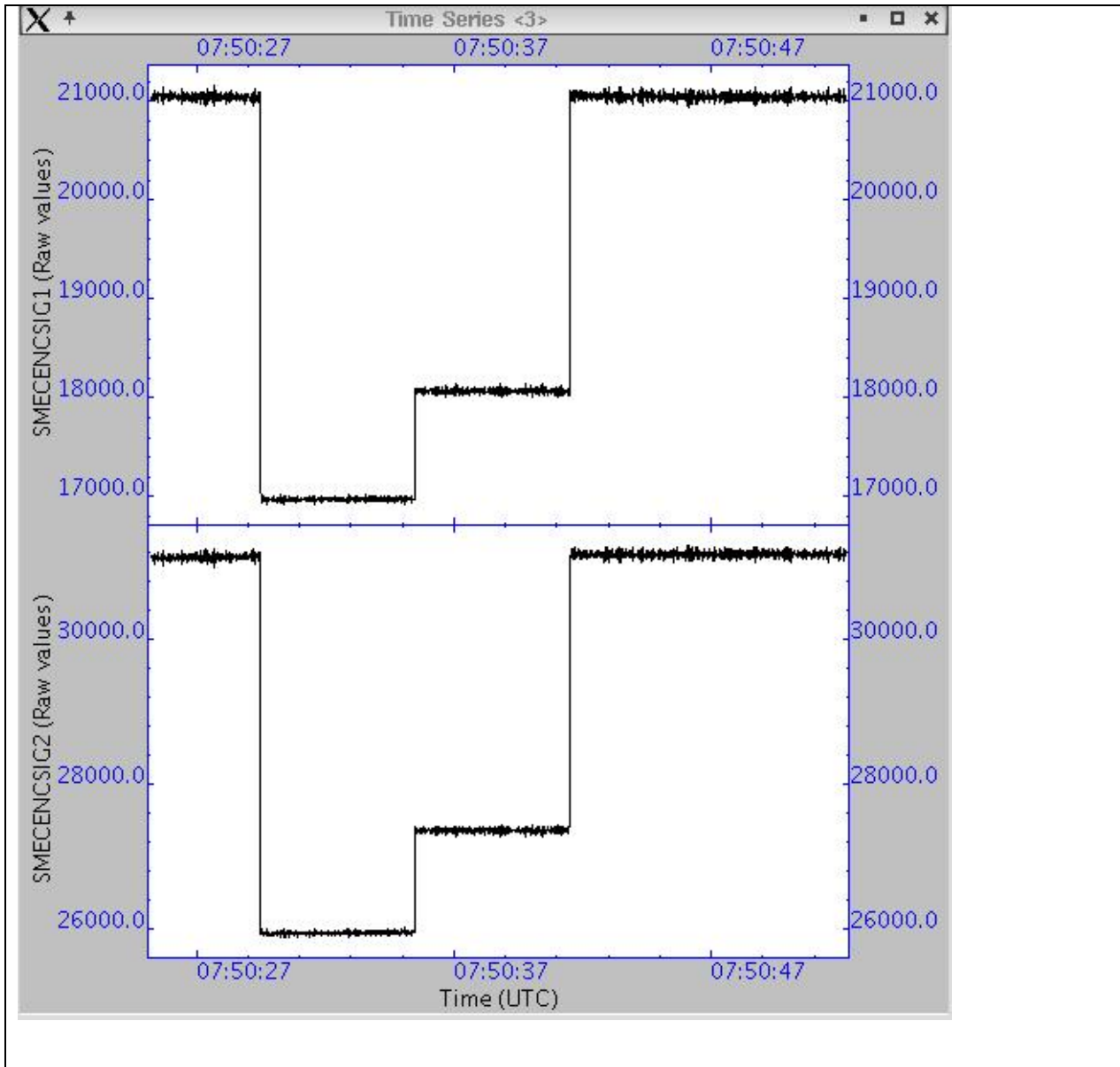
Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	No. of frames received	Test Result
SPIRE-IST-COLD-FUNC-SMEC-03-R	SMECENCPWR SMECENC SIG1 SMECENC SIG2		See plots below		Pass
<p>Start time @: 07:50 End time @: OBSID: 0xb00017fb</p> <p>Comments: Encoder signals 1 & 2 are not saturated at encoder levels 1 to 3.</p>					



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3.3.51 SPIRE-IST-COLD-FUNC-SMEC-OFF-R

Test Id:	SPIRE-IST-COLD-FUNC-SMEC-OFF-R
Test Purpose:	SMEC (RED) Switch OFF
Initial Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON+ SMEC ON (open loop)
Final Configuration:	DRCU_ON + AC/DC thermometry ON +MCU ON+ SMEC OFF
Duration	3 minutes
Success Criteria:	HK Parameters SMECENCPWR and SMECLVDTPWR show expected OFF values.

Test Procedure:

Step#	Action
1	Run Execute SPIRE-IST-COLD-SMEC-OFF-R.tcl test procedure from the CCS.

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	No. of frames received	Test Result
SPIRE-IST-COLD-SMEC-OFF-R	SMECENCPWR SMECLVDTPWR	1/-/0 1/-/0	1/0 1/0		Pass

Start time @: 07:53
End time @:
OBSID: 0xb00017fc

Comments:



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Step#	Action	Comments
0	Open DCU PARAMETERS SCOS Alpha Numeric Display	

3.3.52 SPIRE-IST-COLD-FUNC-DCU-02-R

Test Id:	SPIRE-IST-COLD-FUNC-DCU-02-R
Initial Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON
Duration	5 Minutes (CUS 140.0)
Success Criteria:	Test passed if DCUFRAMECNT goes from n to n+700 and the frametime difference between consecutive frames computed by QLA script is in agreement with the expected differences based on commanded sampling rate: 3. Photometer Sampling rate is 15.3Hz → Δt ~ 65.5 ms 4. Spectrometer Sampling rate is 80Hz → Δt = 12.5 ms
CUS Parameters	photbiasfreq = 200.0; photosampfreq = 15.3; specbiasfreq = 160.0; specsampfreq = 80.0; frames = 100;

Test Procedure:

Step#	Action	Comments
1	Write the current value of DCUFRAMECNT located in DCU PARAMETERS	
2	Run QLA script FUNC-DCU-02.py on QLA console.	
3	Run SPIRE-IST-COLD-FUNC-DCU-02-R test procedure from the CCS.	
4	Write the current value of DCUFRAMECNT	
5	Contingency: If test fails repeat steps 1 to 4.	

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	Nb. of frames received	Test Result
SPIRE-IST-COLD-FUNC-DCU-02-R	DCUFRAMECNT	n/n+700	1200/1900	700	Success
Start time @: 07:56 End time @: OBSID: 0xb00017fd Comments: OK					



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3.3.53 SPIRE-IST-COLD-FUNC-DCU-11-PHOT-R

Test Id:	SPIRE-IST-COLD-FUNC-DCU-11-PHOT-R
Test Purpose:	Photometer BDAs Switch ON Check
Initial Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON+ Photometer LIAs ON + Photometer BIAS ON +Photometer JFETs ON
Duration	7 minutes (CUS 122.0)
Success Criteria:	Test passed if Photometer JFET source and drain voltages are correct: 5. PSWJFETVSS1/2/3/4/5/6 (values according to latest Vss). 6. PMLWJFETVSS1/2/3/4 (values according to latest Vss). 7. PSWJFETSTAT = 0x3F 8. PMLWJFETSTAT = 0x7F
CUS Parameters	heater_V = 0; // Specifies if the heater is to be switched ON or not array = "PF"; //default array to switch ON

Test Procedure:

Step#	Action
1	Run SPIRE-IST-COLD-FUNC-DCU-11-PHOT-R test procedure from the CCS. with default input parameters
2	After the test, write down the values RAW and converted values of: PSWJFETSTAT, PMLWJFETSTAT, PSWJFET1/2/3/4/5/6V PMWJFET1/2/3/4V PLWJFET1/2V located in the DCU PARAMETERS display
3	Contingency: If test fails repeat steps 1 and 2.

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	No. of frames received	Test Result
SPIRE-IST-COLD-FUNC-DCU-11-PHOT-R	PSWJFETSTAT PMLWJFETSTAT PLIABITSTAT PLIAP5V PLIAP9V PLIAM9V	0/0x3f 0/0x7f 1 ~0/ ~+5.17 ± 0.1V ~0/ ~+11.53 ± 0.1V ~0/ ~-11.53 ± 0.1V	OK OK 1 5.24V 11.60V -11.59V	N/A	Pass



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Start time @: 08:00
End time @:
OBSID: 0xb00017fe

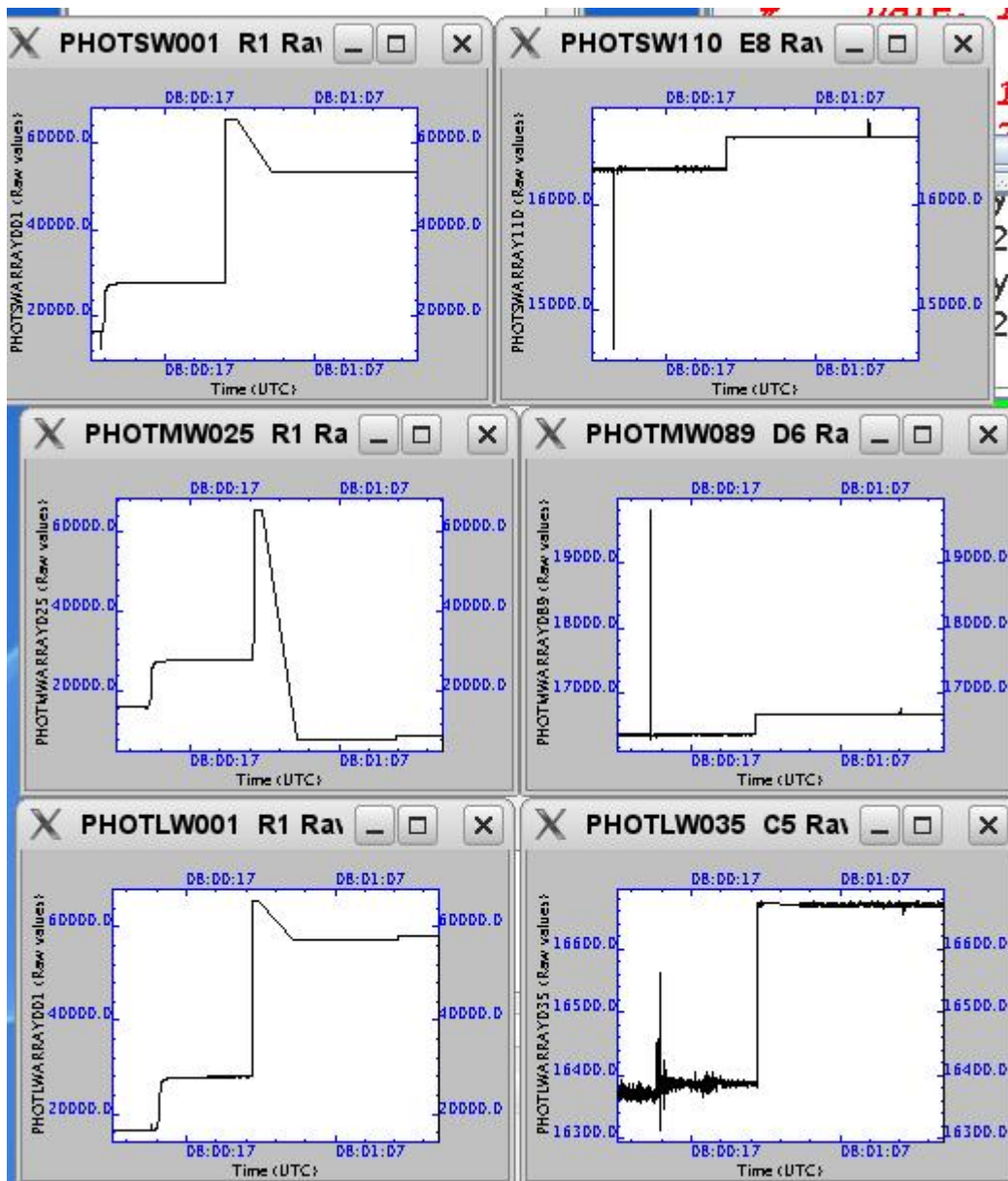
Comments:

All the photometer JFETs switched on OK

Used JPL approved switch-on procedure for the JFETs.

Initial V_{ss} values were -1.47V.

Final V_{ss} values were consistent with Jamie Bock's spreadsheet (least noise).





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3.3.54 SPIRE-IST-COLD-FUNC-DCU-13-PHOT-R

Test Id:	SPIRE-IST-COLD-FUNC-DCU-13-PHOT-R
Test Purpose:	Photometer Detectors Integrity Check
Initial Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON+ Photometer LIAs ON + Photometer BIAS ON +Photometer JFETs ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON+ Photometer LIAs ON + Photometer BIAS ON +Photometer JFETs ON
Duration	15 minutes (CUS 726)
Success Criteria:	Test passed if : The photometer detectors show a small linear variation on the output voltage when different bias is applied through the load curve.
CUS Parameters	dcumode = "PF"; // Specifies array in which to perform LC mclkdiv = 0x95; // Master clock divisor ,which specifies bias freq biasdiv = 0x6; // Sampling divisor ,which specifies sampling rate psw_phase = 0x80; // PSW demod phase pmw_phase = 0x80; // PMW demod phase plw_phase = 0x80; // PLW demod phase ftime = 10; // Time at each bias level

Test Procedure:

Step#	Action
1	Run FUNC-DCU-13P.py script on QLA
2	Run SPIRE-IST-COLD-FUNC-DCU-13-PHOT-R test procedure from the CCS. With default input parameters
3	Contingency: If test fails repeat step 1 and 2.

Test Log:

Test Id	Key Parameter(s)	Expected Value Before	Actual Value Before/After	No. of frames received	Test Result
SPIRE-IST-COLD-FUNC-DCU-13-PHOT-R	PLIABITSTAT PSWJFETSTAT PMLWJFETSTAT	1/1 0x3F/0x3F 0x7F/0x7F	1/1 0x3F/0x3F 0x7F/0x7F		TEST NOT DONE

OBSID:

Start:

End:

Comments: **TEST SKIPPED AS NO NEW INFORMATION**



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3.3.55 SPIRE-IST-COLD-FUNC-DCU-14-PHOT-R

Test Id:	SPIRE-IST-COLD-FUNC-DCU-14-PHOT-R
Initial Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON + Photometer LIAs ON + Photometer BIAS ON + Photometer JFETs ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON + Photometer LIAs ON + Photometer BIAS ON + Photometer JFETs ON
Duration	5 minutes
Success Criteria:	Test passed if : The Photometer detectors do not show excess noise.

Test Procedure:

Step#	Action	Comments
1	Run SPIRE-IST-COLD-FUNC-DCU-14-PHOT-R test procedure from the CCS.	
2	Contingency: If test fails repeat step 1.	

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	Nb. of frames received	Test Result
SPIRE-IST-COLD-FUNC-DCU-14-PHOT-R	PLIABITSTAT PSWJFETSTAT PMLWJFETSTAT	1/1 0x3F/0x3F 0x7F/0x7F			TEST NOT DONE

Start time @:

End time @:

OBSID:

Comments: **TEST SKIPPED AS NO NEW INFORMATION**



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3.3.56 SPIRE-IST-COLD-PHOT-VSS-R

Test Id:	SPIRE-IST-COLD-PHOT-VSS-R
Purpose:	Photometer BDAs Vss Test REDUNDANT
Initial Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON + Photometer LIAs ON + Photometer BIAS ON + Photometer JFETs ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON + Photometer LIAs ON + Photometer BIAS ON + Photometer JFETs ON
Duration	40 minutes
Success Criteria:	Test passed if the Photometer detectors do not show excess noise.

Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Check that Photometer LIAs and detectors are switched on	PLIABITSTAT PSWJFETSTAT PMLWJFETSTAT	1/1 0x3F/0x3F 0x7F/0x7F		
2	Execute TCL script SPIRE-IST-COLD -PHOT-VSS-R.tcl	—	—	—	
3	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
Test Result (Pass/Fail):					

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	Nb. of frames received	Test Result
SPIRE-IST-PHOT-VSS-R	PLIABITSTAT PSWJFETSTAT PMLWJFETSTAT	1/1 0x3F/0x3F 0x7F/0x7F	1/1 0x3F/0x3F 0x7F/0x7F		TEST NOT DONE



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Start time @:

End time @:

OBSID:

Comments: **TEST SKIPPED AS NO NEW INFORMATION**



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3.3.57 SPIRE-IST-COLD-PDET-OFF-R

Test Id:	SPIRE-IST-COLD-PDET-OFF-R
Test Purpose:	Photometer BDAs Switch OFF
Initial Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON + Photometer BDAs ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON + Photometer BDAs OFF
Duration	3 minutes
Success Criteria:	Test passed if SCUDCDCSTAT goes from 4 to 6, Spectrometer LIAs voltages are correct and SJFET voltages are also correct.

Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Execute TCL script SPIRE-IST-COLD-PDET-OFF-R.tcl	—	—	—	
2	Check that the Photometer detectors are switched off	PSWJFETSTAT PMLWJFETSTAT	0x3F/-/0 0x7F/-/0		
3	Check that the Photometer LIAs are switched off	PLIABITSTAT	1/-/0		
4	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	

Test Result (Pass/Fail):

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	Nb. of frames received	Test Result
SPIRE-IST-PDET-OFF-R	PLIABITSTAT PSWJFETSTAT PMLWJFETSTAT	1/0 0x3F/0 0x7F/0	1/0 0x3F/0 0x7F/0	N/A	Pass

Stopped CCS Handler

Changed mission configuration to fm_ist_cft_config14p – restarted CCS Handler

Start time @: 08:11

End time @:

OBSID: 0xb00017ff

Comments: Switched off OK.



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3.3.58 SPIRE-IST-COLD-FUNC-DCU-11-SPEC-R

Test Id:	SPIRE-IST-COLD-FUNC-DCU-11-SPEC-R
Test Purpose:	Spectrometer BDAs switch ON check
Initial Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON + Spectrometer LIAs ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON + Spectrometer LIAs ON + Spectrometer BIAS ON + Spectrometer JFETs ON
Duration	7 minutes
Success Criteria:	Test passed if SCUDCDCSTAT goes from 4 to 6, Spectrometer LIAs voltages are correct and SJFET voltages are also correct.
CUS Parameters	heater_V = 0; //Specifies if the heater is to be switched ON array = "SF"; //default array to swicth ON

Test Procedure:

Step#	Action
1	Run SPIRE-IST-COLD-FUNC-DCU-11-SPEC-R test procedure from the CCS.
2	After the test Write down the values RAW and converted values of: LIASTAT SLIAP5V, SLIAP9V, SLIAM9V SSWJFETSTAT,SLWJFETSTAT SSWJFET1V,SLWJFET2V located in on the DCU PARAMETERS display.
3	Contingency: If test fails repeat steps 1 and 2.

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	No. of frames received	Test Result
SPIRE-IST-COLD-FUNC-DCU-11-SPEC-R	SPECJFETSTAT SSWJFET1V SSWJFET2V SLWJFET1V SLIABITSTAT SLIAP5V SLIAP9V SLIAM9V	0/7 0V/-1.5V 0V/-1.5V 0V/-1.5V 1 ~0/ ~+5.23 ± 0.1V ~0/ ~+11.57 ± 0.1V ~0/ ~-11.54 ± 0.1V	0 / 7 0 / -V 0 / -V 0 / -V See plot below 5.25V 11.59V -11.57V	N/A	Pass



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First attempt will be to switch on the Spec JFETs at the nominal V_{ss} values of ~-1.5V

- Check mission configuration to ensure the right V_{ss} values are used.

Stopped CCS Handler

Changed mission configuration to fm_ist_cft_config19p_Kourou – restarted CCS Handler

Start time @: 08:16

End time @:

OBSID: 0xb0001800

Comments:

All JFET membranes switched on as before

Final V_{ss} values were consistent with Jamie Bock's spreadsheet (least noise).

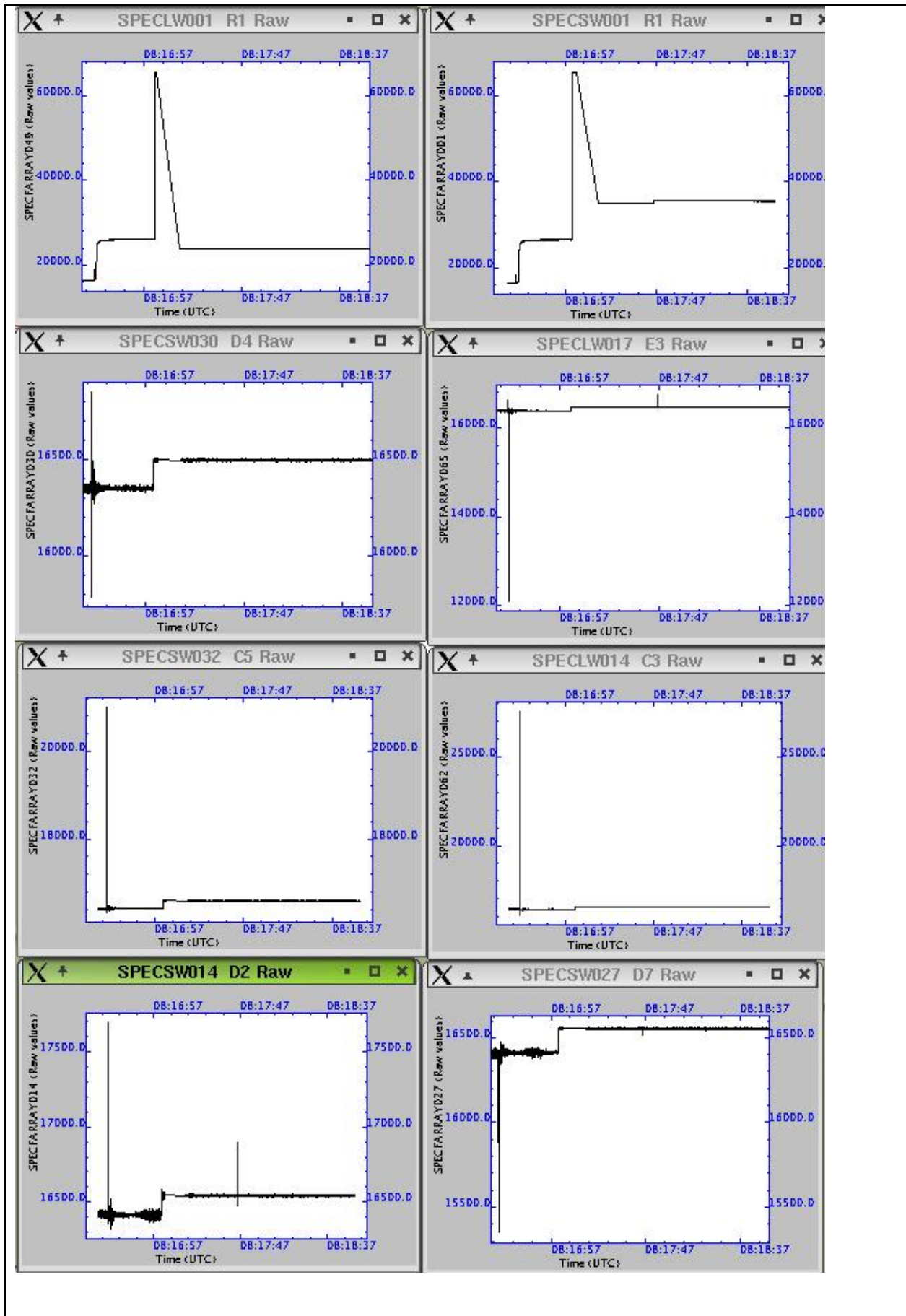
S-LIA temperatures ~300K



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3.3.59 SPIRE-IST-COLD-FUNC-DCU-13-SPEC-R

Test Id:	SPIRE-IST-COLD-FUNC-DCU-13-SPEC-R
Test Purpose:	Spectrometer detectors check
Initial Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON + Spectrometer LIAs ON + Spectrometer BIAS ON + Spectrometer JFETs ON
Final Configuration:	Unchanged
Duration	12 minutes
Success Criteria:	The spectrometer detectors show a small linear variation on the output voltage when different bias is applied through the load curve.
CUS Parameters	dcumode = "SF"; //DCU data mode mclkdiv = 0x79; //Master clock divisor biasdiv = 0x1; // Bias divisor ssw_phase = 0x80; // SSW demod phase slw_phase = 0x80; // SLW demod phase ftime = 10; // Time at each bias level

Test Procedure:

Step#	Action	Comments
1	On QLA bring up a time series display of a couple of pixels on each of the spectrometer BDAs	
2	Run SPIRE-IST-COLD-FUNC-DCU-13-SPEC-R test procedure from the CCS.	
3	Contingency: If test fails repeat steps 1 and 2	

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	No. of frames received	Test Result
SPIRE-IST-COLD-FUNC-DCU-13-SPEC-R	SPECJFETSTAT SLIABITSTAT	7 1	7 1	N/A	TEST NOT DONE

Start time @:

End time @:

OBSID:

Comment: TEST SKIPPED AS NO NEW INFORMATION



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3.3.60 SPIRE-IST-COLD-FUNC-DCU-14-SPEC-R

Test Id:	SPIRE-IST-COLD-FUNC-DCU-14-SPEC-R
Initial Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON + Spectrometer LIAs ON + Spectrometer BIAS ON + Spectrometer JFETs ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON + Spectrometer LIAs ON + Spectrometer BIAS ON + Spectrometer JFETs ON
Duration	5 minutes (CUS 146.0)
Success Criteria:	The Spectrometer detectors don't show excess noise.
CUS Parameters	dcumode = "SF"; //Array ftime = 120; //time

Test Procedure:

Step#	Action	Comments
1	Run SPIRE-IST-COLD-FUNC-DCU-14-SPEC-R test procedure from the CCS.	
2	Contingency: If test fails repeat step 1.	

Test Log:

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	Nb. of frames received	Test Result
SPIRE-IST-COLD-FUNC-DCU-14-SPEC-R	SPECJFETSTAT SLIABITSTAT	7 1		N/A	TEST NOT DONE

Start time @:
 End time @:
 OBSID:

Comments: **TEST SKIPPED AS NO NEW INFORMATION**



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3.3.61 SPIRE-IST-COLD- SPEC-VSS-R

Test Id:	
Purpose	Spectrometer BDAs Vss Test REDUNDANT
Initial Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON + Spectrometer LIAs ON + Spectrometer BIAS ON + Spectrometer JFETs ON
Final Configuration:	Unchanged
Duration	40 minutes (CUS 906.0)
Success Criteria:	Spectrometer BDA Vss values are optimised
CUS Parameters	jfet_Vss_start = -1.5; //Starting JFET source voltage jfet_Vss_end = -4.0; //ending JFET source voltage jfet_Vss_step = -0.1; //stepping JFET source volatge ftime = 60; //wait time at each level;

Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Check that the Spectrometer detectors and LIAs are switched on	SPECJFETSTAT SLIABITSTAT	7 1		
2	Execute TCL script SPIRE-IST-COLD- SPEC-VSS-R.tcl	—	—	—	
3	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
Test Result (Pass/Fail):					

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	Nb. of frames received	Test Result
SPIRE-IST-COLD-SPEC-VSS-R	SPECJFETSTAT SLIABITSTAT	7 1	7 1	N/A	TEST NOT DONE



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Start time @:

End time @:

OBSID:

Comments: TEST SKIPPED AS NO NEW INFORMATION



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3.3.62 SPIRE-IST-COLD-SDET-OFF-R

Test Id:	SPIRE-IST-COLD-SDET-OFF-R
Purpose	Spectrometer BDAs Switch OFF
Initial Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON + Spectrometer LIAs ON + Spectrometer BIAS ON + Spectrometer JFETs ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON+MCU ON + Spectrometer BDAS OFF
Duration	3 minutes
Success Criteria:	DCU HK parameters show expected values

Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Execute TCL script SPIRE-IST-COLD-SDET-OFF-R.tcl	—	—		
2	Check that the Spectrometer detectors are switched off	SPECJFETSTAT	7/-/0	7/-/0	
3	Check that the Spectrometer LIAs are switched off	SLIABITSTAT	1/-/0	1/-/0	
4	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	

Test Result (Pass/Fail):

Test Id	Key Parameter(s)	Expected Value Before/After	Actual Value Before/After	Nb. of frames received	Test Result
SPIRE-IST-COLD-SDET-OFF-R	SPECJFETSTAT SLIABITSTAT	7/0 1/0	7/0 1/0	N/A	PASS



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Stopped CCS Handler

Changed mission configuration to fm_ist_cft_config14p – restarted CCS Handler

Start time @: 08:27

End time @:

OBSID: 0xb0001801

Comments:

Switched CDMS Bus from A to B



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3.3.63 SPIRE-IST-COLD-MCU-OFF-R

Test Id:	SPIRE-IST-COLD-MCU-OFF-R
Purpose	MCU RED Switch OFF
Initial Configuration:	DRCU_ON + AC/DC thermometry ON+MCU RED ON
Final Configuration:	DRCU_ON + AC/DC thermometry ON+MCU RED OFF
Duration	5 minutes
Success Criteria:	MCU HK parameters show expected values

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Execute SPIRE-IST-COLD-MCU-OFF-R.tcl	—	—	—	OBSID: 0xb0001802 08:34
2	Check that the MCU is switched off	MCUBITSTAT	1/-/0	1/-/0	OK

Test Result (Pass/Fail): **PASS**



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3.3.64 SPIRE-IST-COLD-SCU-OFF-R

Test Id:	SPIRE-IST-COLD-SCU-OFF-R
Purpose	SCU RED Switch OFF
Initial Configuration:	DRCU_ON + AC/DC thermometry ON
Final Configuration:	DRCU_ON + AC/DC thermometry OFF
Duration	5 minutes
Success Criteria:	SCU HK parameters show expected values

Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Execute TCL script SPIRE-IST-COLD-SCU-OFF-R.tcl	—	—	—	OBSID: 0xb0001803 08:36
2	A few seconds later record the value of parameter SCUTEMPSTAT	SCUTEMPSTAT	0xFFFF/-/0	0xFFFF/-/0	OK
3	A few seconds later record the value of parameter SUBKSTAT	SUBKSTAT	1/-/0	1/-/0	OK
Test Result (Pass/Fail): PASS					



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3.3.65 SPIRE-IST-COLD-DRCU-OFF-R

Test Id:	SPIRE-IST-COLD-DRCU-OFF-R
Purpose	DRCU RED Switch OFF
Initial Configuration:	SPIRE DPU and DRCU RED are ON and SPIRE HK is being produced and AC/DC thermometry is ON.
Final Configuration:	SPIRE DPU RED is ON, SPIRE DRCU RED is OFF and SPIRE HK is not being produced.
Duration	5 minutes
Success Criteria:	THSK and TM2N stop refreshing/incrementing

Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Execute TCL script SPIRE-IST-COLD-DRCU-OFF.tcl	—	—	—	
2	Check that THSK parameter is not refreshing anymore	THSK	Not refreshing	—	OK
3	Check that TM2N parameter is not incrementing anymore	TM2N	Not incrementing	—	OK
4	Power OFF the SPIRE DRCU RED unit.	—	—	—	

Test Result (Pass/Fail):
OBSID: 0xb0001804
08:38



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3.3.66 SPIRE-IST-COLD-DPU-OFF-R

Test Id:	SPIRE-IST-COLD-DPU-OFF-R
Purpose	DPU RED Switch OFF
Initial Configuration:	SPIRE DPU RED is ON but not generating HK.
Final Configuration:	SPIRE DPU RED is OFF.
Duration	5 minutes
Success Criteria:	Power to SPIRE DPU RED is OFF

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Power OFF the SPIRE DPU RED unit.	—	—	—	OK

Test Result (Pass/Fail): **PASS**

DPU Redundant Side LCL opened at 08:41



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4. CONCLUSIONS

- All the CFTs were successfully executed.
- NCR-4705 (SPIRE TB/TV SSW JFET problem) can be closed on a “use as is” basis. To ensure safe operation in flight, the SSW JFET will not be turned on until L3 has reached operational temperature of ~12-15K (see .
- The SPIRE instrument is therefore ready for flight.



5. ANNEXE 1 (RESULTS OF LOAD CURVES – PRIME SIDE)

The following graphs (1-12) show the response of the 288 Photometer detectors to the input voltage during the Load Curve (FUNC-DCU-13). The graph (13) shows the response of the 3 PTC channels to the input voltage during the Load Curve. The graphs (14-16) show the spectrometer 78 detectors output voltage during the load curve performed on the spectrometer side. These plots are for the PRIME SIDE tests: OBSIDs 0xB00017D3 for photometer and 0xB00017DC for spectrometer.

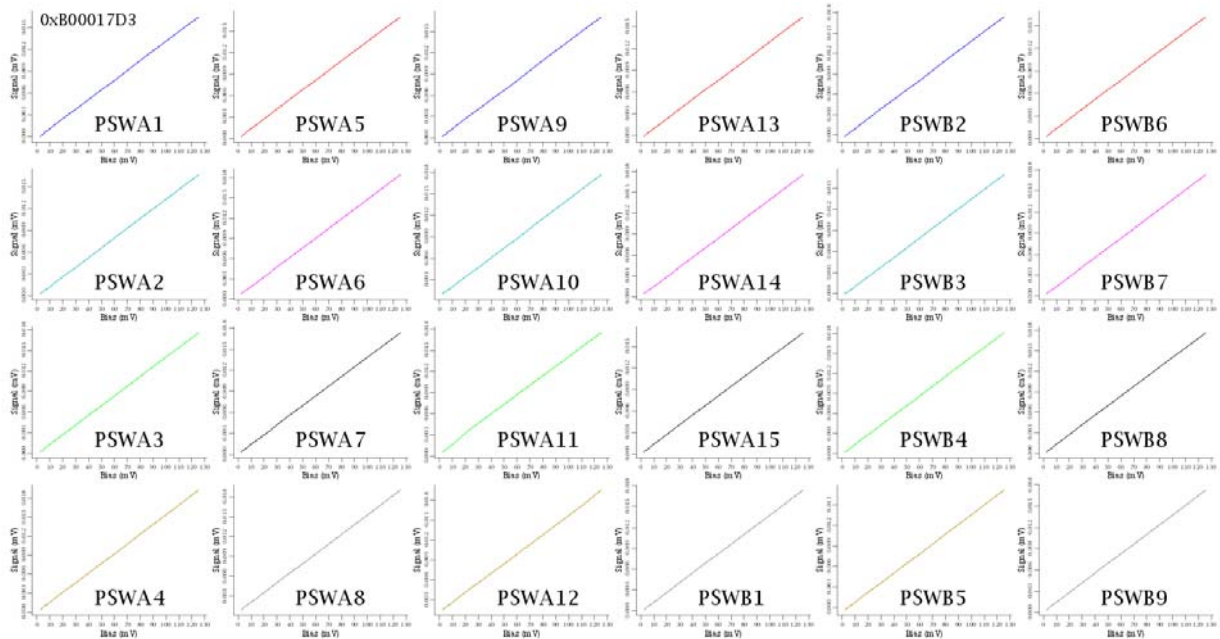


Figure 1. PSW Detectors (1)

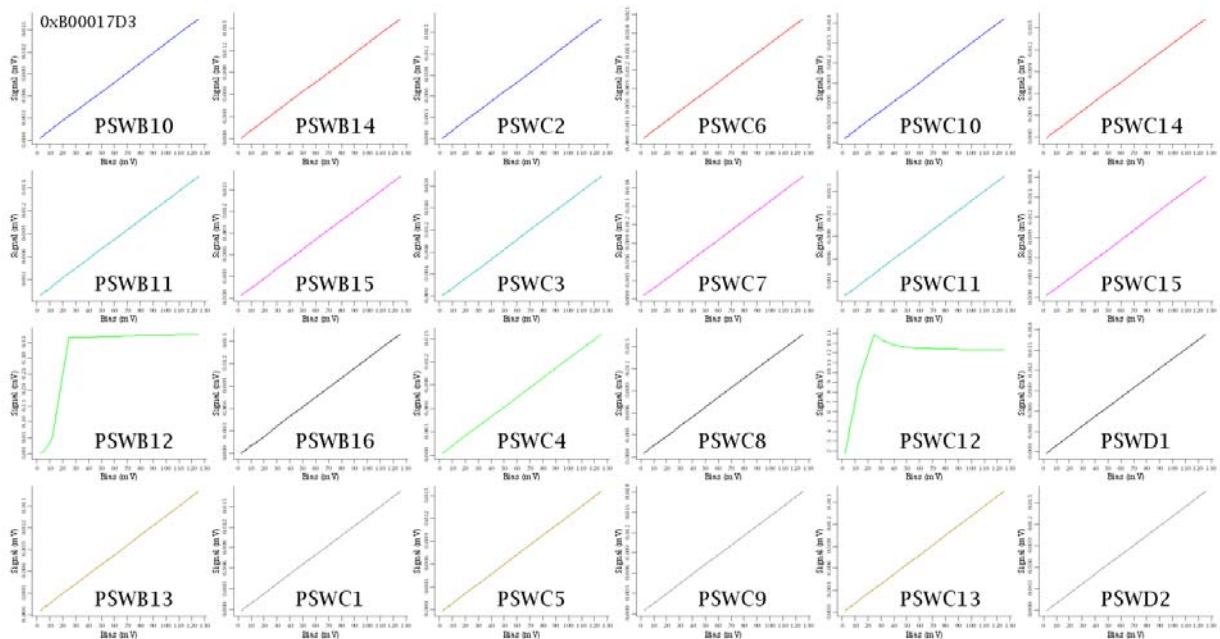


Figure 2. PSW Detectors (2)



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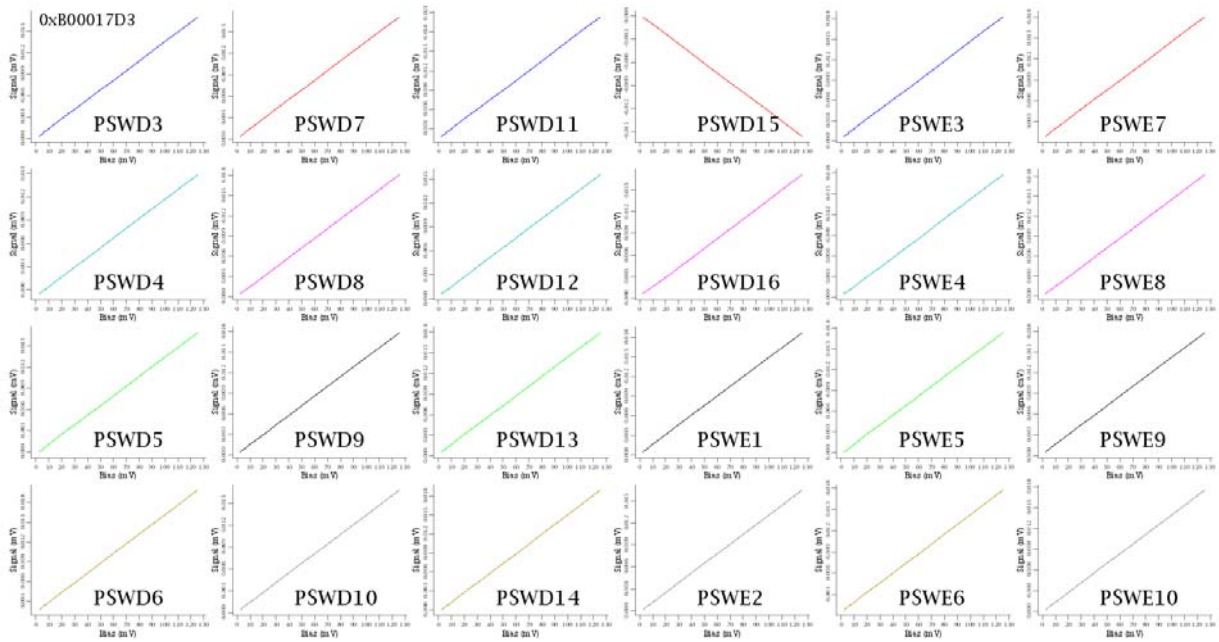


Figure 3. PSW Detectors (3)

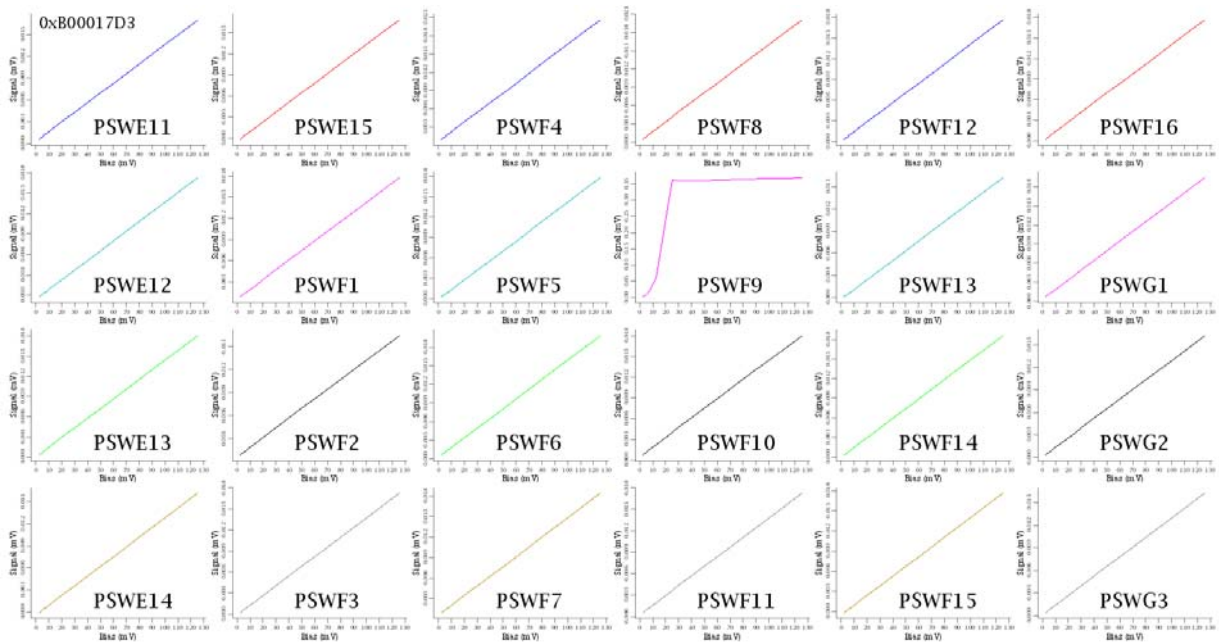


Figure 4. PSW Detectors (4)



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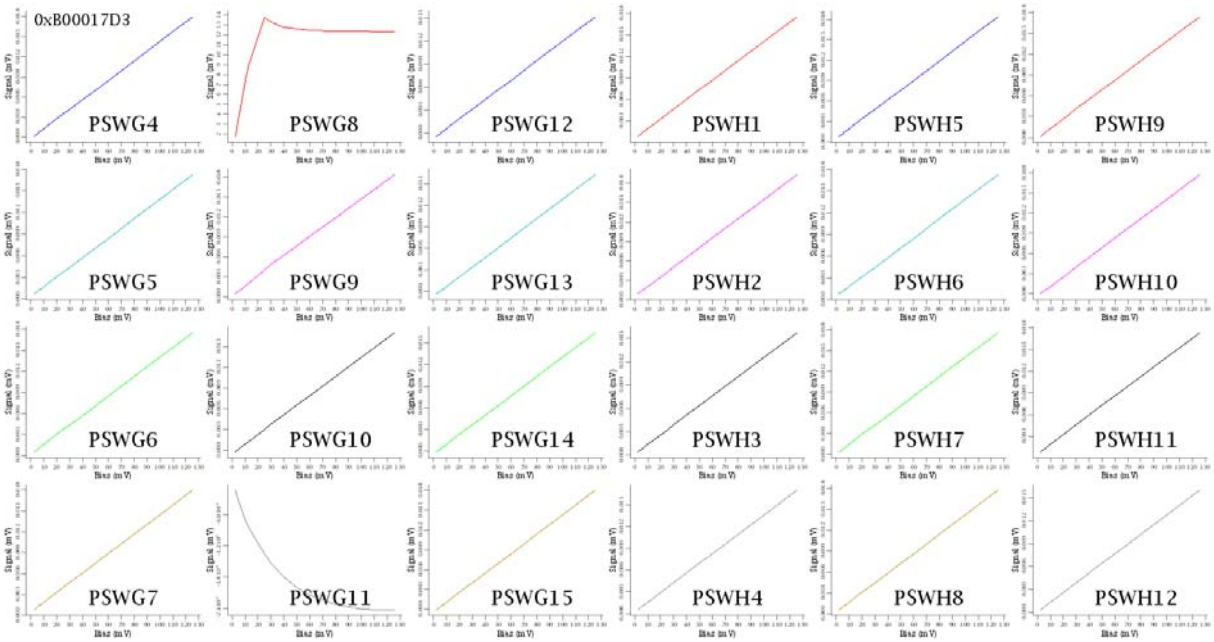


Figure 5. PSW Detectors (5)

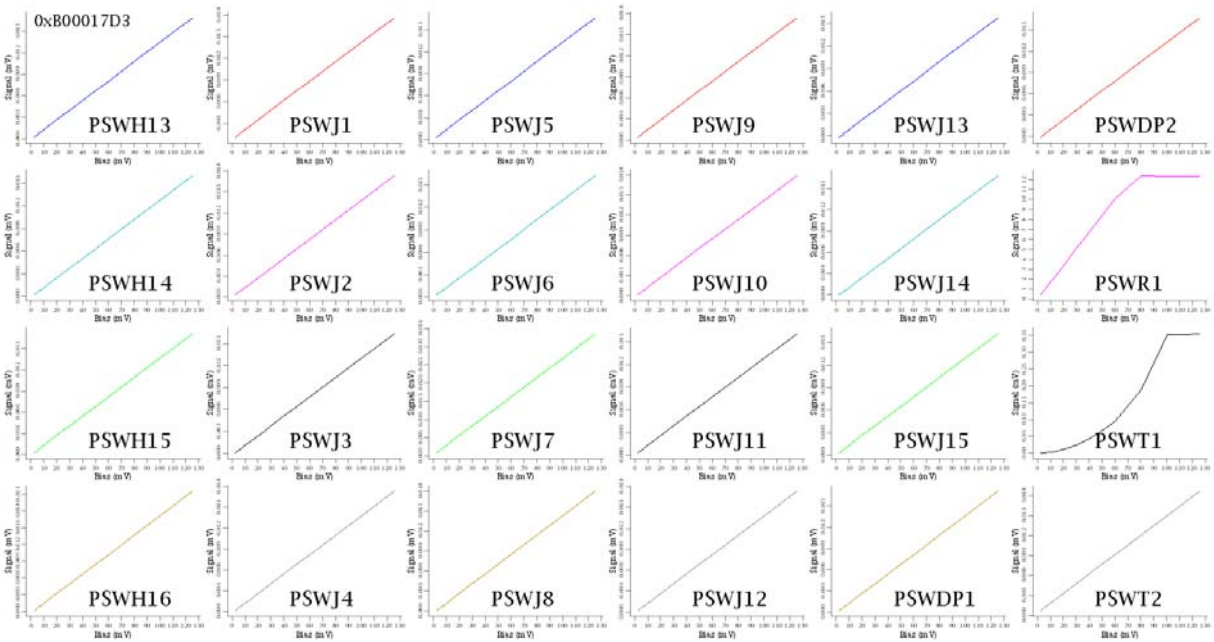


Figure 6. PSW Detectors (6)



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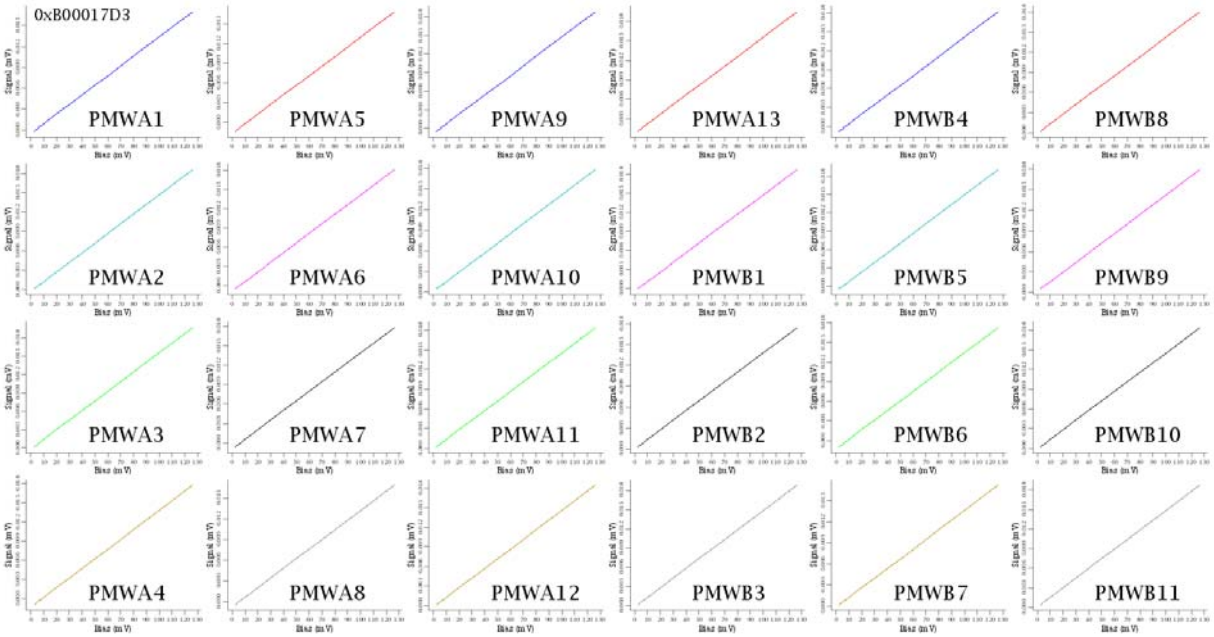


Figure 7. PMW Detectors (1)

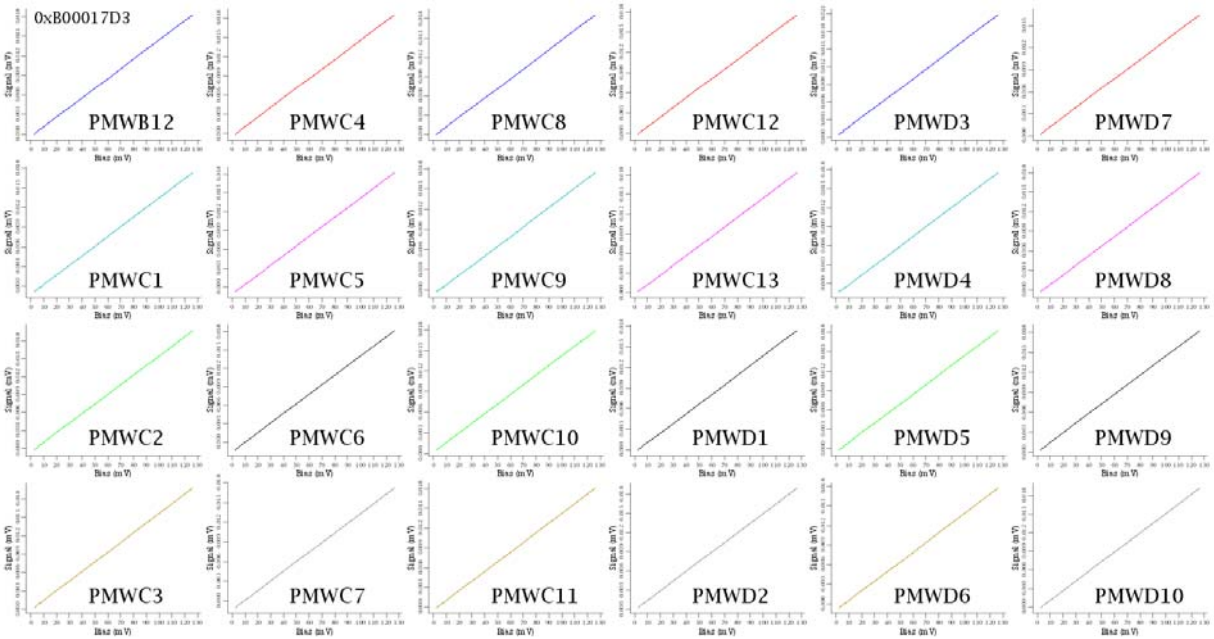


Figure 8. PMW Detectors (2)



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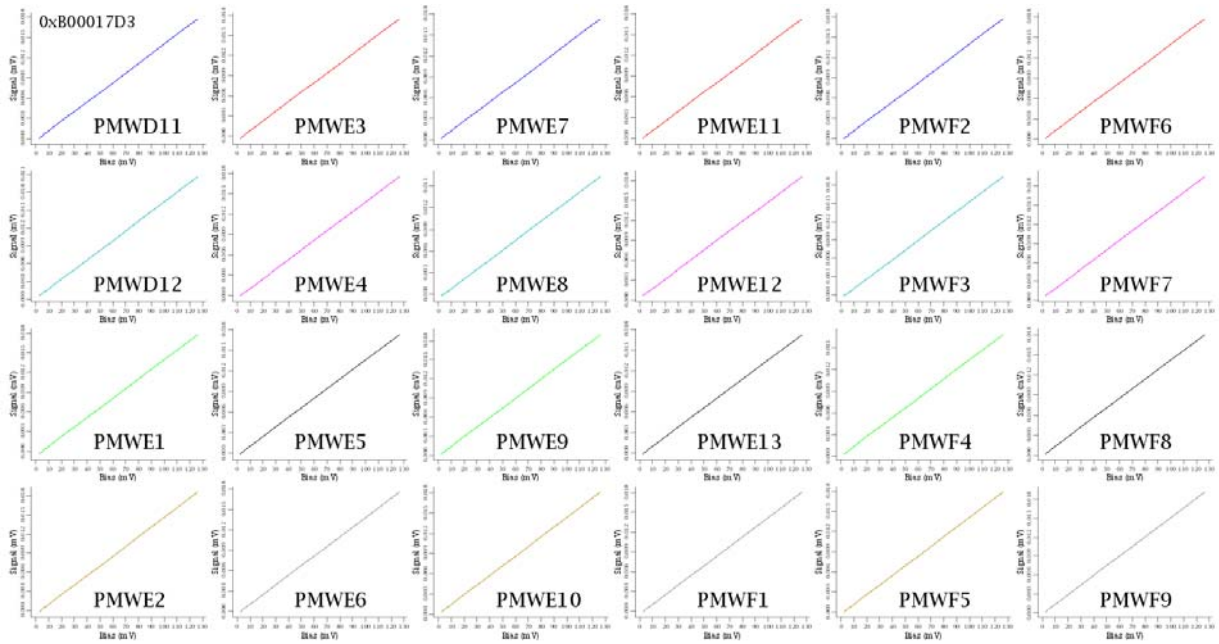


Figure 9. PMW Detectors (3)

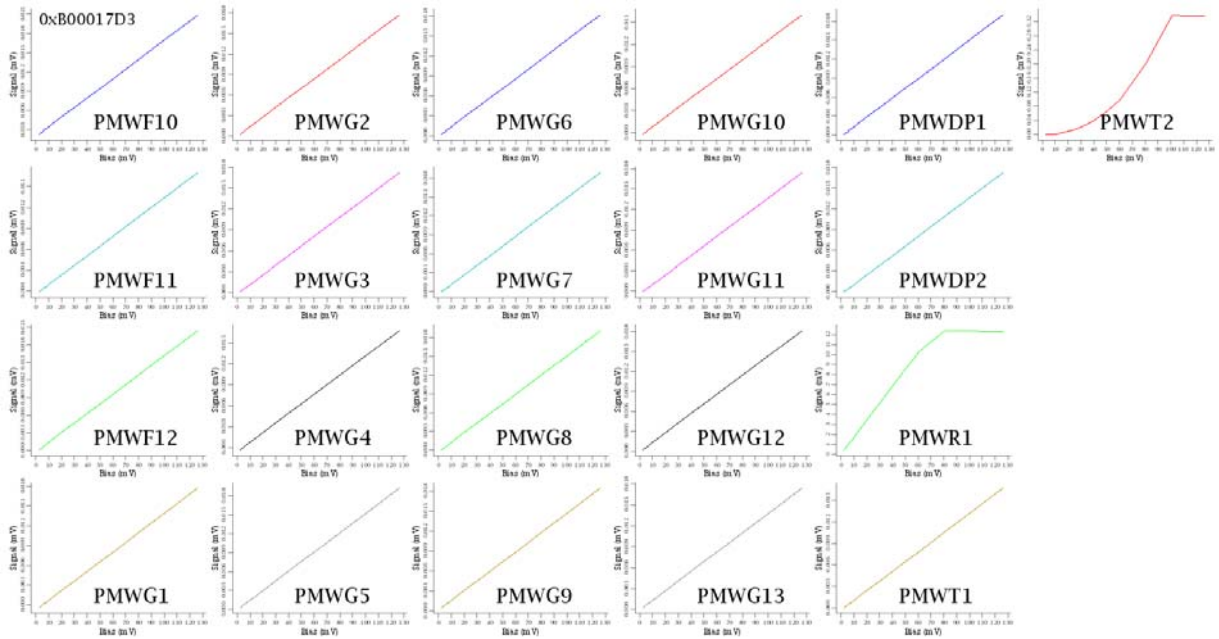


Figure 10. PMW Detectors (4)



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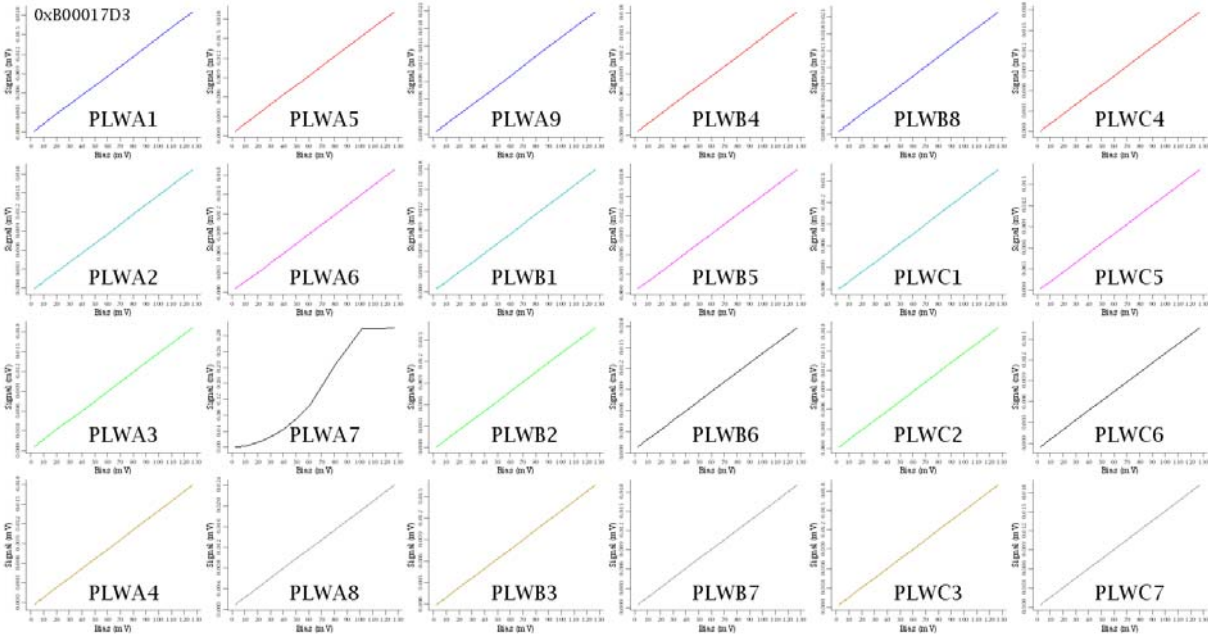


Figure 11. PLW Detectors (1)

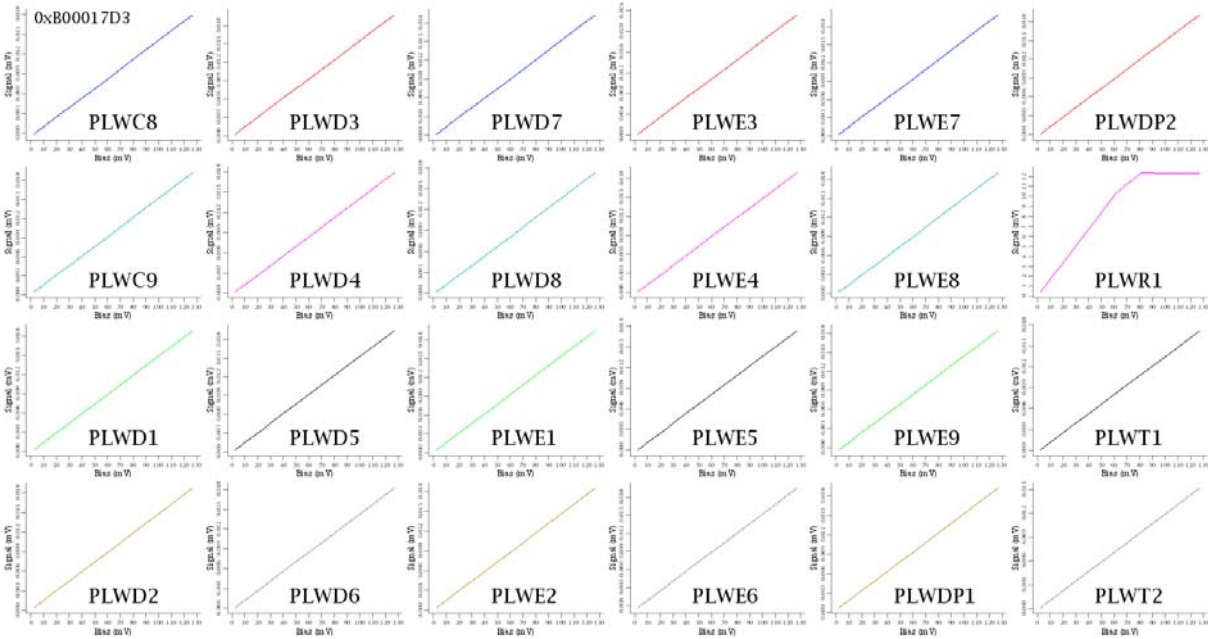


Figure 12. PLW Detectors (2)



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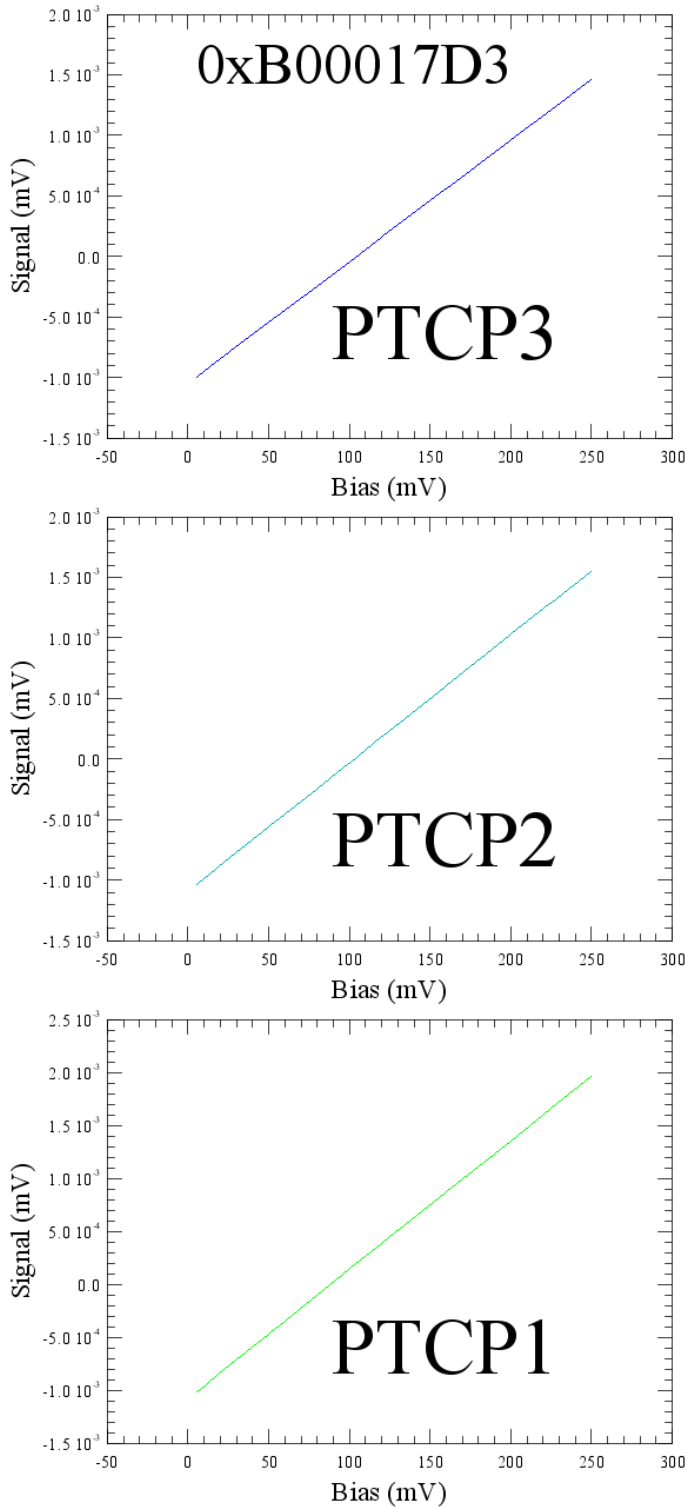


Figure 13. PTC Detectors (1)



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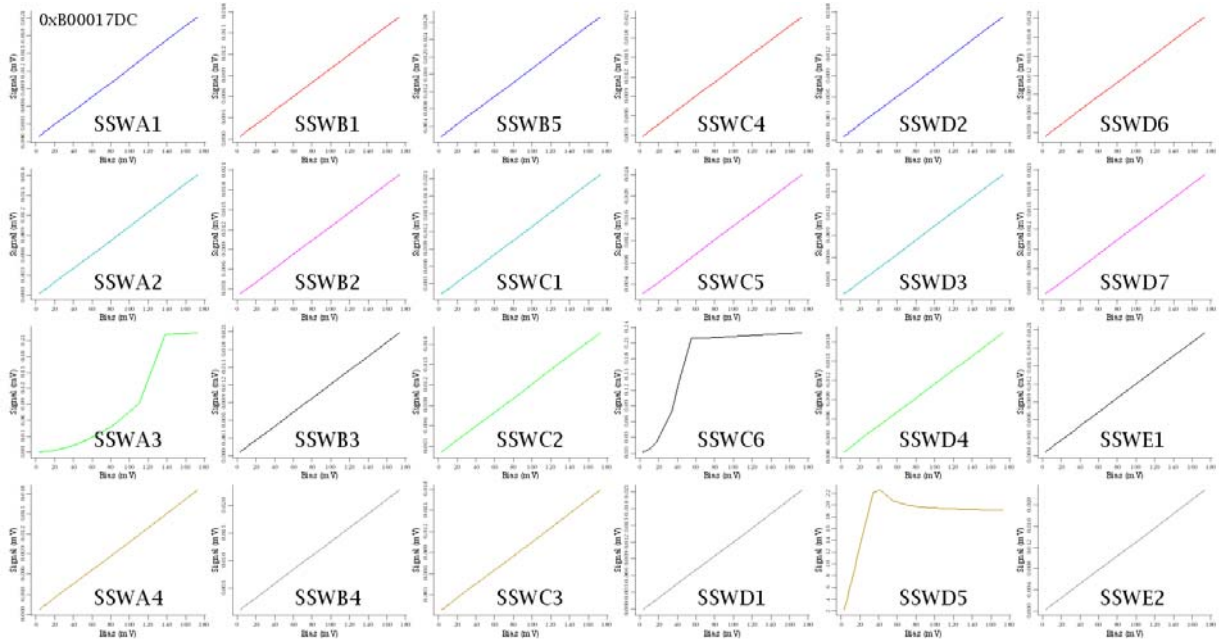


Figure 14. SSW Detectors (1)

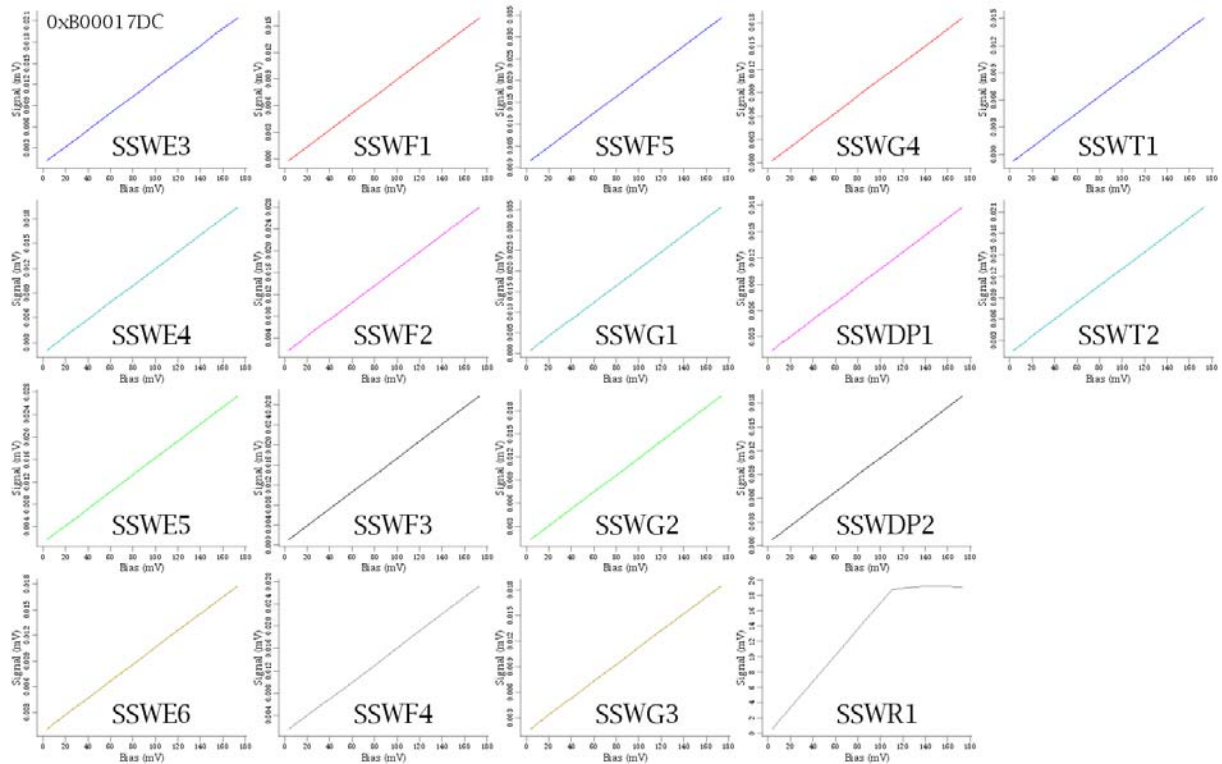


Figure 15. SSW Detectors (2)



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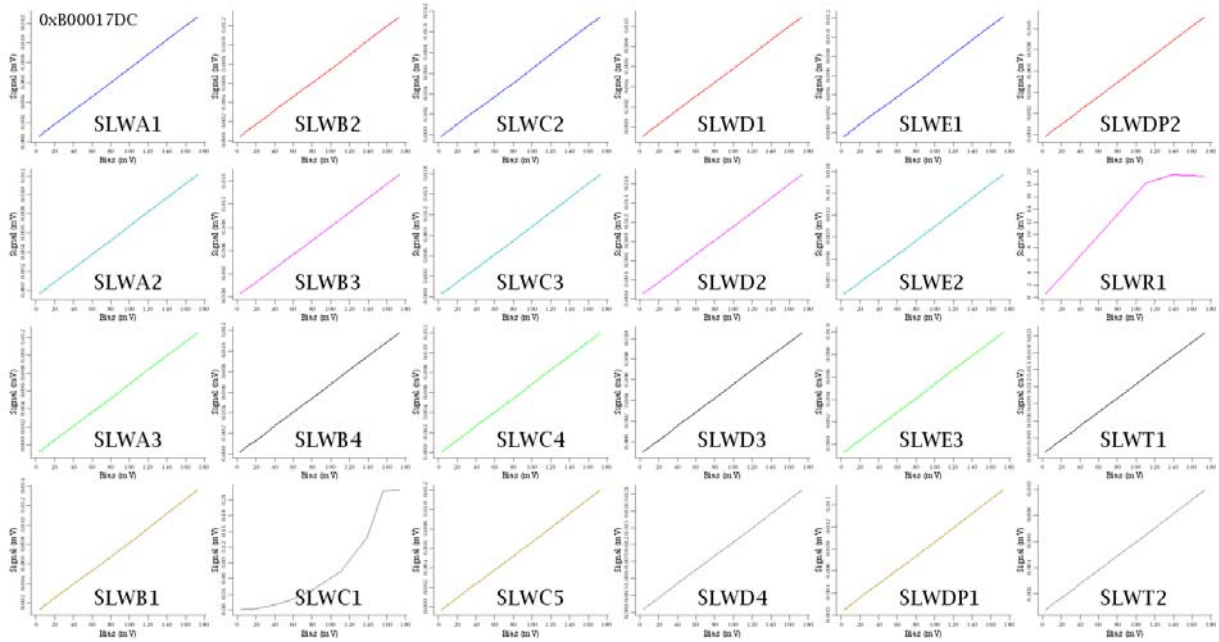


Figure 16. SLW Detectors (1)



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6. ANNEXE 2 (BOLOMETER RESISTANCES – PRIME SIDE)

6.1 PSW

Average Resistances: Stddev kOhm Resistance kOhm
Calculated by fitting a straight line to points 2-9 in the load curve

PSWA1	3.1211	133.0545
PSWA2	3.0950	132.9591
PSWA3	3.2579	138.8930
PSWA4	3.5657	152.3806
PSWA5	3.1467	134.0753
PSWA6	3.3219	140.7130
PSWA7	3.1886	135.1939
PSWA8	3.3626	143.0413
PSWA9	3.1590	134.1209
PSWA10	3.1603	134.1812
PSWA11	3.4303	147.0977
PSWA12	3.4069	145.9793
PSWA13	3.1583	135.9004
PSWA14	3.2830	140.9579
PSWA15	3.1959	136.5930
PSWB1	3.2616	138.8687
PSWB2	3.3277	140.2731
PSWB3	3.1956	136.7864
PSWB4	3.3720	144.4657
PSWB5	3.2655	139.7488
PSWB6	3.0114	128.3763
PSWB7	3.1998	135.7571
PSWB8	3.2836	139.5427
PSWB9	3.1720	134.2511
PSWB10	3.0341	128.9201
PSWB11	3.0222	129.2566
PSWB12	289.9168	46032.3915
PSWB13	3.1479	134.8716
PSWB14	3.1218	133.4770
PSWB15	3.1938	137.0032
PSWB16	3.0480	131.4372
PSWC1	3.2681	139.8053
PSWC2	3.1765	134.8493
PSWC3	4.0880	174.6267
PSWC4	2.9025	124.7170
PSWC5	2.9544	126.5292
PSWC6	3.6598	155.8232
PSWC7	3.6200	153.9904
PSWC8	3.0434	128.5561
PSWC9	3.3088	139.9345
PSWC10	3.4096	144.1766
PSWC11	3.0580	130.2619
PSWC12	9005.9606	3622703.1649
PSWC13	3.1264	133.3724
PSWC14	3.1302	133.9973
PSWC15	3.3868	145.5329
PSWD1	3.3484	142.1967
PSWD2	3.1530	135.3322
PSWD3	3.1515	134.3904
PSWD4	2.8999	123.2773
PSWD5	3.1928	136.1663
PSWD6	3.4335	146.5707



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PSWD7	3.1412	132.8955
PSWD8	3.3164	140.4826
PSWD9	3.2748	139.3112
PSWD10	3.0825	130.4699
PSWD11	3.5400	150.4953
PSWD12	2.8791	122.4254
PSWD13	3.3285	142.4881
PSWD14	3.6217	155.5163
PSWD15	-2.9642	125.3249
PSWD16	3.1238	138.6415
PSWE1	3.4654	148.0683
PSWE2	3.0622	130.4609
PSWE3	3.3040	140.8968
PSWE4	3.2050	137.6540
PSWE5	3.2593	139.4333
PSWE6	3.1673	134.4204
PSWE7	3.2098	136.9955
PSWE8	3.3687	142.5533
PSWE9	3.2657	138.7032
PSWE10	3.2596	138.6435
PSWE11	3.1585	135.4584
PSWE12	3.2535	138.6362
PSWE13	3.3031	141.1766
PSWE14	3.0376	129.8405
PSWE15	3.1442	134.5176
PSWF1	3.2320	137.5713
PSWF2	2.9746	127.0718
PSWF3	3.1906	136.5420
PSWF4	3.6762	156.6885
PSWF5	3.2233	137.5196
PSWF6	3.5124	149.5995
PSWF7	3.2131	136.0764
PSWF8	3.6361	153.2090
PSWF9	272.2095	43056.0778
PSWF10	3.2252	136.4039
PSWF11	3.1050	131.2438
PSWF12	3.2014	137.2406
PSWF13	3.0183	128.5930
PSWF14	3.4070	145.0834
PSWF15	3.3089	142.0014
PSWF16	3.2480	138.1698
PSWG1	3.5766	152.6214
PSWG2	2.9927	127.9166
PSWG3	2.9598	125.8698
PSWG4	3.3181	141.6872
PSWG5	3.0343	129.0626
PSWG6	3.1199	132.0181
PSWG7	3.2052	135.3441
PSWG8	8641.4531	3449715.1285
PSWG9	3.5476	152.4596
PSWG10	3.2271	135.8947
PSWG11	-0.9513	60.0776
PSWG12	2.8896	122.4540
PSWG13	3.0941	132.1025
PSWG14	3.1177	133.2335
PSWG15	3.3555	143.4892
PSWH1	3.1824	135.9552
PSWH2	3.4954	150.0920
PSWH3	2.8880	124.1396
PSWH4	3.0852	132.2800
PSWH5	3.2989	140.9589



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PSWH6	3.0515	129.4490
PSWH7	3.2003	135.7914
PSWH8	3.1695	133.8602
PSWH9	3.2234	135.9838
PSWH10	3.2821	139.0818
PSWH11	3.0251	128.0868
PSWH12	2.9005	123.1877
PSWH13	3.0771	130.8857
PSWH14	2.9452	125.1181
PSWH15	3.1611	134.5624
PSWH16	3.9895	169.9276
PSWJ1	3.1818	135.9346
PSWJ2	3.2258	138.2375
PSWJ3	3.0797	132.7876
PSWJ4	3.2211	137.6643
PSWJ5	3.0204	128.5640
PSWJ6	2.9564	125.3042
PSWJ7	6.0177	255.6801
PSWJ8	3.3118	139.7302
PSWJ9	3.1468	132.9661
PSWJ10	3.3464	141.6901
PSWJ11	2.9386	125.5826
PSWJ12	3.2003	136.1417
PSWJ13	2.9933	127.8342
PSWJ14	3.1589	134.5884
PSWJ15	2.9645	125.8523
PSWDP1	3.2010	135.9524
PSWDP2	3.1446	134.3303
PSWR1	5208.9361	221143.7822
PSWT1	26.7042	3140.5212
PSWT2	3.4253	146.2919

6.2 PMW

Average Resistances: Stddev kOhm Resistance kOhm

Calculated by fitting a straight line to points 2-9 in the load curve

PMWA1	3.3862	143.7576
PMWA2	3.6580	154.9591
PMWA3	3.8599	164.1033
PMWA4	3.6932	157.0846
PMWA5	3.5109	148.8750
PMWA6	3.5263	148.5276
PMWA7	3.5644	150.6696
PMWA8	3.2322	135.9415
PMWA9	3.6249	152.8435
PMWA10	3.2328	136.9470
PMWA11	3.3871	144.3560
PMWA12	3.4023	144.6926
PMWA13	3.3985	143.5801
PMWB1	3.7532	159.3096
PMWB2	3.3654	142.7556
PMWB3	3.7112	156.4181
PMWB4	3.7181	157.5546
PMWB5	3.8169	161.1178
PMWB6	3.5277	149.0762
PMWB7	3.1477	133.6725
PMWB8	3.3503	142.0089
PMWB9	3.2664	138.1186
PMWB10	3.4232	145.2030
PMWB11	3.4070	144.7306



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PMWB12	3.3988	144.3386
PMWC1	3.6206	153.0924
PMWC2	3.9964	169.3513
PMWC3	3.8174	161.7702
PMWC4	3.6419	154.0456
PMWC5	3.7039	156.9000
PMWC6	3.8048	160.9837
PMWC7	3.5557	150.5882
PMWC8	3.5077	149.2732
PMWC9	3.2885	139.3876
PMWC10	3.2540	137.8700
PMWC11	3.3889	144.0222
PMWC12	3.2938	139.5849
PMWC13	3.3761	143.1069
PMWD1	3.1060	132.2896
PMWD2	3.7084	156.5367
PMWD3	3.6774	156.3129
PMWD4	3.7356	158.3191
PMWD5	3.3680	142.1801
PMWD6	3.6056	152.2641
PMWD7	3.1017	131.5281
PMWD8	3.4078	144.8996
PMWD9	3.4059	144.9962
PMWD10	3.6122	153.7925
PMWD11	3.2904	140.2192
PMWD12	3.7363	158.0531
PMWE1	3.2818	138.0883
PMWE2	3.3700	142.9618
PMWE3	3.2525	137.3253
PMWE4	3.2136	136.2866
PMWE5	3.2115	136.4061
PMWE6	3.1957	136.3147
PMWE7	3.2325	137.4009
PMWE8	3.1154	132.1932
PMWE9	3.5579	150.7354
PMWE10	3.4160	145.0607
PMWE11	3.3256	141.4605
PMWE12	3.4832	147.6467
PMWE13	3.2285	137.3462
PMWF1	3.2566	138.2740
PMWF2	3.1940	135.3896
PMWF3	3.5705	151.1932
PMWF4	3.0444	129.0022
PMWF5	3.2668	138.6411
PMWF6	3.2169	136.6156
PMWF7	3.5432	150.1335
PMWF8	3.3911	143.5288
PMWF9	3.5944	152.6155
PMWF10	3.5454	150.0892
PMWF11	3.3021	139.5802
PMWF12	3.9473	167.5172
PMWG1	3.2594	137.2333
PMWG2	3.1727	134.7352
PMWG3	3.1110	132.5795
PMWG4	3.1664	133.7364
PMWG5	3.4909	148.1798
PMWG6	3.2857	139.9700
PMWG7	3.4759	147.5574
PMWG8	3.6272	154.1358
PMWG9	3.4224	144.7833
PMWG10	3.0895	131.2730



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PMWG11  3.3566  142.0084
PMWG12  3.4824  147.5680
PMWG13  3.3065  140.2661
PMWDP1  3.7894  159.9707
PMWDP2  3.3523  142.3611
PMWR1   4973.4816 209792.7382
PMWT1   3.0772  130.8884
PMWT2   23.3372  3401.9909

```

6.3 PLW

Average Resistances: Stddev kOhm Resistance kOhm
Calculated by fitting a straight line to points 2-9 in the load curve

```

PLWA1  3.4432  146.6281
PLWA2  3.5273  149.4608
PLWA3  3.3747  142.7390
PLWA4  3.3722  143.4630
PLWA5  3.4141  145.3407
PLWA6  3.3057  143.2571
PLWA7  27.6652  3330.9493
PLWA8  4.1966  178.0078
PLWA9  3.7300  158.3429
PLWB1  3.2688  139.1475
PLWB2  3.1138  132.5329
PLWB3  3.0917  131.9642
PLWB4  3.3094  140.6482
PLWB5  3.4509  146.5089
PLWB6  3.1649  134.3463
PLWB7  3.4247  145.0486
PLWB8  3.9433  167.3805
PLWC1  3.0096  128.6913
PLWC2  3.4343  145.8552
PLWC3  3.3475  142.5869
PLWC4  3.3022  140.5680
PLWC5  3.0787  130.4474
PLWC6  3.1336  131.8557
PLWC7  3.4707  147.6832
PLWC8  3.2755  139.0979
PLWC9  3.4492  147.8602
PLWD1  3.3756  144.1988
PLWD2  3.3018  139.9852
PLWD3  3.5575  150.9106
PLWD4  3.2209  136.7464
PLWD5  3.4868  148.7408
PLWD6  3.2922  139.6916
PLWD7  3.4818  148.2899
PLWD8  3.1211  131.8682
PLWE1  3.4491  146.0849
PLWE2  3.2758  139.2820
PLWE3  4.1707  177.4245
PLWE4  3.4157  145.0076
PLWE5  3.1548  134.3122
PLWE6  3.5850  152.4329
PLWE7  3.5821  152.1071
PLWE8  3.4441  146.6492
PLWE9  3.4155  144.1003
PLWDP1  3.4719  148.0081
PLWDP2  3.4929  148.8808
PLWR1   5079.2353 215740.0666
PLWT1   3.1802  134.2559
PLWT2   2.7284  116.2262

```



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6.4 SSW

Resistances: Stddev kOhm Resistance kOhm
Calculated by fitting a straight line to points 2-9 in the load curve

SSWA1	2.8577	122.5250
SSWA2	2.5273	108.2335
SSWA3	10.8133	1204.9392
SSWA4	2.5113	107.5987
SSWB1	2.3624	100.7645
SSWB2	2.5958	109.9756
SSWB3	2.8461	121.1614
SSWB4	3.0015	128.0691
SSWB5	3.8920	165.8447
SSWC1	2.8099	119.7291
SSWC2	2.5307	107.7984
SSWC3	2.4312	104.0837
SSWC4	2.5316	108.8775
SSWC5	2.9494	125.8302
SSWC6	100.7318	10926.5564
SSWD1	3.0444	129.6700
SSWD2	2.4061	102.3140
SSWD3	2.3624	100.5529
SSWD4	2.5909	110.0620
SSWD5	13962.6005	4175521.6101
SSWD6	2.5739	109.7305
SSWD7	2.4787	105.6269
SSWE1	2.8821	122.5061
SSWE2	3.1515	134.4571
SSWE3	2.8634	122.1972
SSWE4	2.3638	100.4737
SSWE5	3.4463	146.7329
SSWE6	2.2648	96.1702
SSWF1	2.3188	99.1578
SSWF2	3.6927	157.1835
SSWF3	4.0984	174.2489
SSWF4	3.4103	145.9901
SSWF5	4.4756	190.6329
SSWG1	5.0421	214.5679
SSWG2	2.6653	113.2890
SSWG3	2.2629	96.1015
SSWG4	2.5761	109.8769
SSWDP1	2.3109	98.9176
SSWDP2	2.4457	104.0742
SSWR1	5233.0358	222400.1115
SSWT1	2.2711	95.8132
SSWT2	2.7610	117.5364

6.5 SLW

Resistances: Stddev kOhm Resistance kOhm
Calculated by fitting a straight line to points 2-9 in the load curve

SLWA1	2.3860	101.6372
SLWA2	2.4995	105.0423
SLWA3	2.7274	115.8536
SLWB1	2.3874	99.5642
SLWB2	2.4663	104.1326
SLWB3	3.1291	133.5279



SPIRE Report

IST COLD FUNCTIONAL TEST REPORT - III
Prime & Redundant
S.D. Sidher, T.L. Lim & B.M. Swinyard

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SLWB4	2.3597	100.4424
SLWC1	11.3460	1388.5064
SLWC2	2.2878	96.5151
SLWC3	3.5015	148.5875
SLWC4	2.4005	102.1434
SLWC5	2.4915	106.1133
SLWD1	2.3465	98.6642
SLWD2	3.7250	158.5713
SLWD3	2.3302	99.7380
SLWD4	4.3388	184.5205
SLWE1	2.4720	103.1275
SLWE2	3.2728	138.9283
SLWE3	2.1447	90.3086
SLWDP1	3.1614	134.6025
SLWDP2	2.2708	96.4016
SLWR1	6824.6523	290084.4215
SLWT1	4.1090	175.4242
SLWT2	1.8746	79.6532